

RF output power

Mode	DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
ac20-mode [VHT-MCS0]; 5180MHz	5180.0000	8.2	30.0	8.2	93.902	PASS
ac20-mode [VHT-MCS0]; 5200MHz	5200.0000	7.8	30.0	7.8	93.835	PASS
ac20-mode [VHT-MCS0]; 5240MHz	5240.0000	8.6	30.0	8.6	93.868	PASS
ac20-mode [VHT-MCS0]; 5745MHz	5745.0000	3.2	30.0	3.2	93.938	PASS
ac20-mode [VHT-MCS0]; 5785MHz	5785.0000	3.7	30.0	3.7	93.928	PASS
ac20-mode [VHT-MCS0]; 5825MHz	5825.0000	3.5	30.0	3.5	93.833	PASS
ac20-mode [VHT-MCS1]; 5180MHz	5180.0000	8.1	30.0	8.1	89.043	PASS
ac20-mode [VHT-MCS1]; 5200MHz	5200.0000	7.7	30.0	7.7	88.838	PASS
ac20-mode [VHT-MCS1]; 5240MHz	5240.0000	8.5	30.0	8.5	88.978	PASS
ac20-mode [VHT-MCS1]; 5745MHz	5745.0000	3.1	30.0	3.1	88.904	PASS
ac20-mode [VHT-MCS1]; 5785MHz	5785.0000	3.6	30.0	3.6	89.019	PASS
ac20-mode [VHT-MCS1]; 5825MHz	5825.0000	3.4	30.0	3.4	88.994	PASS
ac20-mode [VHT-MCS2]; 5180MHz	5180.0000	8.3	30.0	8.3	84.492	PASS
ac20-mode [VHT-MCS2]; 5200MHz	5200.0000	7.9	30.0	7.9	84.644	PASS
ac20-mode [VHT-MCS2]; 5240MHz	5240.0000	8.7	30.0	8.7	84.795	PASS
ac20-mode [VHT-MCS2]; 5745MHz	5745.0000	3.3	30.0	3.3	84.783	PASS
ac20-mode [VHT-MCS2]; 5785MHz	5785.0000	3.8	30.0	3.8	84.617	PASS
ac20-mode [VHT-MCS2]; 5825MHz	5825.0000	3.6	30.0	3.6	84.717	PASS
ac20-mode [VHT-MCS3]; 5180MHz	5180.0000	8.8	30.0	8.8	80.900	PASS
ac20-mode [VHT-MCS3]; 5200MHz	5200.0000	8.4	30.0	8.4	80.808	PASS
ac20-mode [VHT-MCS3]; 5240MHz	5240.0000	9.1	30.0	9.1	80.865	PASS
ac20-mode [VHT-MCS3]; 5745MHz	5745.0000	3.9	30.0	3.9	80.957	PASS
ac20-mode [VHT-MCS3]; 5785MHz	5785.0000	4.3	30.0	4.3	80.835	PASS
ac20-mode [VHT-MCS3]; 5825MHz	5825.0000	4.2	30.0	4.2	81.022	PASS
ac20-mode [VHT-MCS4]; 5180MHz	5180.0000	8.8	30.0	8.8	74.425	PASS
ac20-mode [VHT-MCS4]; 5200MHz	5200.0000	8.3	30.0	8.3	74.676	PASS
ac20-mode [VHT-MCS4]; 5240MHz	5240.0000	9.2	30.0	9.2	74.654	PASS
ac20-mode [VHT-MCS4]; 5745MHz	5745.0000	3.9	30.0	3.9	74.565	PASS
ac20-mode [VHT-MCS4]; 5785MHz	5785.0000	4.3	30.0	4.3	74.644	PASS
ac20-mode [VHT-MCS4]; 5825MHz	5825.0000	4.1	30.0	4.1	74.720	PASS
ac20-mode [VHT-MCS5]; 5180MHz	5180.0000	8.8	30.0	8.8	69.763	PASS
ac20-mode [VHT-MCS5]; 5200MHz	5200.0000	8.4	30.0	8.4	69.648	PASS
ac20-mode [VHT-MCS5]; 5240MHz	5240.0000	9.1	30.0	9.1	69.837	PASS
ac20-mode [VHT-MCS5]; 5745MHz	5745.0000	3.9	30.0	3.9	69.802	PASS
ac20-mode [VHT-MCS5]; 5785MHz	5785.0000	4.3	30.0	4.3	69.828	PASS
ac20-mode [VHT-MCS5]; 5825MHz	5825.0000	4.1	30.0	4.1	69.720	PASS
ac20-mode [VHT-MCS6]; 5180MHz	5180.0000	8.8	30.0	8.8	67.558	PASS
ac20-mode [VHT-MCS6]; 5200MHz	5200.0000	8.4	30.0	8.4	67.571	PASS
ac20-mode [VHT-MCS6]; 5240MHz	5240.0000	9.2	30.0	9.2	67.618	PASS
ac20-mode [VHT-MCS6]; 5745MHz	5745.0000	3.9	30.0	3.9	67.506	PASS
ac20-mode [VHT-MCS6]; 5785MHz	5785.0000	4.3	30.0	4.3	67.628	PASS
ac20-mode [VHT-MCS6]; 5825MHz	5825.0000	4.2	30.0	4.2	67.599	PASS
ac20-mode [VHT-MCS7]; 5180MHz	5180.0000	8.8	30.0	8.8	65.690	PASS
ac20-mode [VHT-MCS7]; 5200MHz	5200.0000	8.4	30.0	8.4	65.918	PASS
ac20-mode [VHT-MCS7]; 5240MHz	5240.0000	9.1	30.0	9.1	65.781	PASS
ac20-mode [VHT-MCS7]; 5745MHz	5745.0000	3.9	30.0	3.9	65.650	PASS
ac20-mode [VHT-MCS7]; 5785MHz	5785.0000	4.3	30.0	4.3	65.850	PASS
ac20-mode [VHT-MCS7]; 5825MHz	5825.0000	4.1	30.0	4.1	65.746	PASS

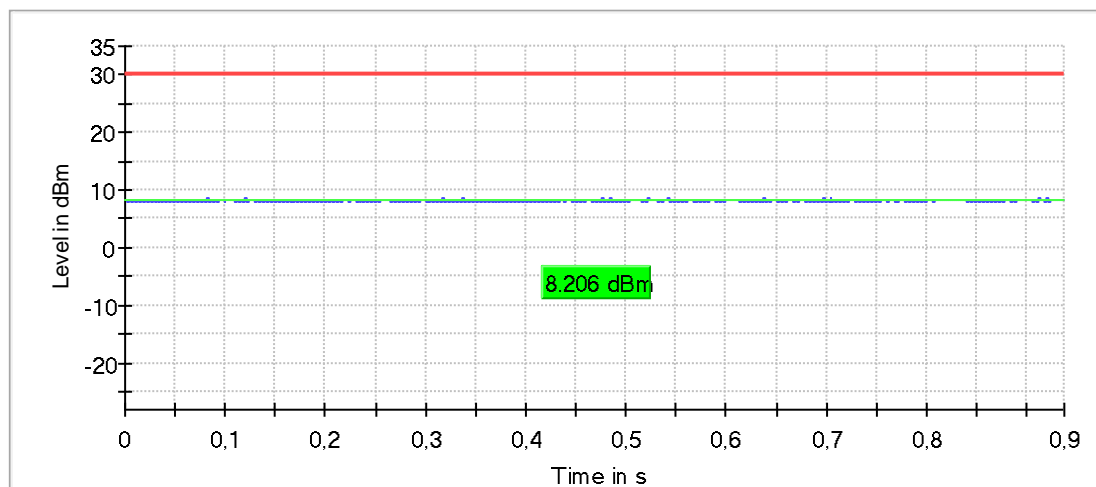
RF output power (5180 MHz; ac20-mode [VHT-MCS0] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5180.000000	8.2	30.0	8.2	93.902	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

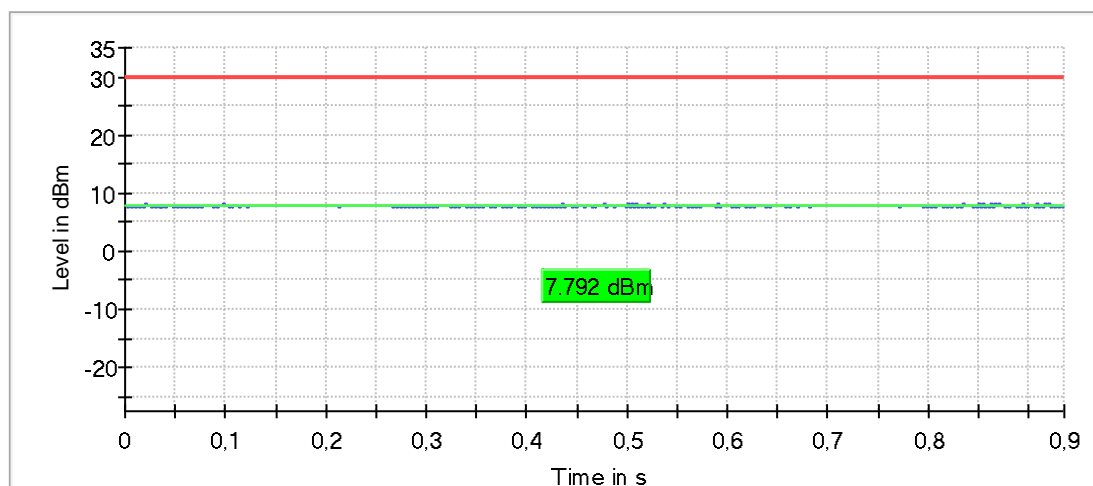
RF output power (5200 MHz; ac20-mode [VHT-MCS0] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5200.000000	7.8	30.0	7.8	93.835	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 µs	1.000 µs
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 µs	1.000 µs

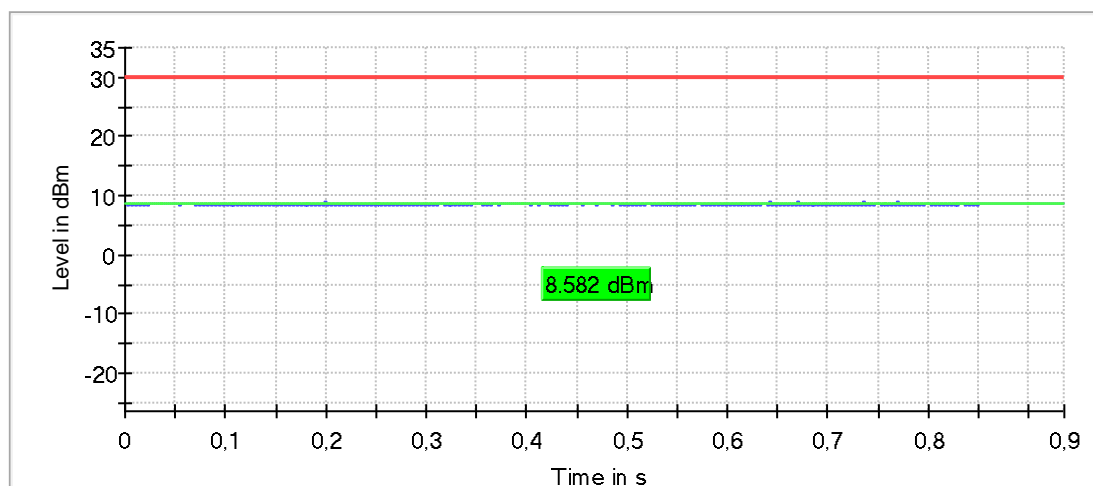
RF output power (5240 MHz; ac20-mode [VHT-MCS0] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5240.000000	8.6	30.0	8.6	93.868	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

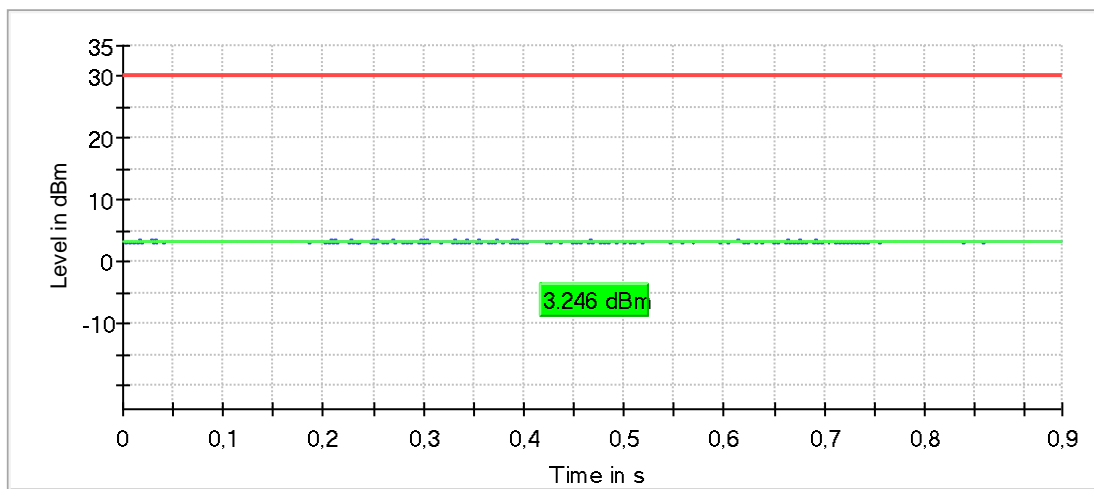
RF output power (5745 MHz; ac20-mode [VHT-MCS0] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5745.000000	3.2	30.0	3.2	93.938	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

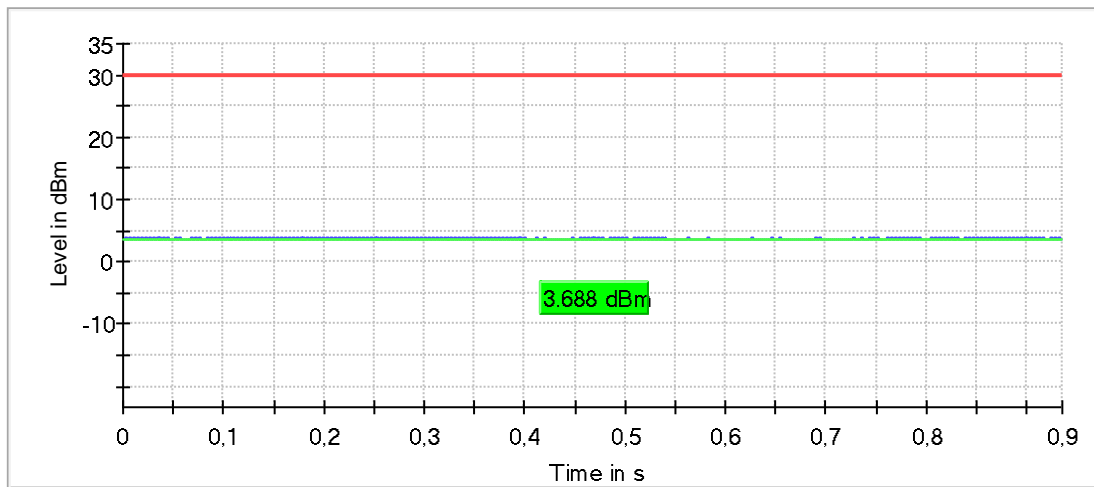
RF output power (5785 MHz; ac20-mode [VHT-MCS0] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5785.000000	3.7	30.0	3.7	93.928	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

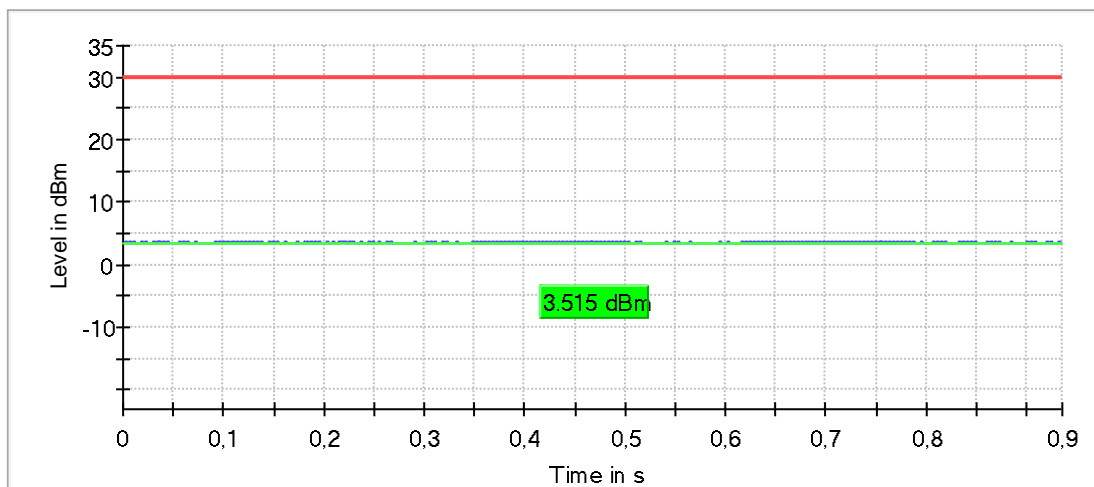
RF output power (5825 MHz; ac20-mode [VHT-MCS0] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5825.000000	3.5	30.0	3.5	93.833	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μs	1.000 μs

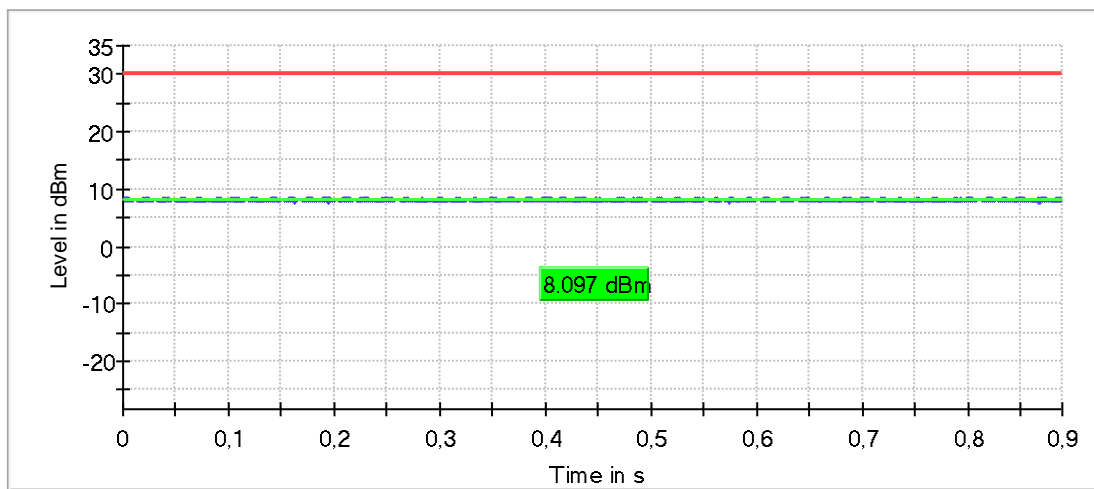
RF output power (5180 MHz; ac20-mode [VHT-MCS1] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5180.000000	8.1	30.0	8.1	89.043	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μs	1.000 μs

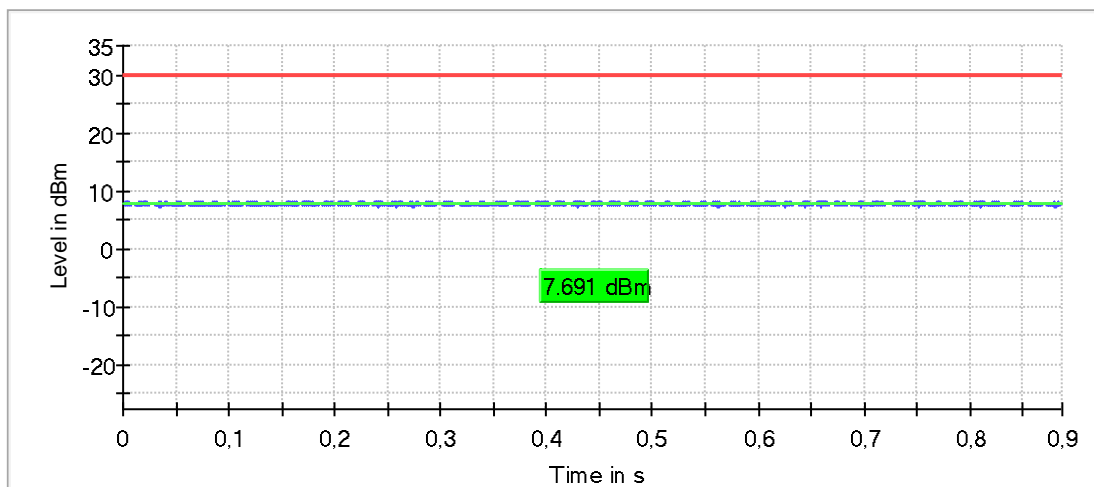
RF output power (5200 MHz; ac20-mode [VHT-MCS1] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5200.000000	7.7	30.0	7.7	88.838	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μs	1.000 μs

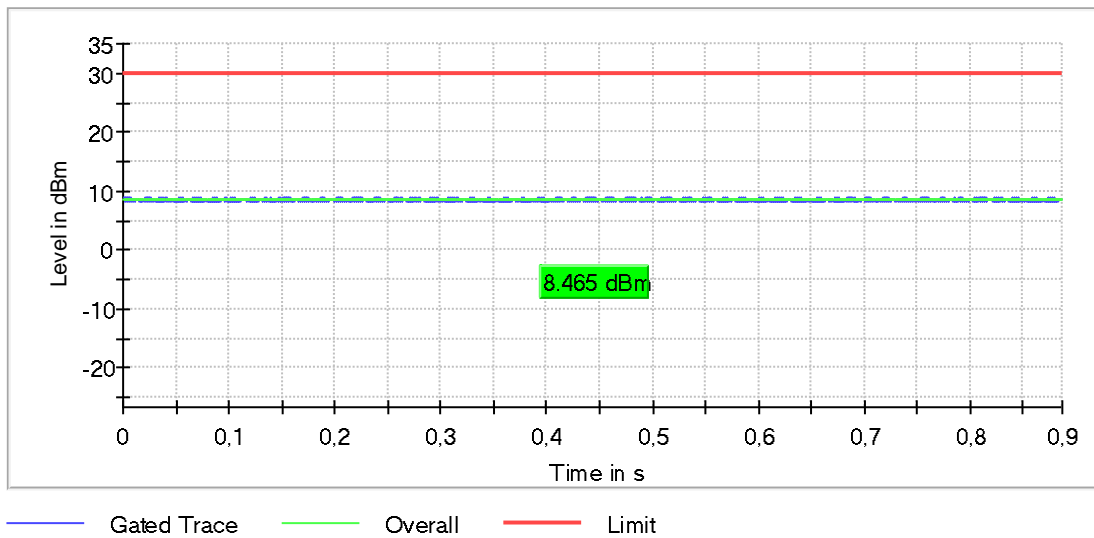
RF output power (5240 MHz; ac20-mode [VHT-MCS1] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5240.000000	8.5	30.0	8.5	88.978	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μs	1.000 μs

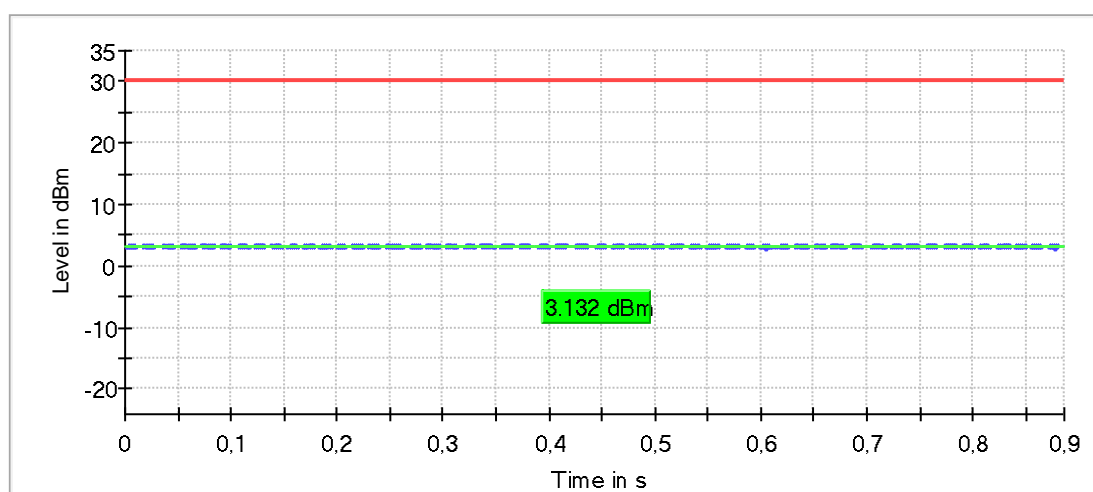
RF output power (5745 MHz; ac20-mode [VHT-MCS1] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5745.000000	3.1	30.0	3.1	88.904	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μs	1.000 μs

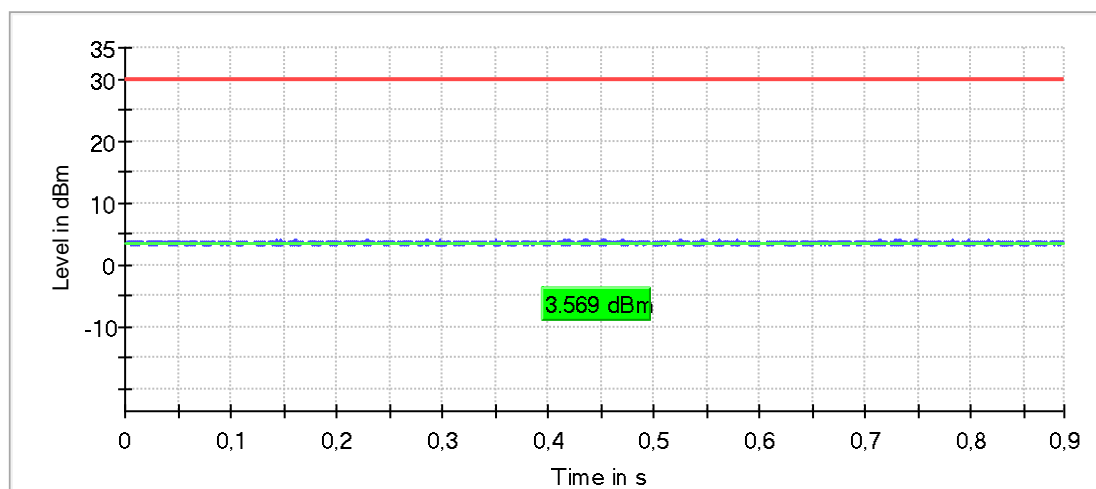
RF output power (5785 MHz; ac20-mode [VHT-MCS1] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5785.000000	3.6	30.0	3.6	89.019	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

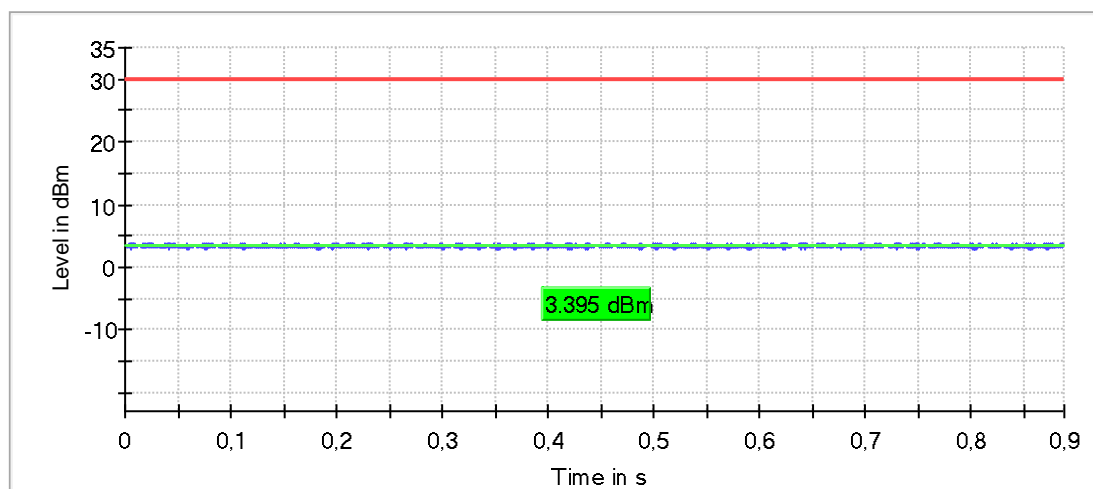
RF output power (5825 MHz; ac20-mode [VHT-MCS1] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5825.000000	3.4	30.0	3.4	88.994	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μs	1.000 μs

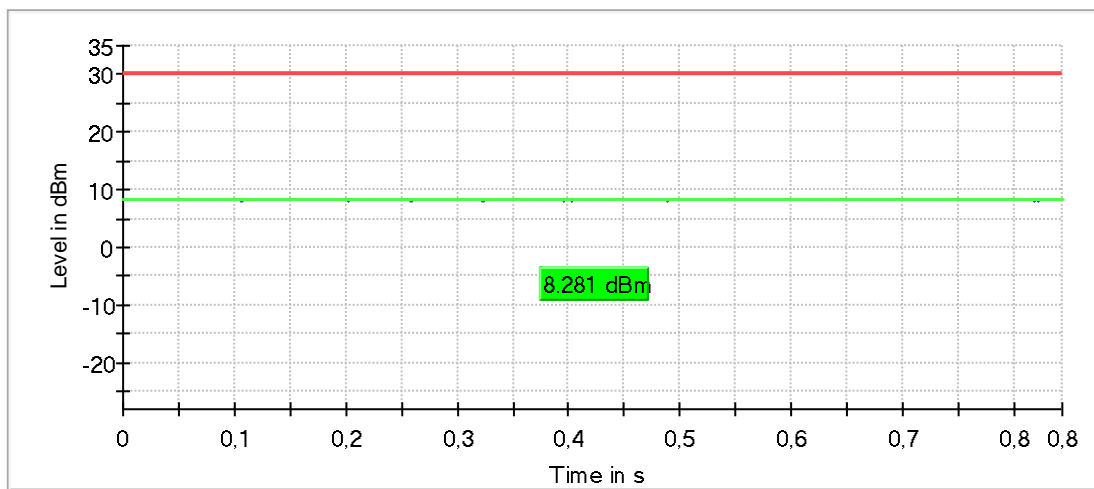
RF output power (5180 MHz; ac20-mode [VHT-MCS2] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5180.000000	8.3	30.0	8.3	84.492	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

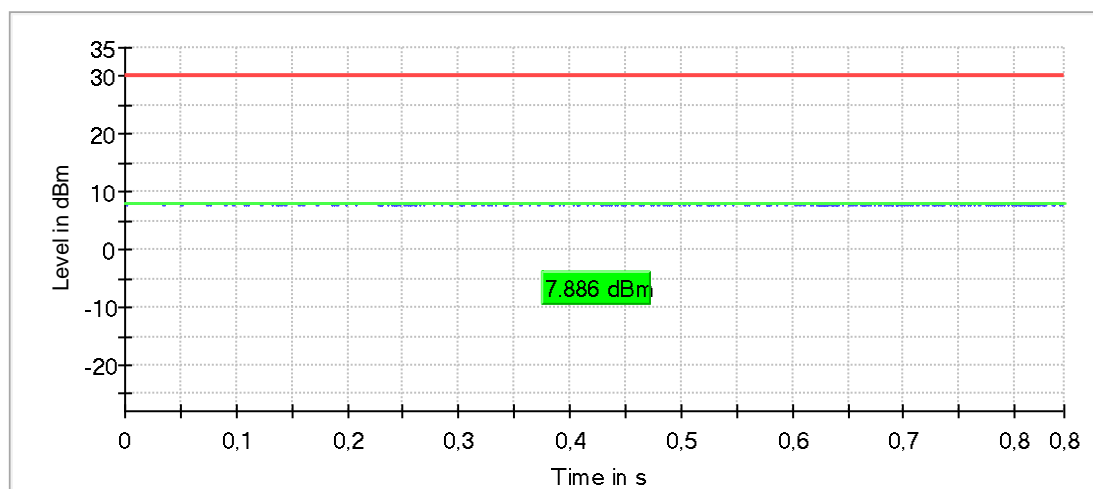
RF output power (5200 MHz; ac20-mode [VHT-MCS2] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5200.000000	7.9	30.0	7.9	84.644	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μs	1.000 μs

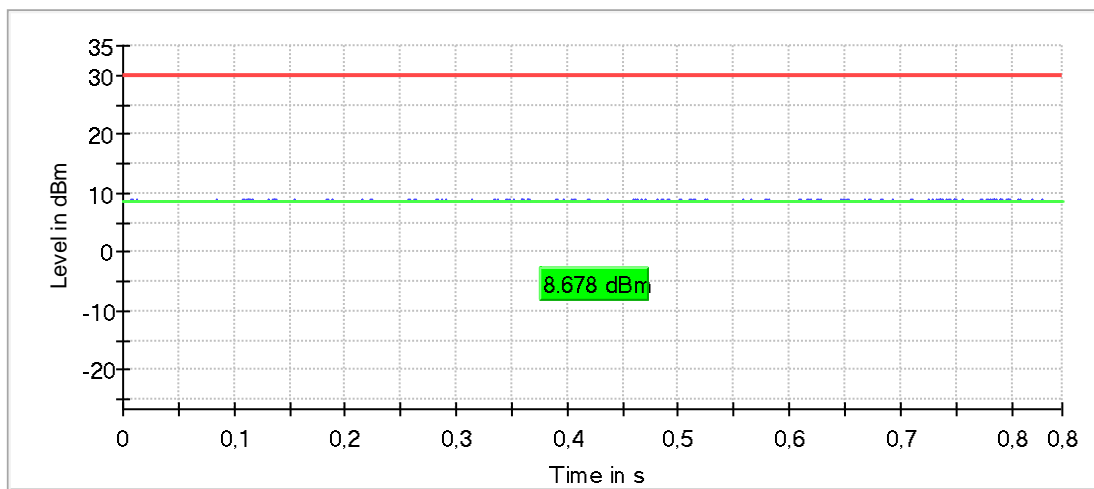
RF output power (5240 MHz; ac20-mode [VHT-MCS2] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5240.000000	8.7	30.0	8.7	84.795	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 µs	1.000 µs

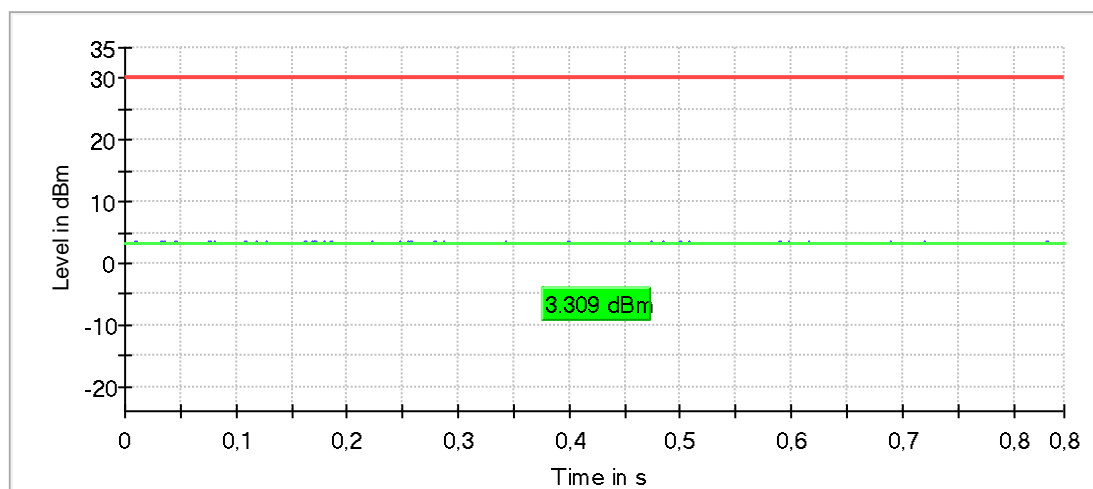
RF output power (5745 MHz; ac20-mode [VHT-MCS2] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5745.000000	3.3	30.0	3.3	84.783	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μs	1.000 μs

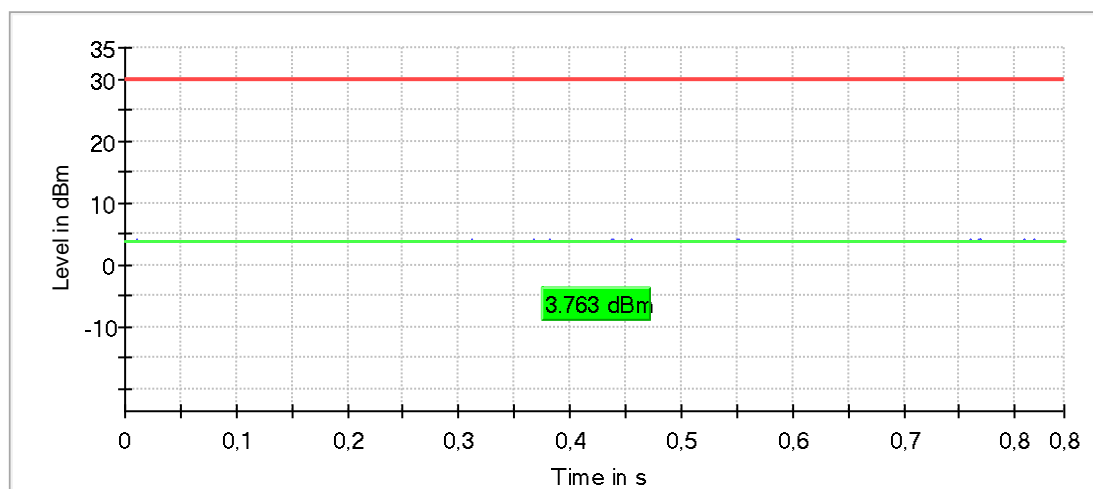
RF output power (5785 MHz; ac20-mode [VHT-MCS2] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5785.000000	3.8	30.0	3.8	84.617	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μs	1.000 μs

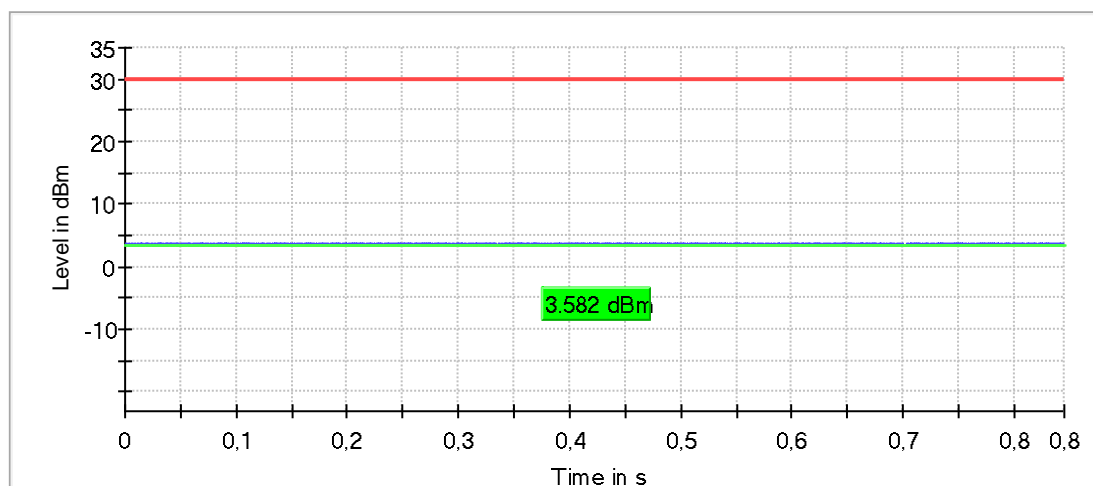
RF output power (5825 MHz; ac20-mode [VHT-MCS2] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5825.000000	3.6	30.0	3.6	84.717	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μs	1.000 μs

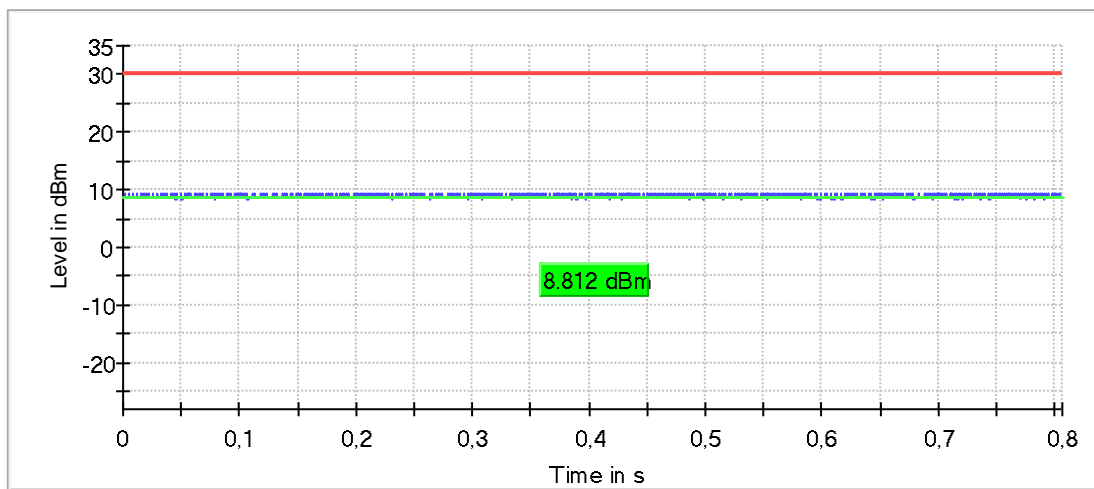
RF output power (5180 MHz; ac20-mode [VHT-MCS3] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5180.000000	8.8	30.0	8.8	80.900	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

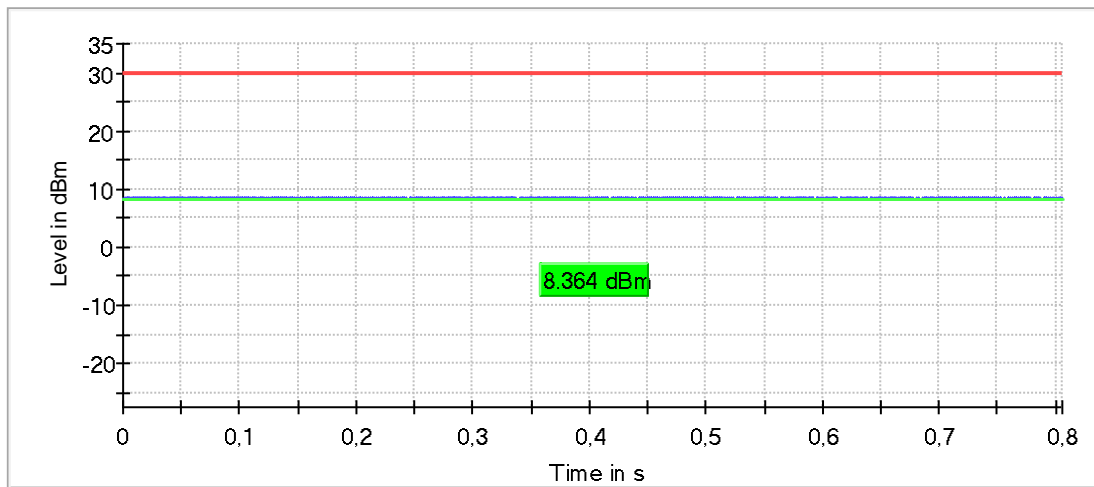
RF output power (5200 MHz; ac20-mode [VHT-MCS3] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5200.000000	8.4	30.0	8.4	80.808	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μs	1.000 μs

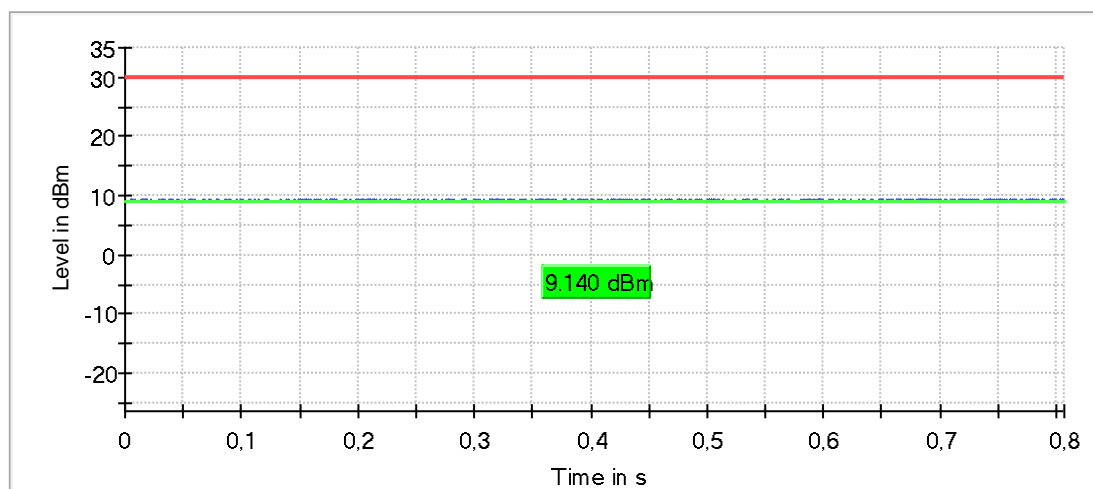
RF output power (5240 MHz; ac20-mode [VHT-MCS3] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5240.000000	9.1	30.0	9.1	80.865	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μs	1.000 μs

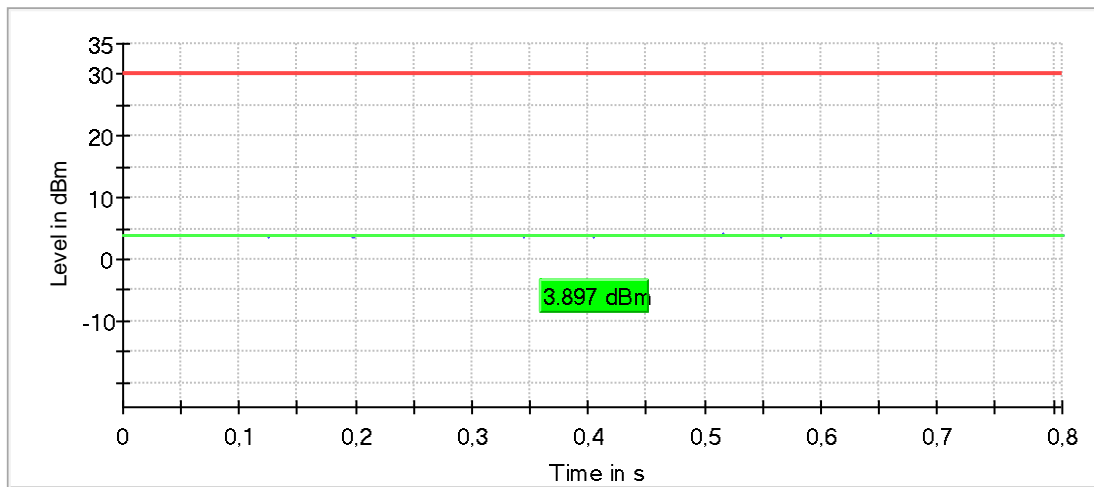
RF output power (5745 MHz; ac20-mode [VHT-MCS3] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5745.000000	3.9	30.0	3.9	80.957	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

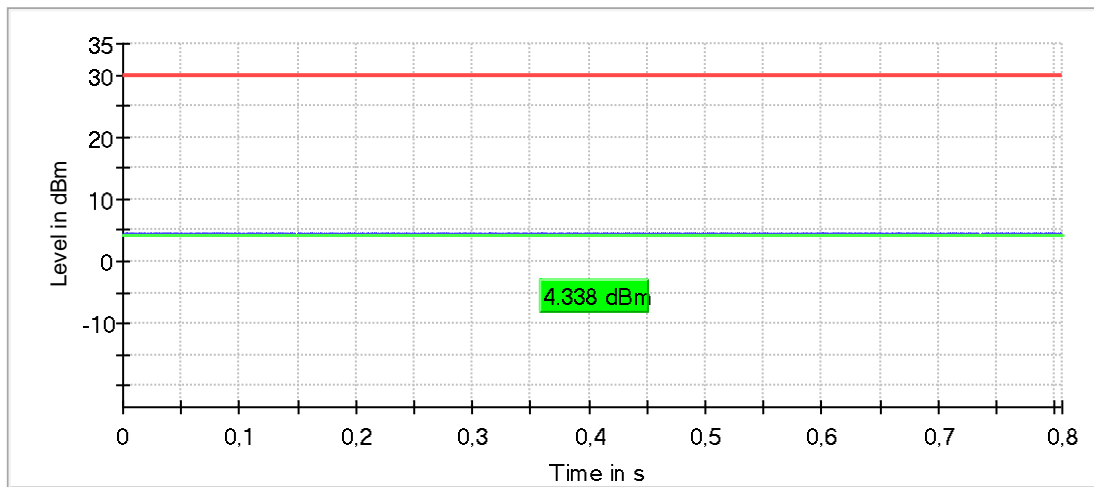
RF output power (5785 MHz; ac20-mode [VHT-MCS3] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5785.000000	4.3	30.0	4.3	80.835	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μs	1.000 μs

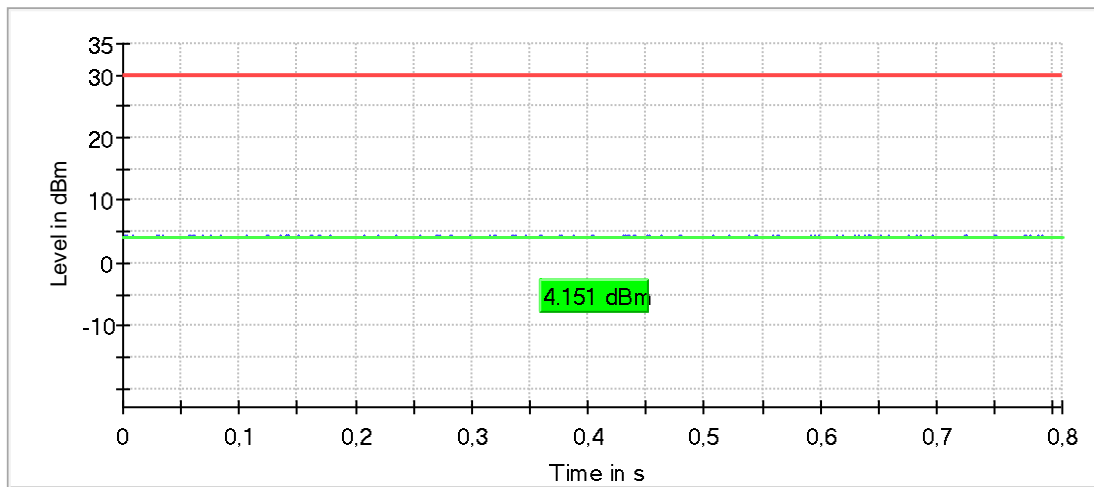
RF output power (5825 MHz; ac20-mode [VHT-MCS3] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5825.000000	4.2	30.0	4.2	81.022	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μs	1.000 μs

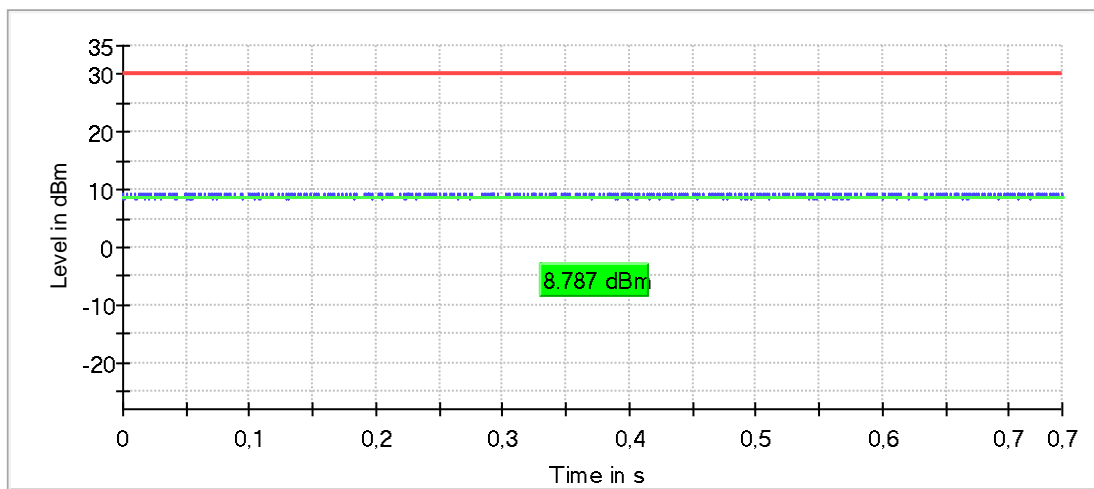
RF output power (5180 MHz; ac20-mode [VHT-MCS4] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5180.000000	8.8	30.0	8.8	74.425	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

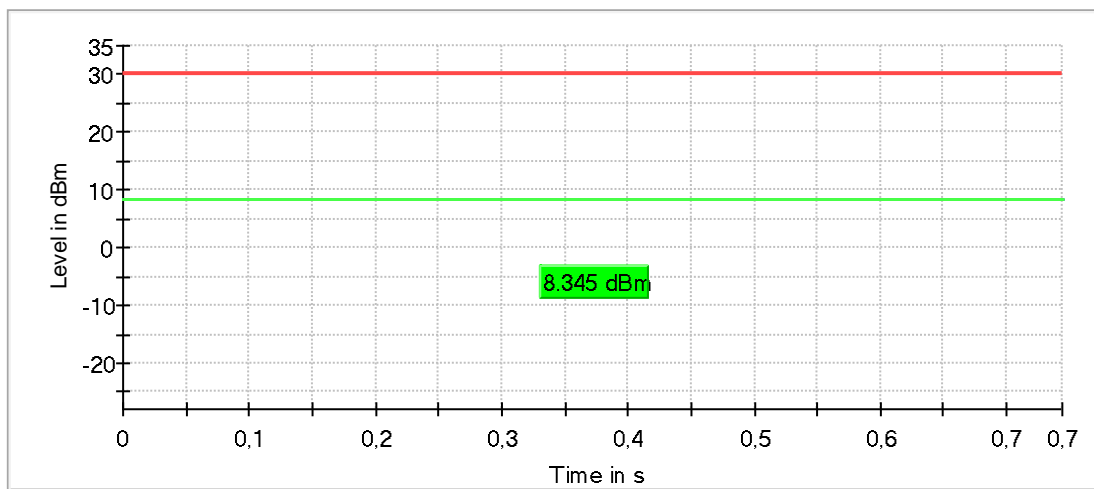
RF output power (5200 MHz; ac20-mode [VHT-MCS4] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5200.000000	8.3	30.0	8.3	74.676	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μs	1.000 μs

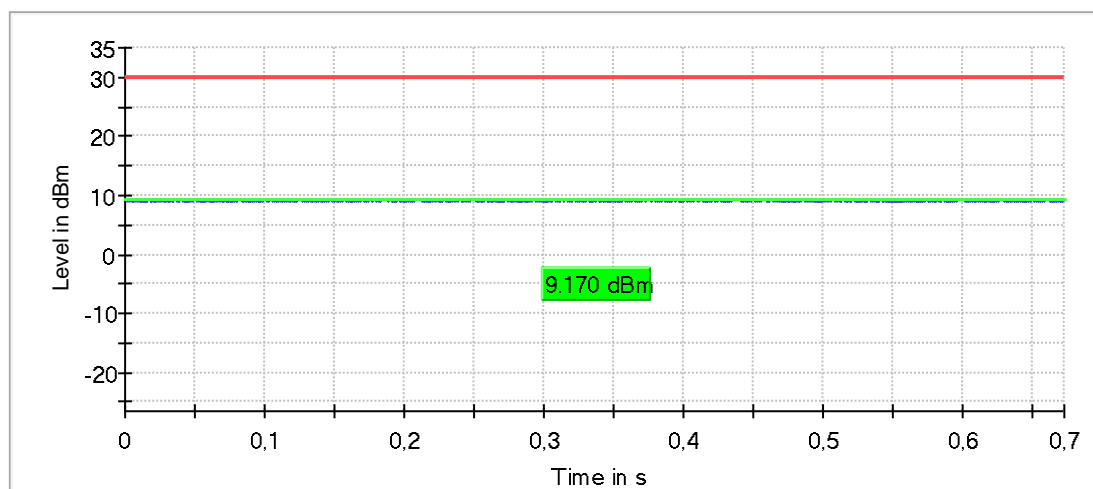
RF output power (5240 MHz; ac20-mode [VHT-MCS4] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5240.000000	9.2	30.0	9.2	74.654	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μs	1.000 μs

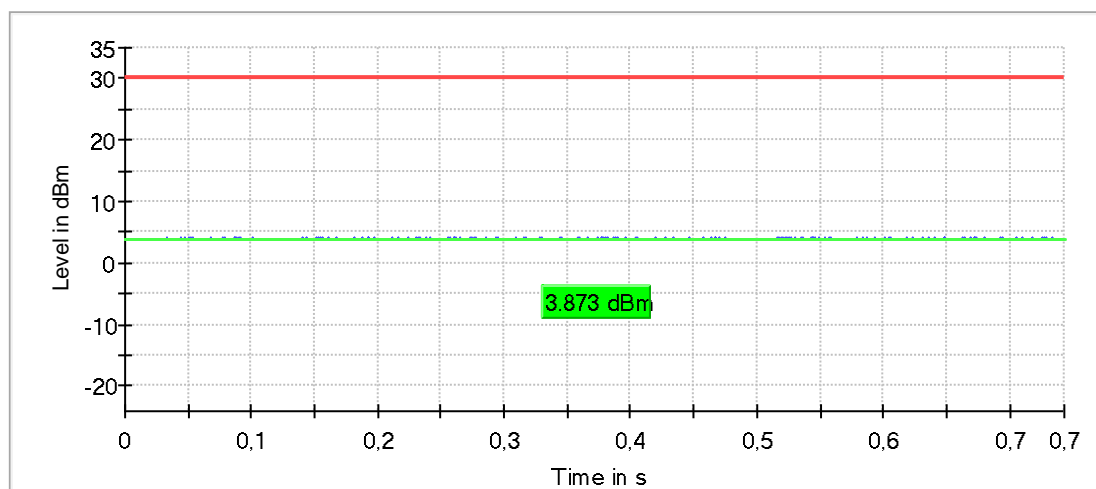
RF output power (5745 MHz; ac20-mode [VHT-MCS4] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5745.000000	3.9	30.0	3.9	74.565	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μs	1.000 μs

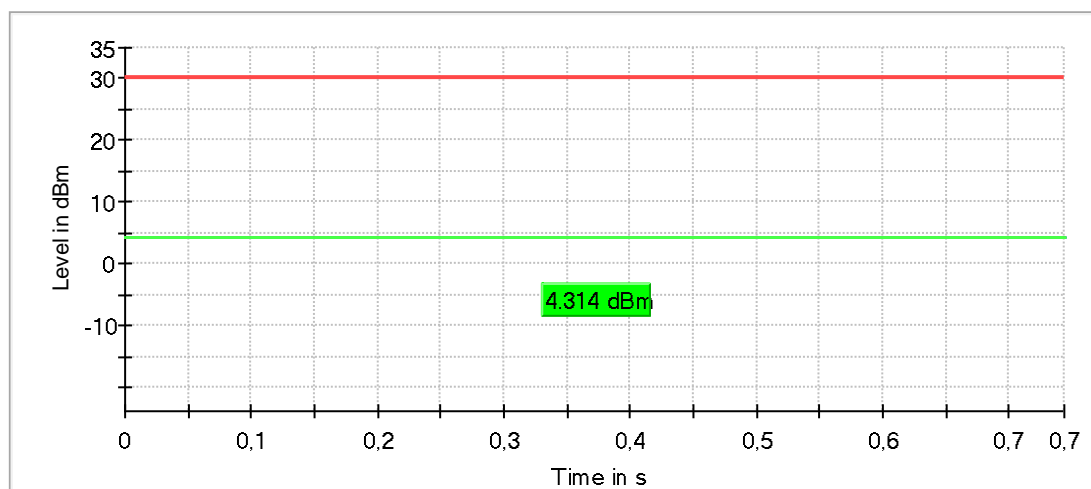
RF output power (5785 MHz; ac20-mode [VHT-MCS4] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5785.000000	4.3	30.0	4.3	74.644	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 µs	1.000 µs
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 µs	1.000 µs

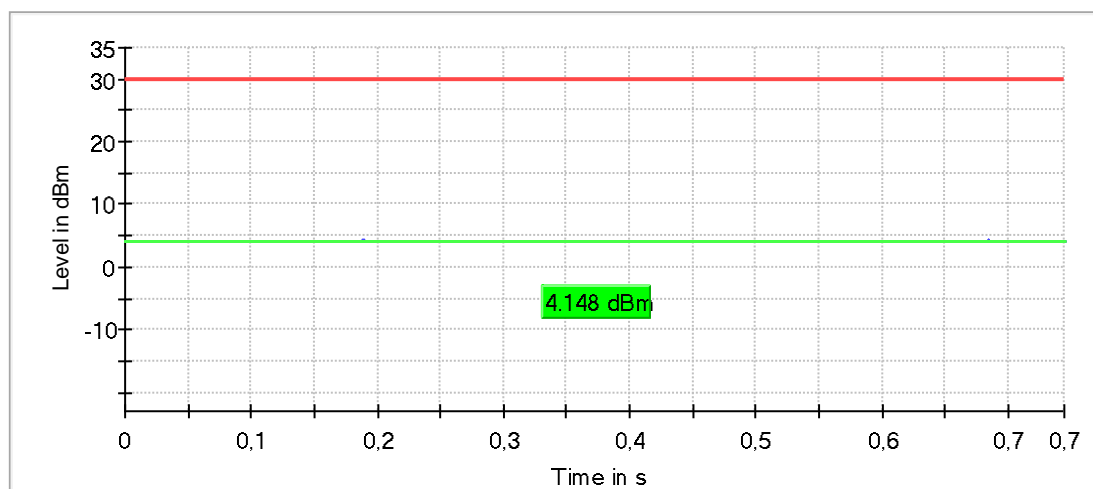
RF output power (5825 MHz; ac20-mode [VHT-MCS4] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5825.000000	4.1	30.0	4.1	74.720	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μs	1.000 μs

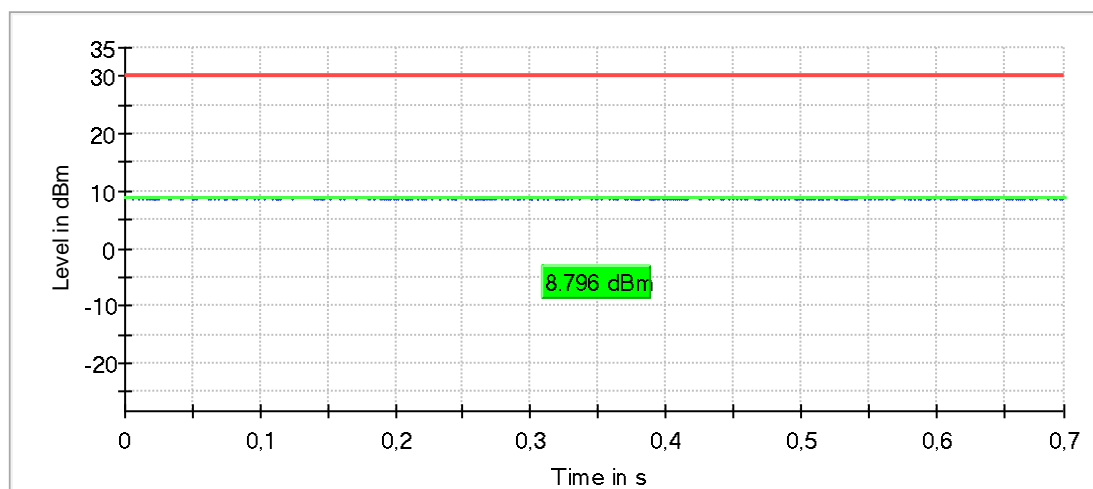
RF output power (5180 MHz; ac20-mode [VHT-MCS5] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5180.000000	8.8	30.0	8.8	69.763	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

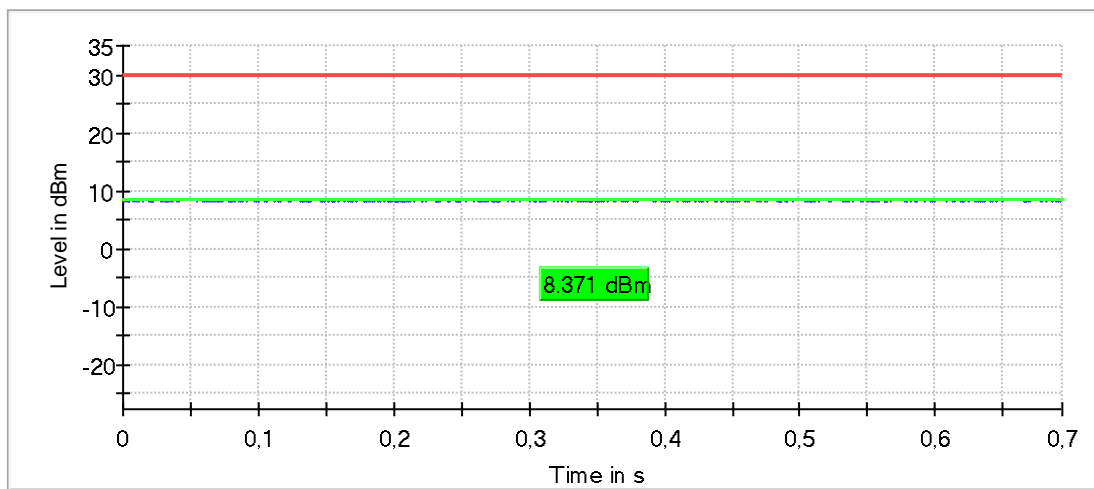
RF output power (5200 MHz; ac20-mode [VHT-MCS5] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5200.000000	8.4	30.0	8.4	69.648	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μs	1.000 μs

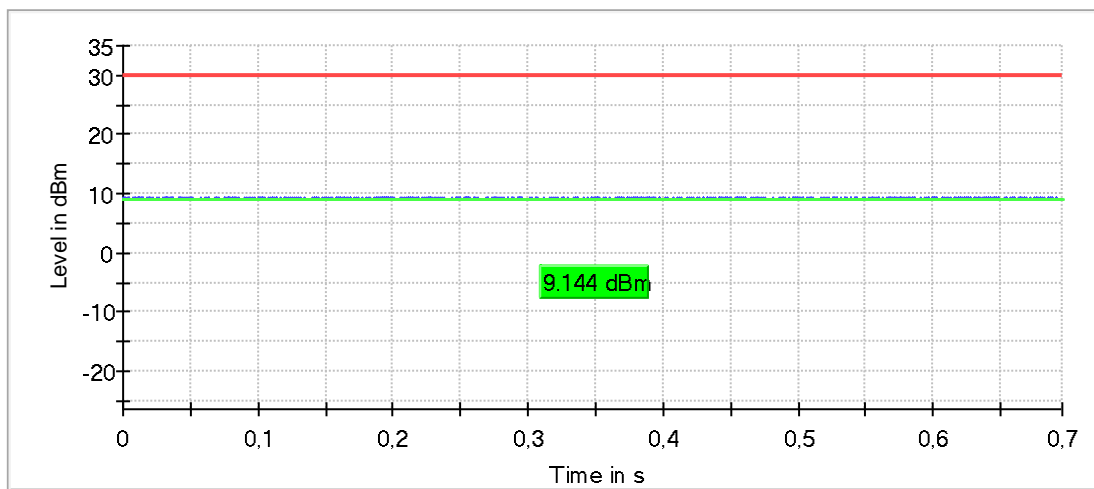
RF output power (5240 MHz; ac20-mode [VHT-MCS5] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5240.000000	9.1	30.0	9.1	69.837	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

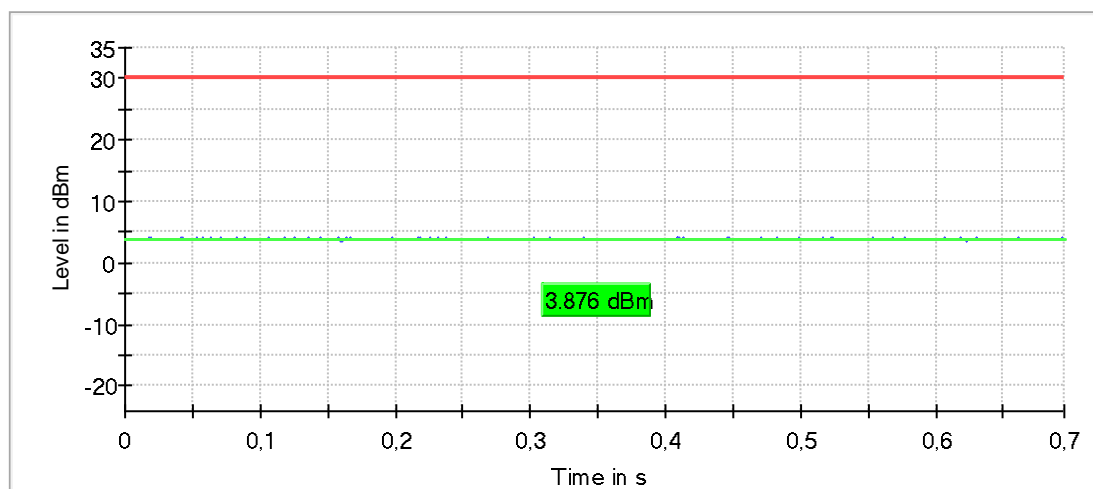
RF output power (5745 MHz; ac20-mode [VHT-MCS5] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5745.000000	3.9	30.0	3.9	69.802	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μs	1.000 μs

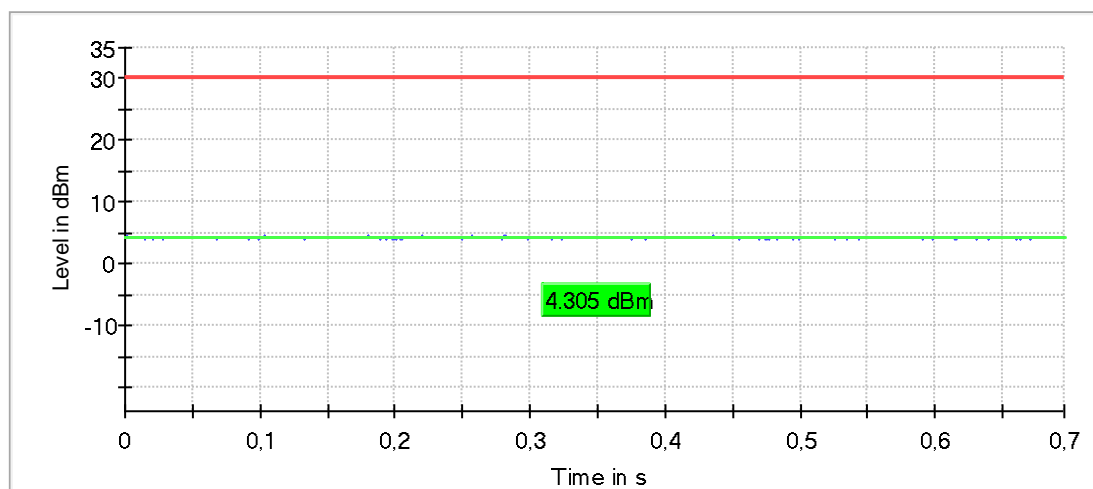
RF output power (5785 MHz; ac20-mode [VHT-MCS5] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5785.000000	4.3	30.0	4.3	69.828	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μs	1.000 μs

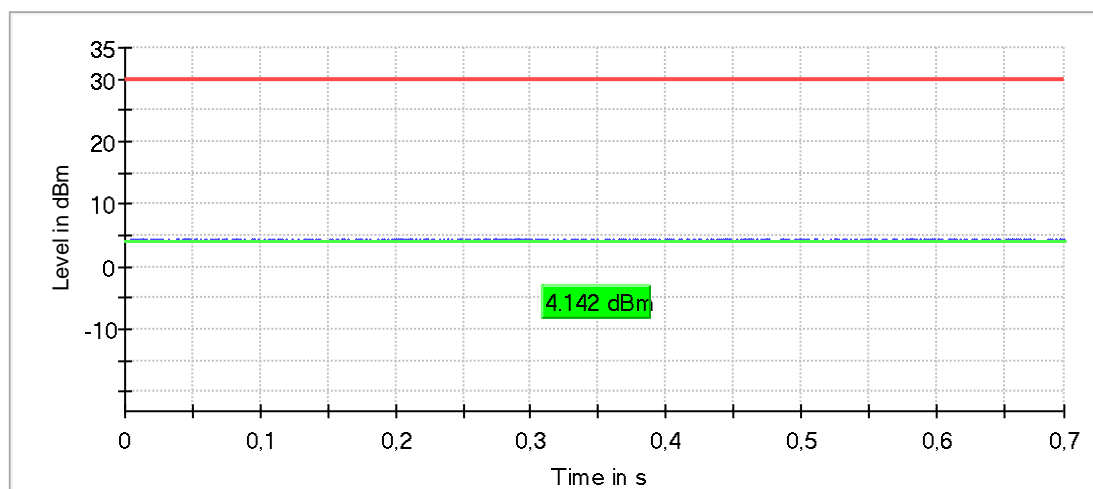
RF output power (5825 MHz; ac20-mode [VHT-MCS5] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5825.000000	4.1	30.0	4.1	69.720	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μs	1.000 μs

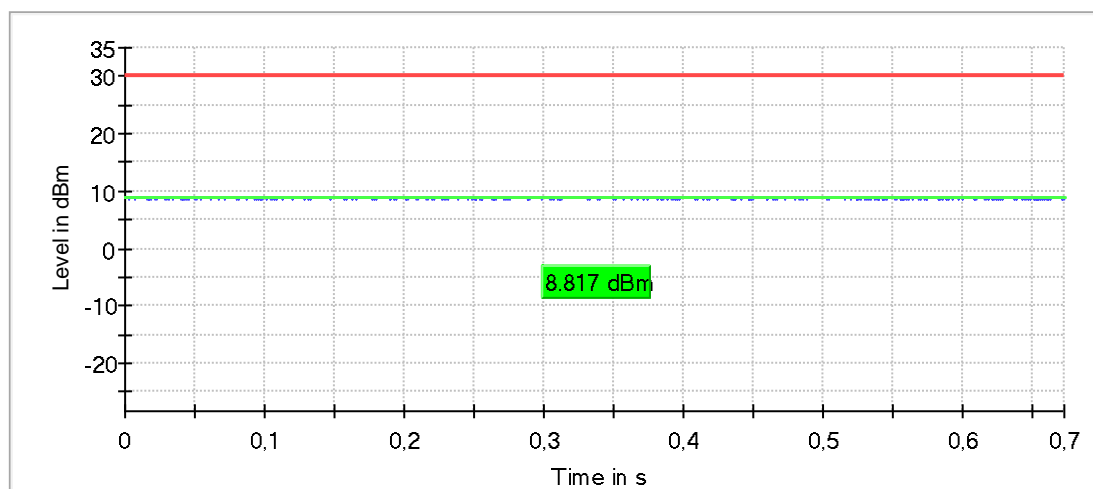
RF output power (5180 MHz; ac20-mode [VHT-MCS6] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5180.000000	8.8	30.0	8.8	67.558	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

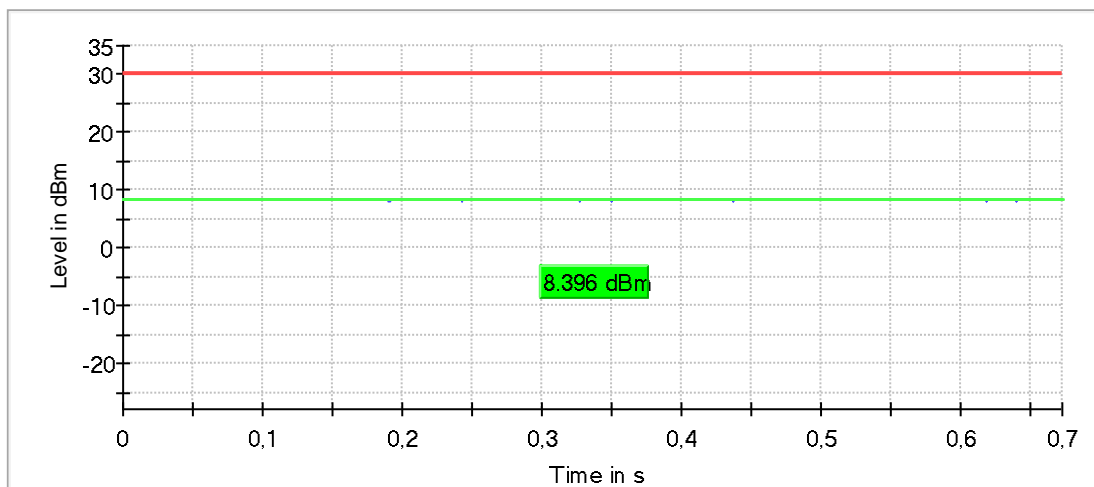
RF output power (5200 MHz; ac20-mode [VHT-MCS6] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5200.000000	8.4	30.0	8.4	67.571	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μs	1.000 μs

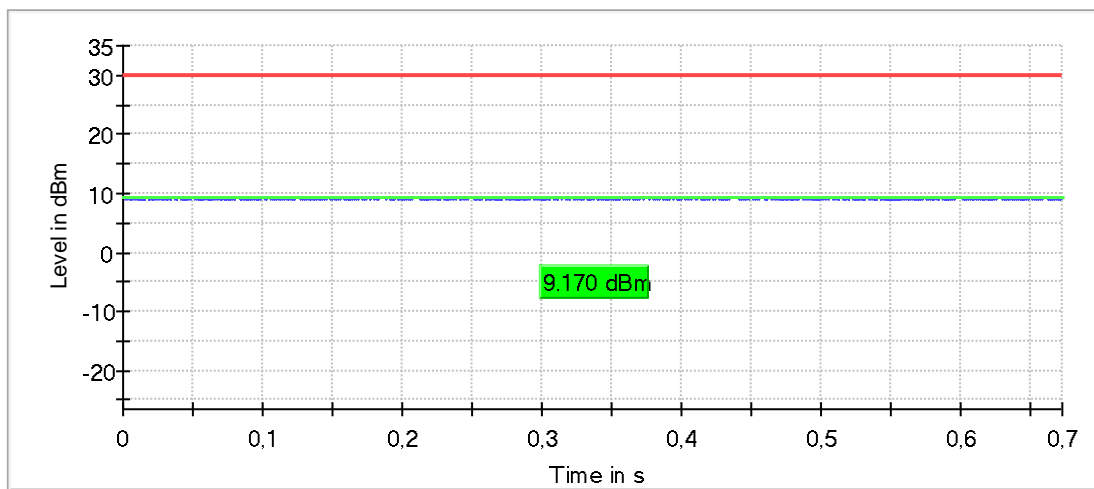
RF output power (5240 MHz; ac20-mode [VHT-MCS6] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5240.000000	9.2	30.0	9.2	67.618	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μs	1.000 μs

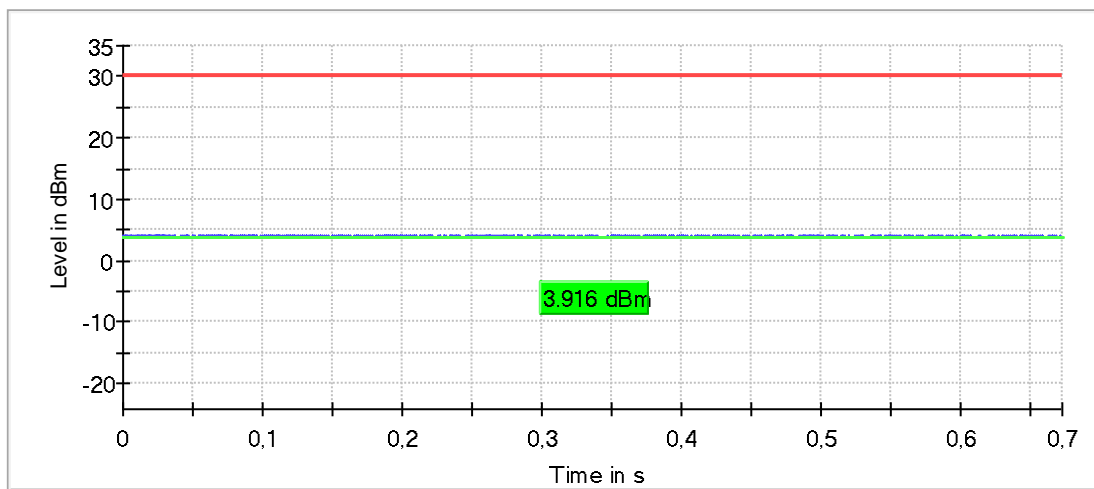
RF output power (5745 MHz; ac20-mode [VHT-MCS6] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5745.000000	3.9	30.0	3.9	67.506	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μs	1.000 μs

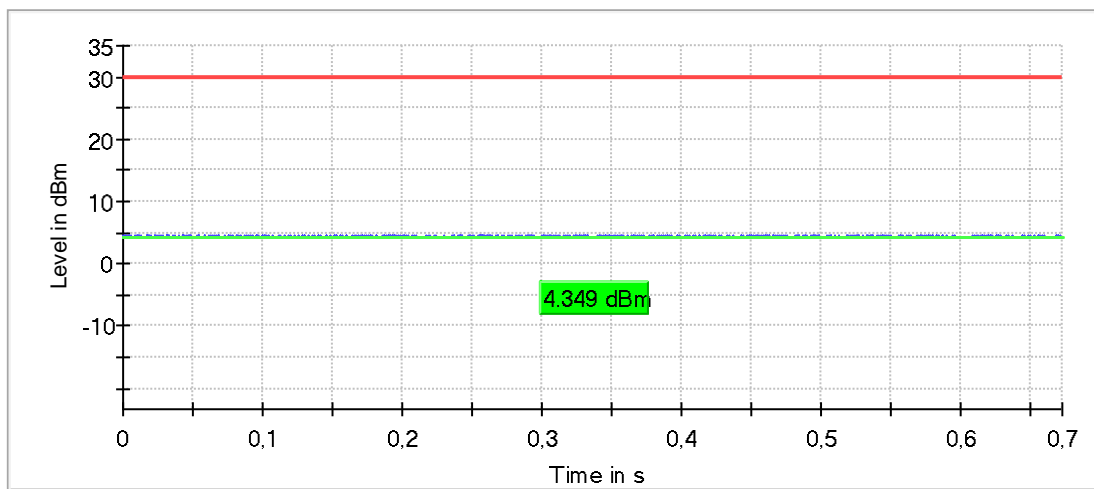
RF output power (5785 MHz; ac20-mode [VHT-MCS6] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5785.000000	4.3	30.0	4.3	67.628	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μs	1.000 μs

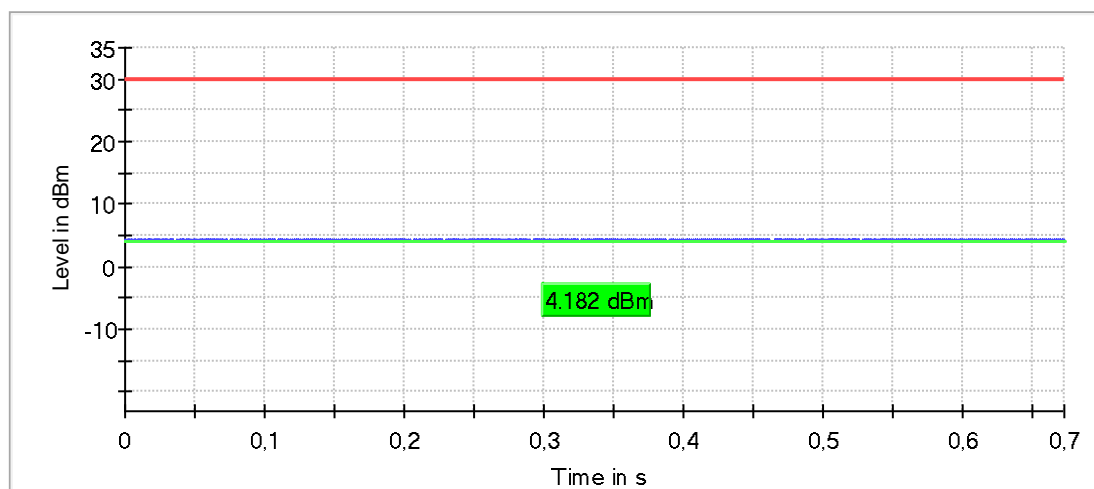
RF output power (5825 MHz; ac20-mode [VHT-MCS6] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5825.000000	4.2	30.0	4.2	67.599	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

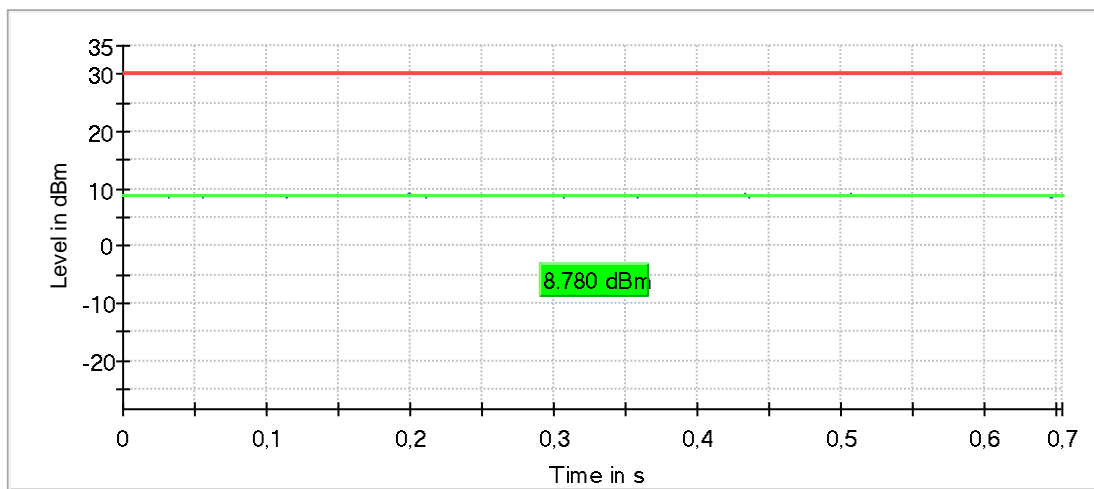
RF output power (5180 MHz; ac20-mode [VHT-MCS7] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5180.000000	8.8	30.0	8.8	65.690	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

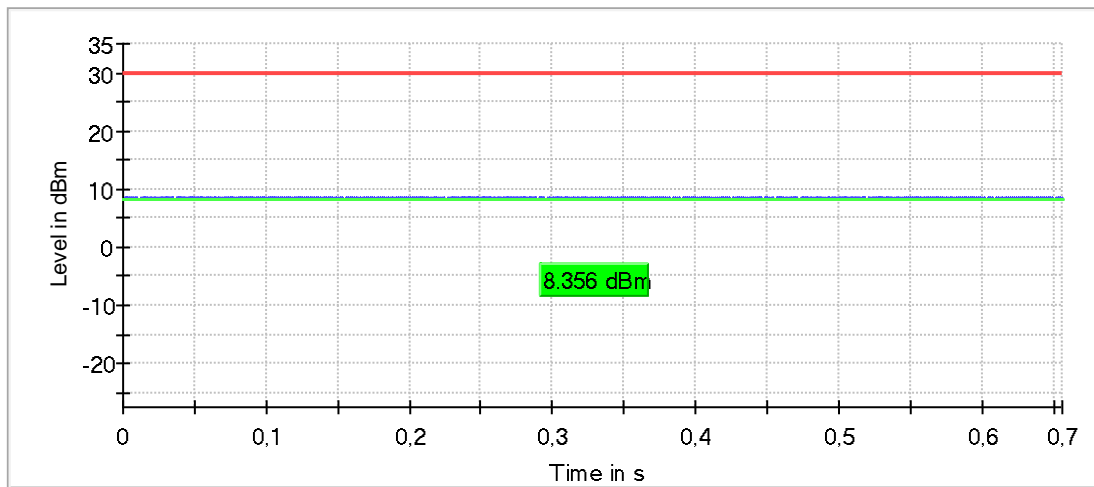
RF output power (5200 MHz; ac20-mode [VHT-MCS7] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5200.000000	8.4	30.0	8.4	65.918	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μs	1.000 μs

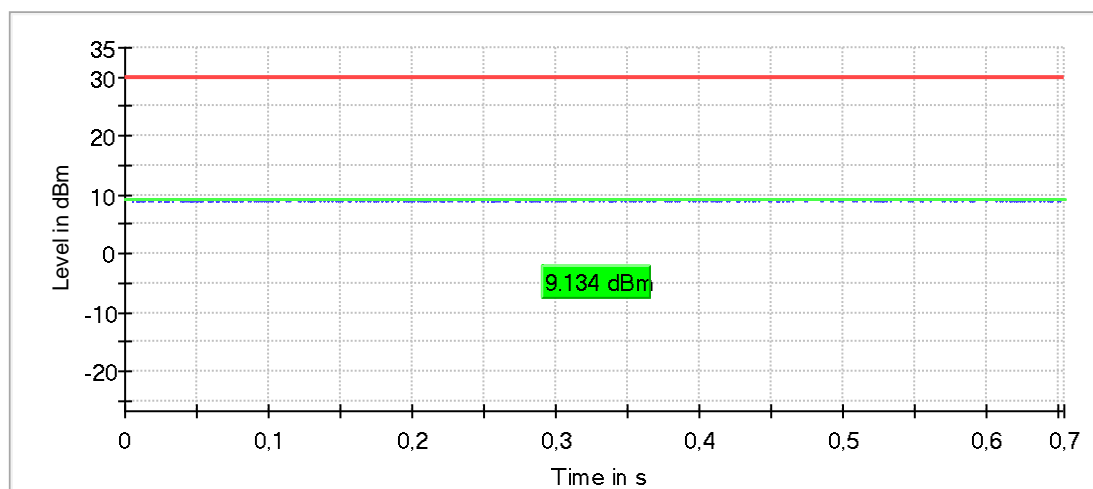
RF output power (5240 MHz; ac20-mode [VHT-MCS7] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5240.000000	9.1	30.0	9.1	65.781	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

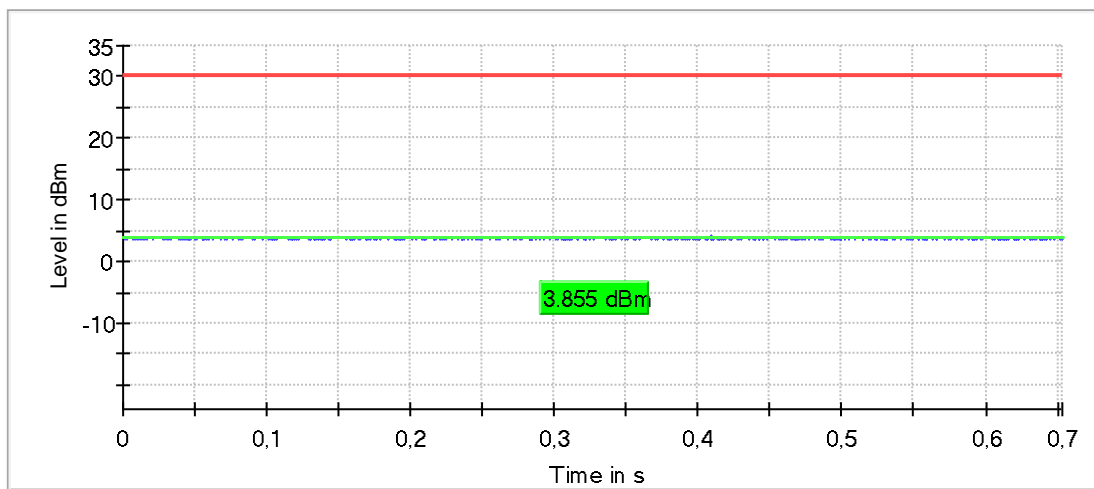
RF output power (5745 MHz; ac20-mode [VHT-MCS7] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5745.000000	3.9	30.0	3.9	65.650	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 µs	1.000 µs

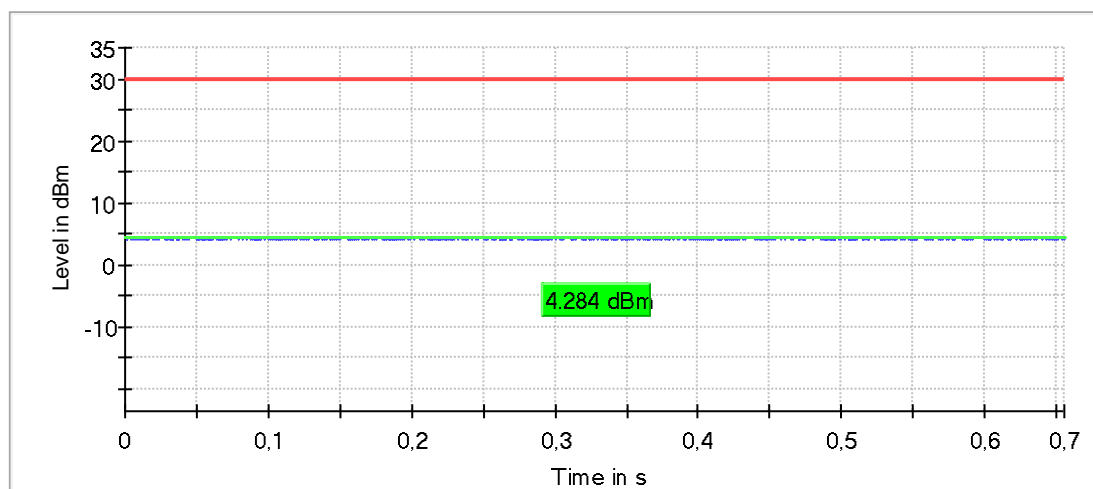
RF output power (5785 MHz; ac20-mode [VHT-MCS7] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5785.000000	4.3	30.0	4.3	65.850	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μs	1.000 μs

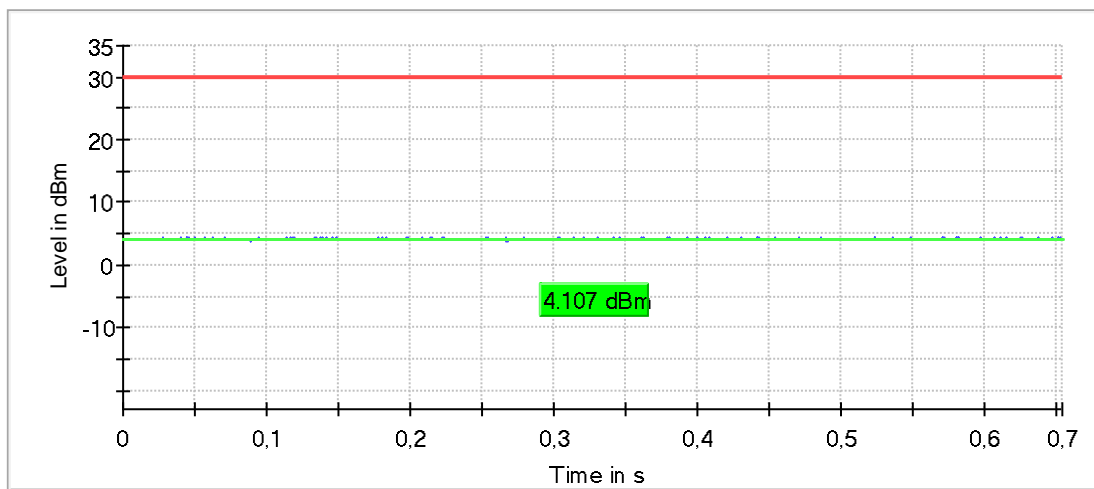
RF output power (5825 MHz; ac20-mode [VHT-MCS7] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5825.000000	4.1	30.0	4.1	65.746	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μs	1.000 μs

RF output power

Mode	DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
n40-mode [MCS0]; 5190MHz	5190.0000	8.5	30.0	8.5	88.619	PASS
n40-mode [MCS0]; 5230MHz	5230.0000	8.9	30.0	8.9	88.730	PASS
n40-mode [MCS0]; 5755MHz	5755.0000	4.2	30.0	4.2	88.661	PASS
n40-mode [MCS0]; 5795MHz	5795.0000	4.1	30.0	4.1	88.596	PASS
n40-mode [MCS1]; 5190MHz	5190.0000	8.5	30.0	8.5	80.206	PASS
n40-mode [MCS1]; 5230MHz	5230.0000	8.9	30.0	8.9	80.128	PASS
n40-mode [MCS1]; 5755MHz	5755.0000	4.2	30.0	4.2	80.422	PASS
n40-mode [MCS1]; 5795MHz	5795.0000	4.1	30.0	4.1	80.302	PASS
n40-mode [MCS2]; 5190MHz	5190.0000	8.5	30.0	8.5	73.914	PASS
n40-mode [MCS2]; 5230MHz	5230.0000	8.9	30.0	8.9	73.803	PASS
n40-mode [MCS2]; 5755MHz	5755.0000	4.2	30.0	4.2	73.902	PASS
n40-mode [MCS2]; 5795MHz	5795.0000	4.1	30.0	4.1	73.662	PASS
n40-mode [MCS3]; 5190MHz	5190.0000	8.6	30.0	8.6	68.790	PASS
n40-mode [MCS3]; 5230MHz	5230.0000	9.0	30.0	9.0	68.586	PASS
n40-mode [MCS3]; 5755MHz	5755.0000	4.3	30.0	4.3	68.686	PASS
n40-mode [MCS3]; 5795MHz	5795.0000	4.2	30.0	4.2	68.534	PASS
n40-mode [MCS4]; 5190MHz	5190.0000	8.6	30.0	8.6	60.998	PASS
n40-mode [MCS4]; 5230MHz	5230.0000	9.0	30.0	9.0	60.965	PASS
n40-mode [MCS4]; 5755MHz	5755.0000	4.3	30.0	4.3	61.065	PASS
n40-mode [MCS4]; 5795MHz	5795.0000	4.2	30.0	4.2	61.080	PASS
n40-mode [MCS5]; 5190MHz	5190.0000	8.6	30.0	8.6	56.032	PASS
n40-mode [MCS5]; 5230MHz	5230.0000	9.0	30.0	9.0	55.897	PASS
n40-mode [MCS5]; 5755MHz	5755.0000	4.3	30.0	4.3	56.012	PASS
n40-mode [MCS5]; 5795MHz	5795.0000	4.2	30.0	4.2	56.074	PASS
n40-mode [MCS6]; 5190MHz	5190.0000	8.6	30.0	8.6	53.696	PASS
n40-mode [MCS6]; 5230MHz	5230.0000	9.0	30.0	9.0	53.859	PASS
n40-mode [MCS6]; 5755MHz	5755.0000	4.3	30.0	4.3	53.973	PASS
n40-mode [MCS6]; 5795MHz	5795.0000	4.2	30.0	4.2	54.039	PASS
n40-mode [MCS7]; 5190MHz	5190.0000	8.6	30.0	8.6	51.635	PASS
n40-mode [MCS7]; 5230MHz	5230.0000	9.0	30.0	9.0	51.756	PASS
n40-mode [MCS7]; 5755MHz	5755.0000	4.2	30.0	4.2	51.825	PASS
n40-mode [MCS7]; 5795MHz	5795.0000	4.2	30.0	4.2	51.837	PASS

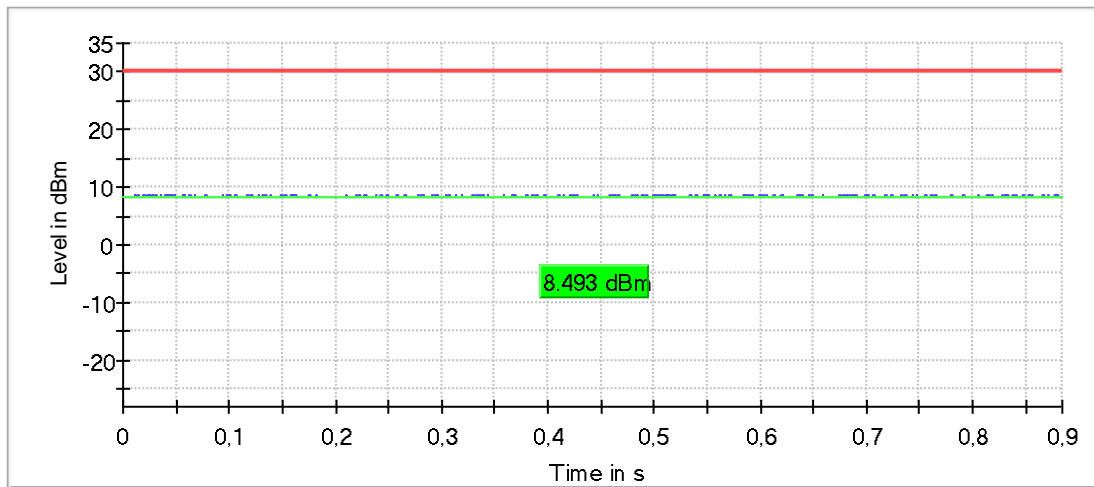
RF output power (5190 MHz; n40-mode [MCS0] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5190.000000	8.5	30.0	8.5	88.619	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

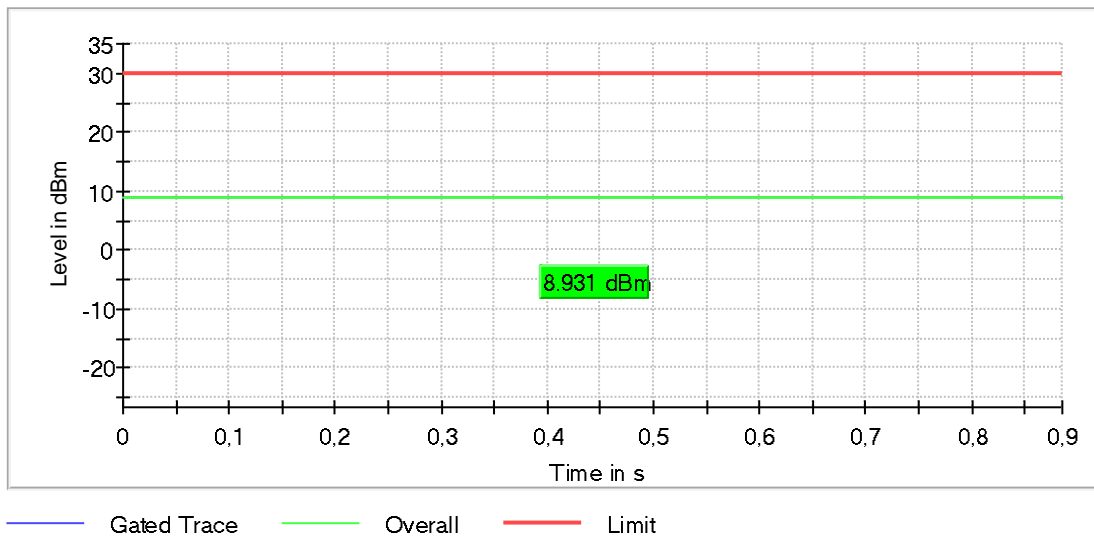
RF output power (5230 MHz; n40-mode [MCS0] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5230.000000	8.9	30.0	8.9	88.730	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 µs	1.000 µs

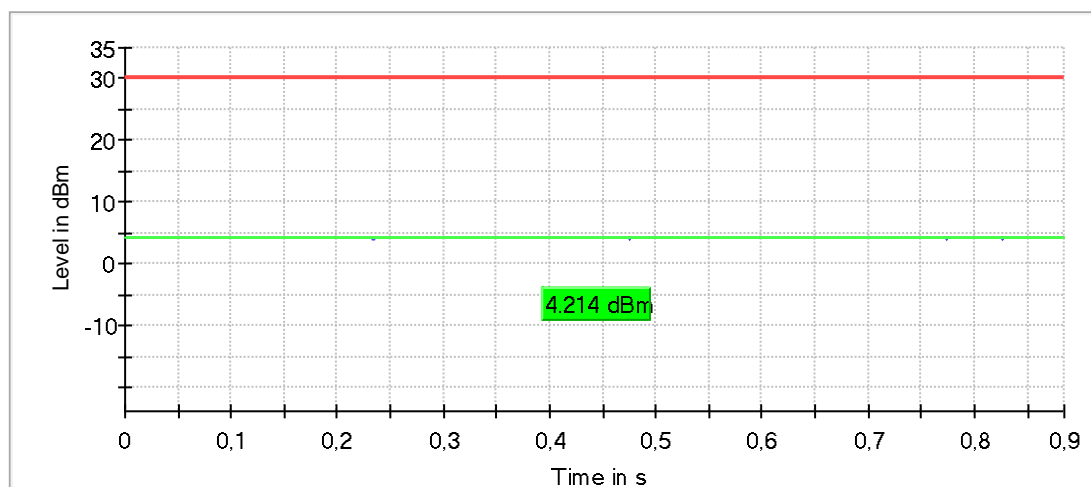
RF output power (5755 MHz; n40-mode [MCS0] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5755.000000	4.2	30.0	4.2	88.661	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μs	1.000 μs

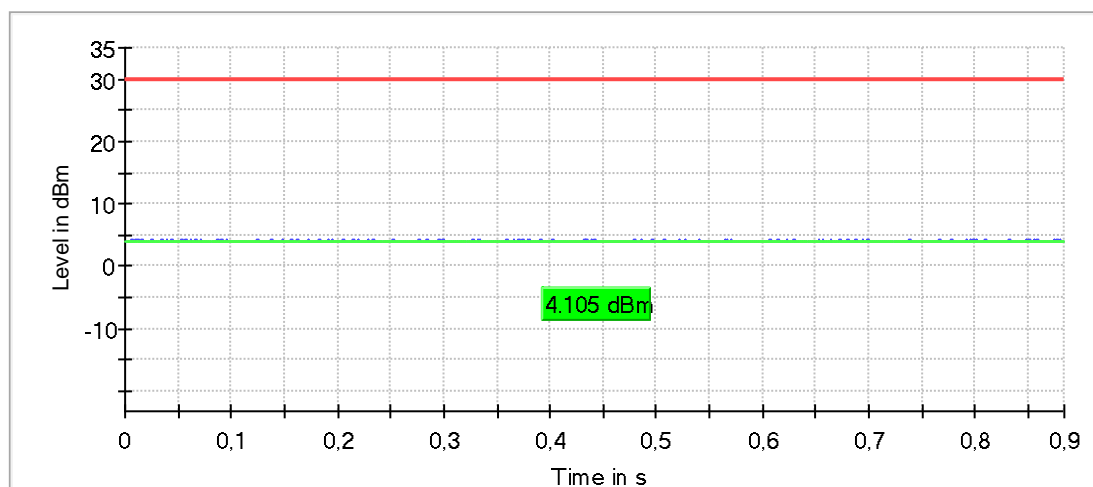
RF output power (5795 MHz; n40-mode [MCS0] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5795.000000	4.1	30.0	4.1	88.596	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μs	1.000 μs

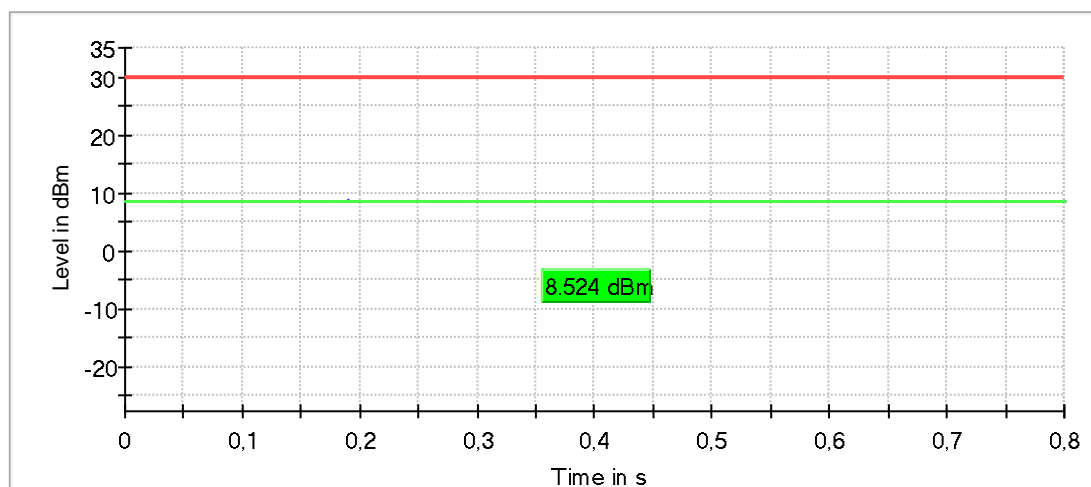
RF output power (5190 MHz; n40-mode [MCS1] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5190.000000	8.5	30.0	8.5	80.206	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 µs	1.000 µs

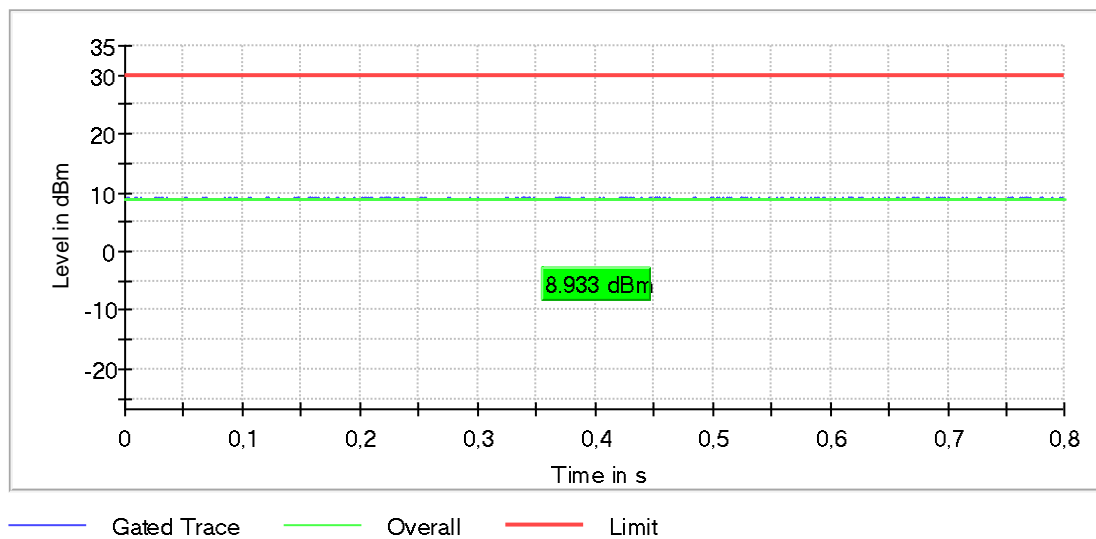
RF output power (5230 MHz; n40-mode [MCS1] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5230.000000	8.9	30.0	8.9	80.128	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μs	1.000 μs

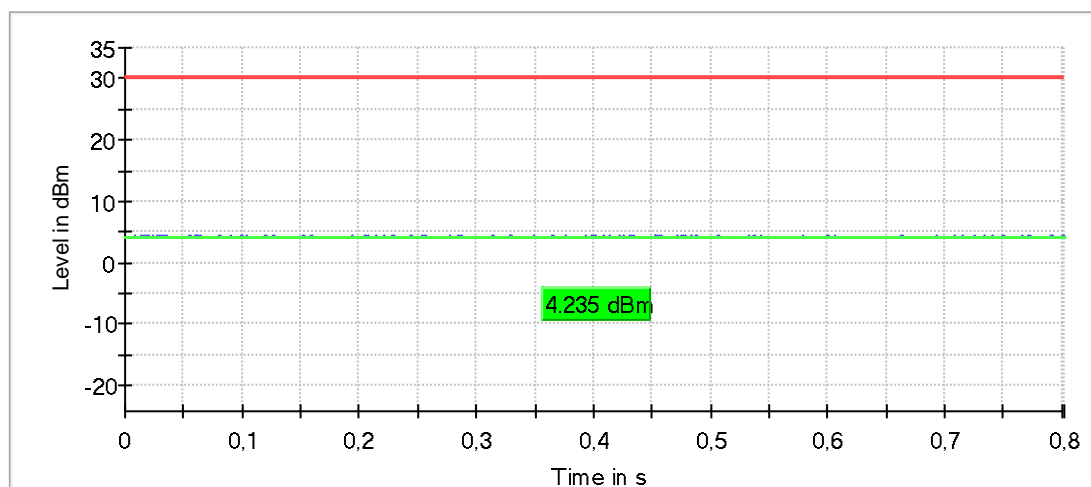
RF output power (5755 MHz; n40-mode [MCS1] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5755.000000	4.2	30.0	4.2	80.422	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μs	1.000 μs

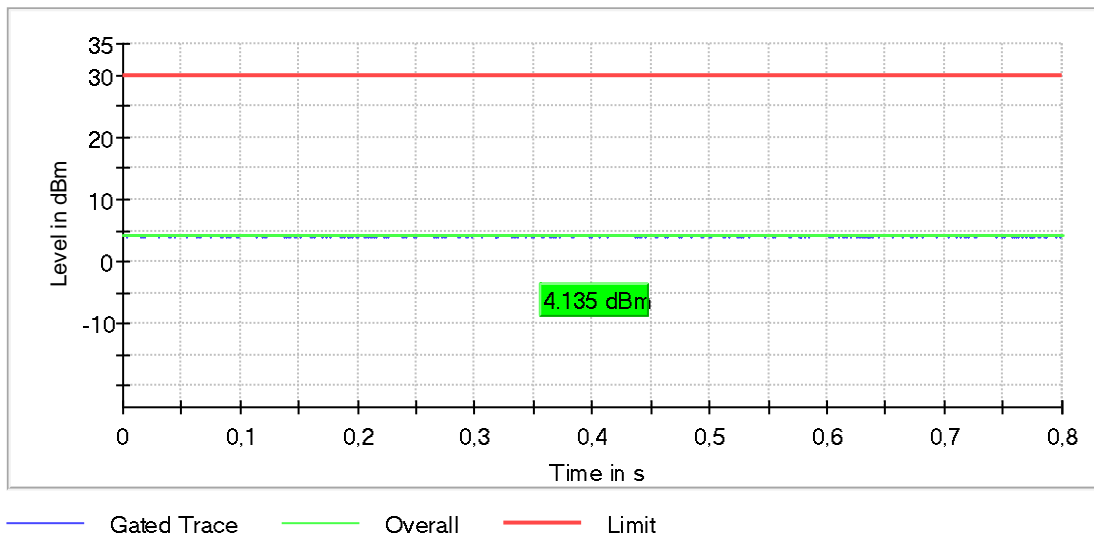
RF output power (5795 MHz; n40-mode [MCS1] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5795.000000	4.1	30.0	4.1	80.302	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 µs	1.000 µs

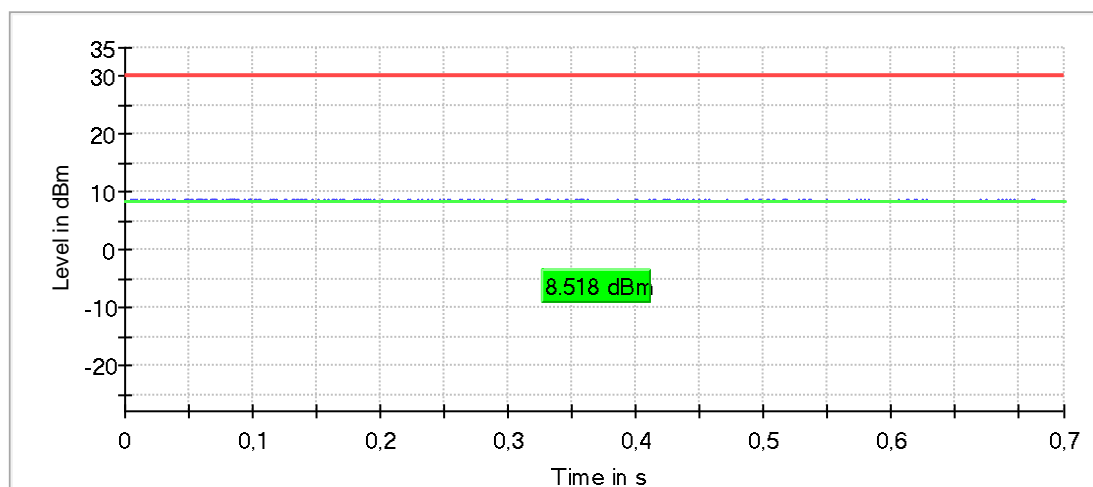
RF output power (5190 MHz; n40-mode [MCS2] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5190.000000	8.5	30.0	8.5	73.914	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 µs	1.000 µs

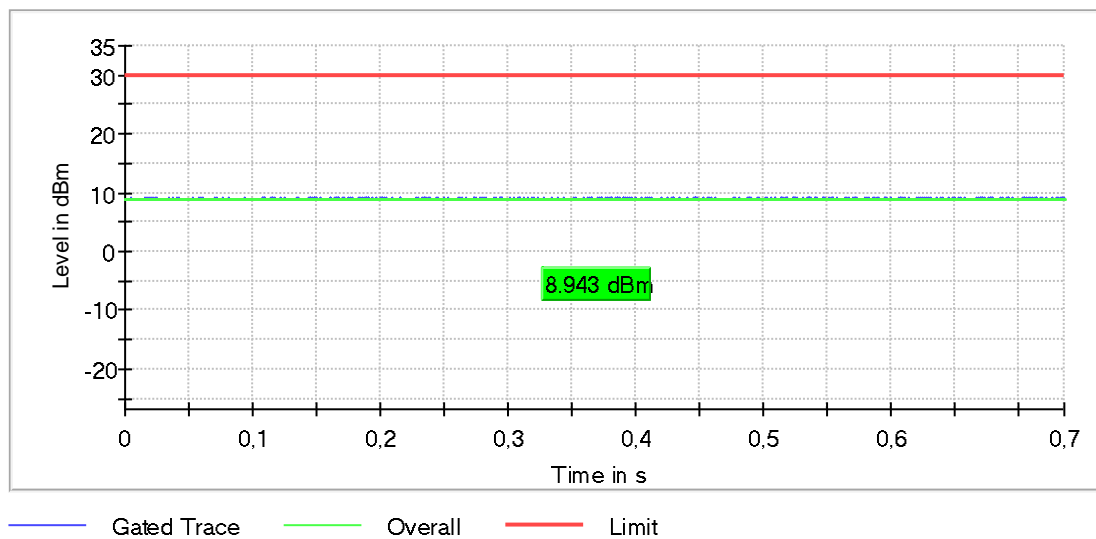
RF output power (5230 MHz; n40-mode [MCS2] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5230.000000	8.9	30.0	8.9	73.803	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 µs	1.000 µs

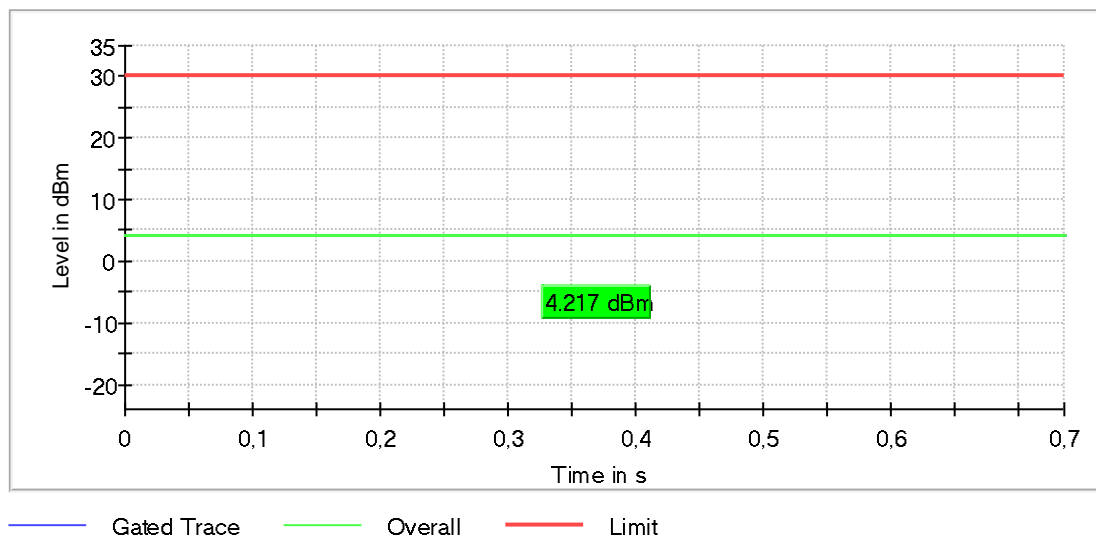
RF output power (5755 MHz; n40-mode [MCS2] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5755.000000	4.2	30.0	4.2	73.902	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 µs	1.000 µs

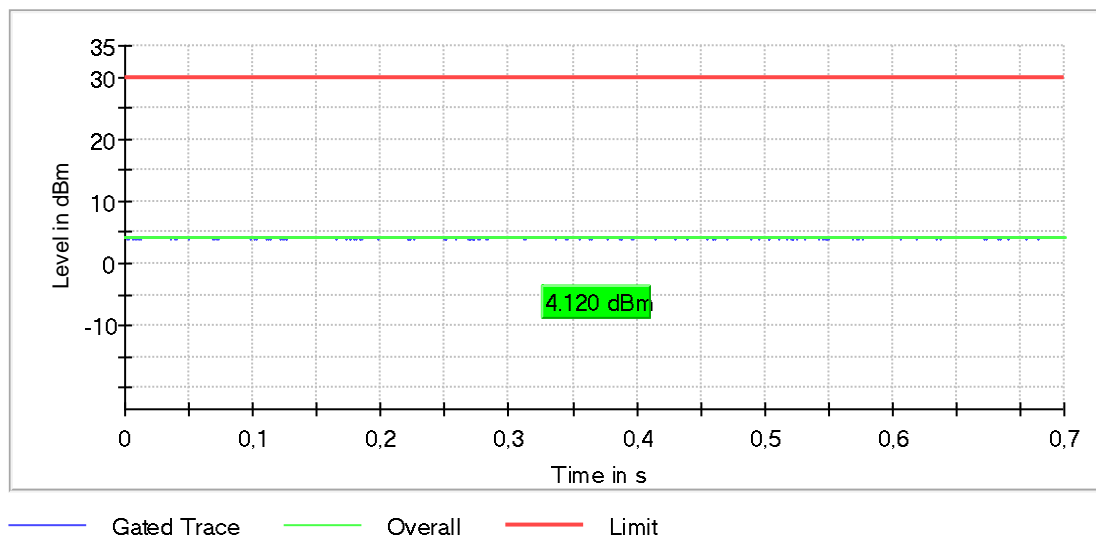
RF output power (5795 MHz; n40-mode [MCS2] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5795.000000	4.1	30.0	4.1	73.662	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μs	1.000 μs

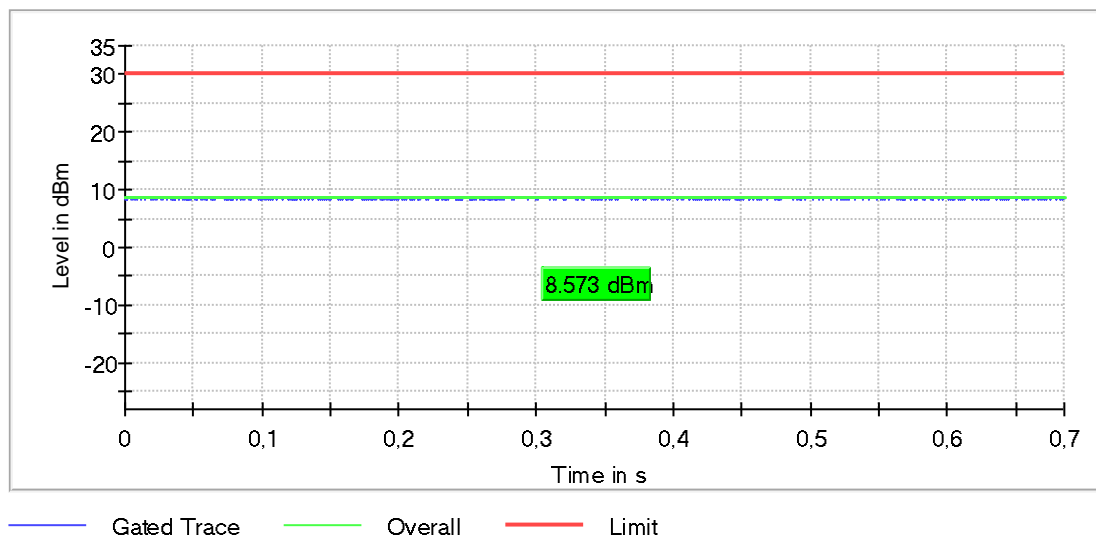
RF output power (5190 MHz; n40-mode [MCS3] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5190.000000	8.6	30.0	8.6	68.790	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 µs	1.000 µs

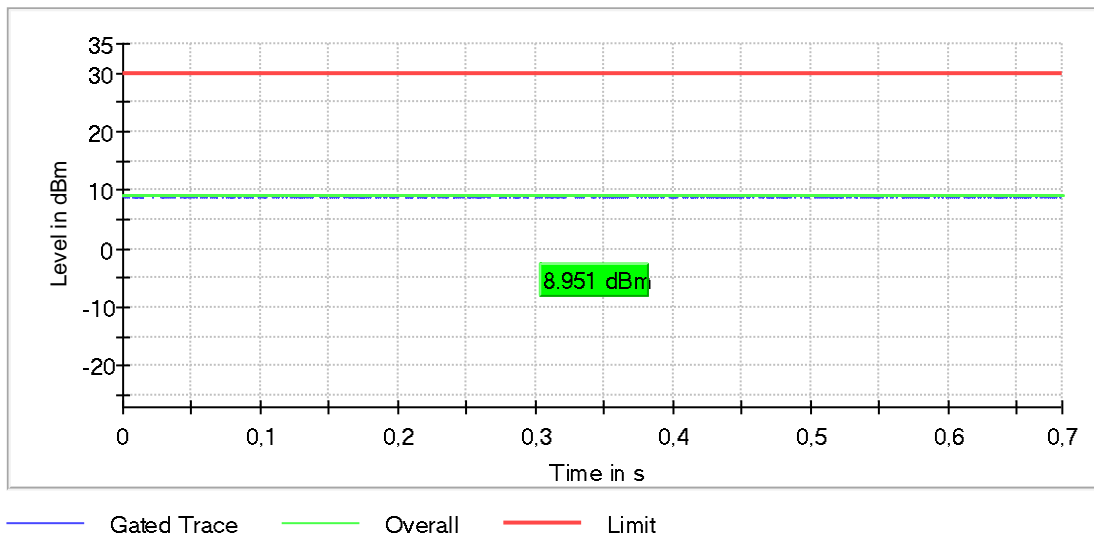
RF output power (5230 MHz; n40-mode [MCS3] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5230.000000	9.0	30.0	9.0	68.586	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 µs	1.000 µs

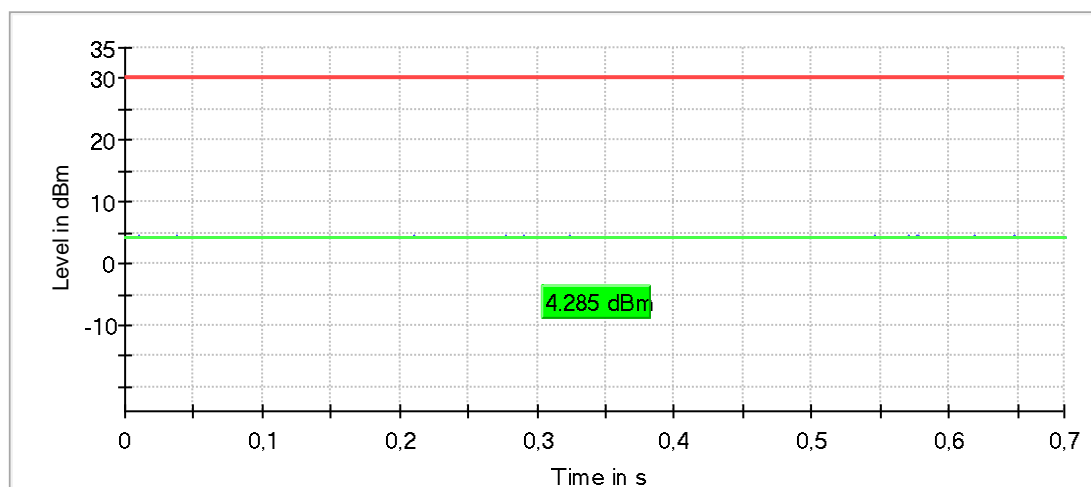
RF output power (5755 MHz; n40-mode [MCS3] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5755.000000	4.3	30.0	4.3	68.686	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

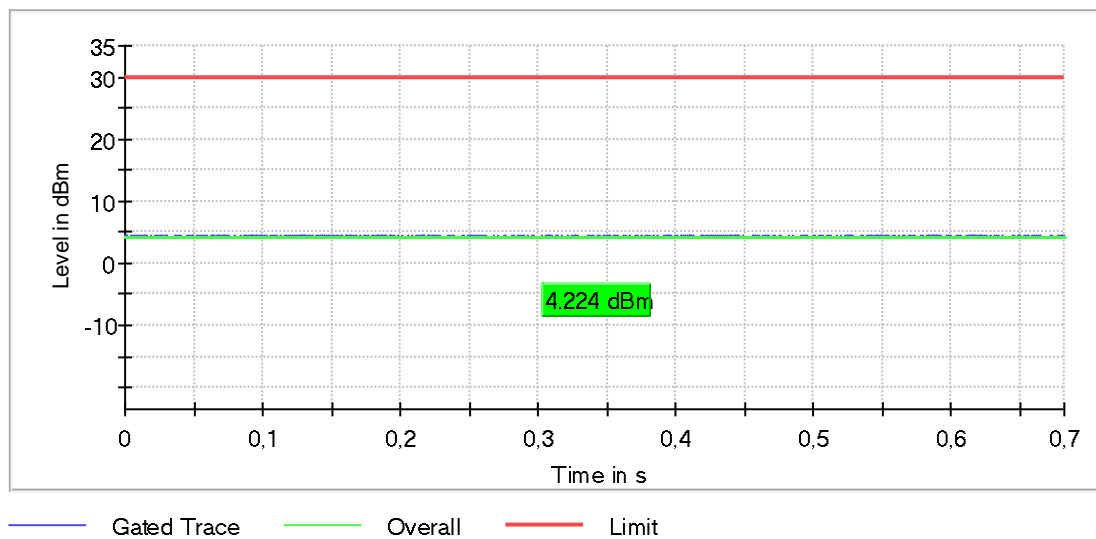
RF output power (5795 MHz; n40-mode [MCS3] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5795.000000	4.2	30.0	4.2	68.534	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 µs	1.000 µs

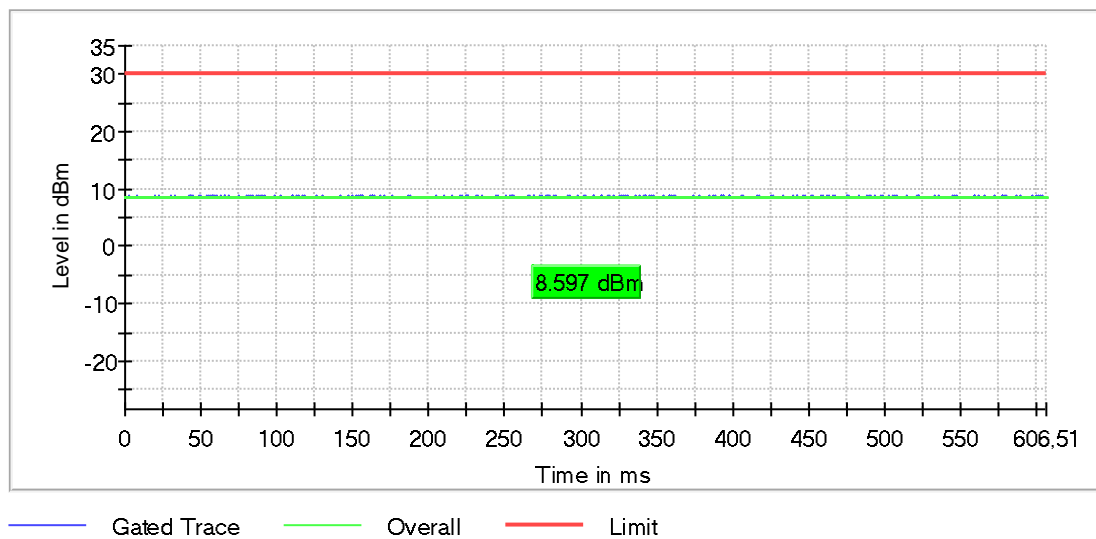
RF output power (5190 MHz; n40-mode [MCS4] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5190.000000	8.6	30.0	8.6	60.998	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 µs	1.000 µs

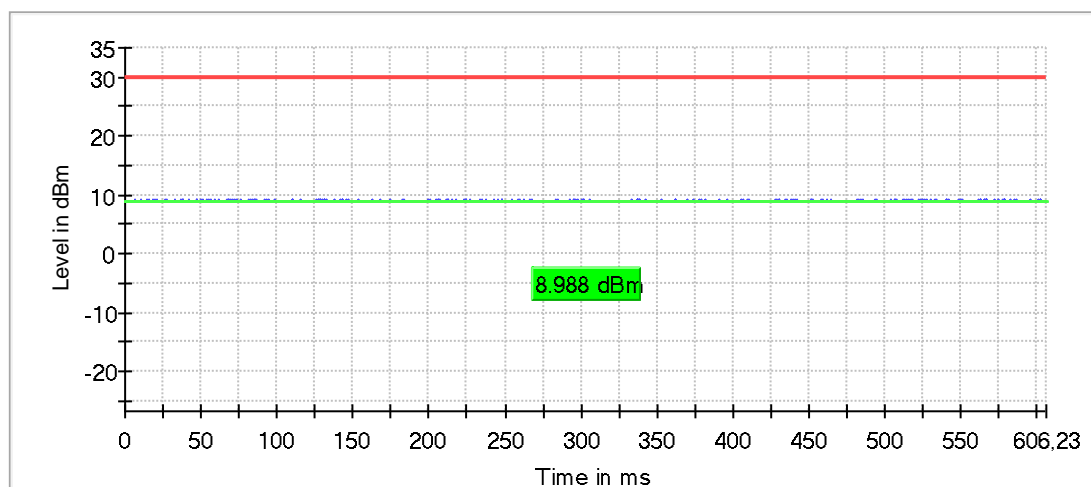
RF output power (5230 MHz; n40-mode [MCS4] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5230.000000	9.0	30.0	9.0	60.965	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μs	1.000 μs

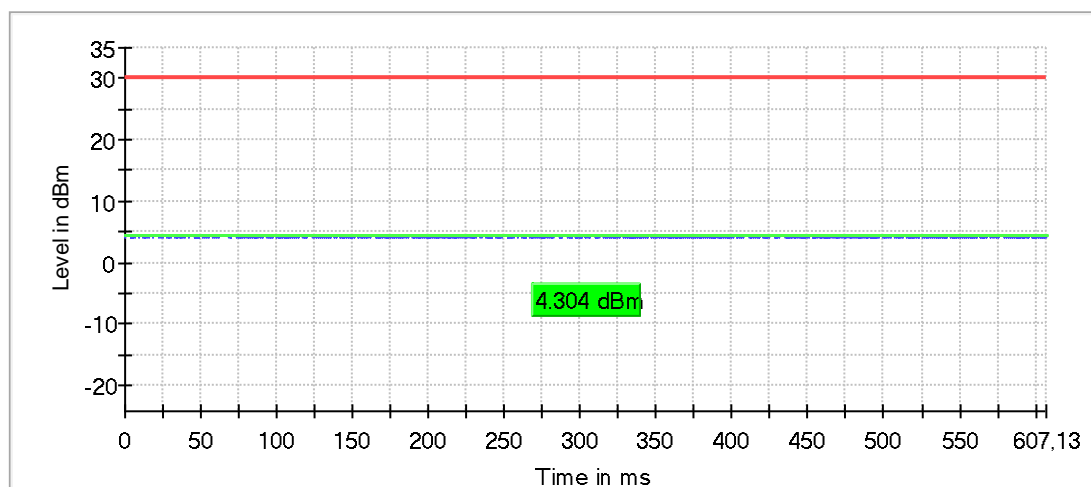
RF output power (5755 MHz; n40-mode [MCS4] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5755.000000	4.3	30.0	4.3	61.065	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μs	1.000 μs

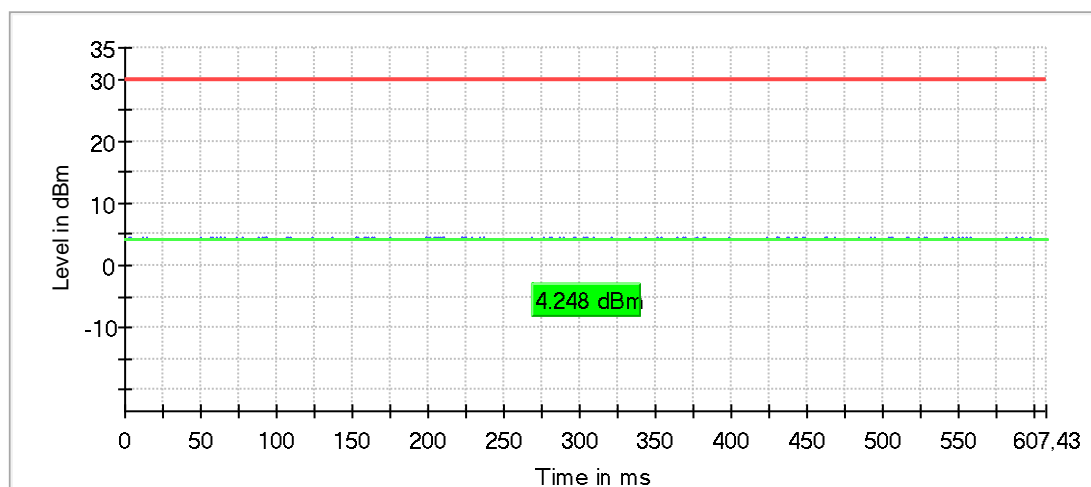
RF output power (5795 MHz; n40-mode [MCS4] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5795.000000	4.2	30.0	4.2	61.080	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μs	1.000 μs

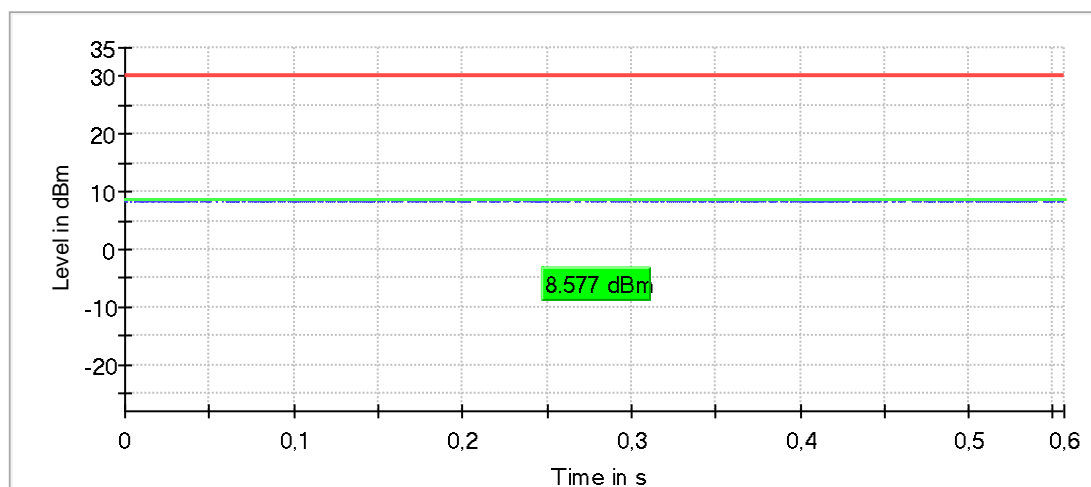
RF output power (5190 MHz; n40-mode [MCS5] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5190.000000	8.6	30.0	8.6	56.032	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μs	1.000 μs

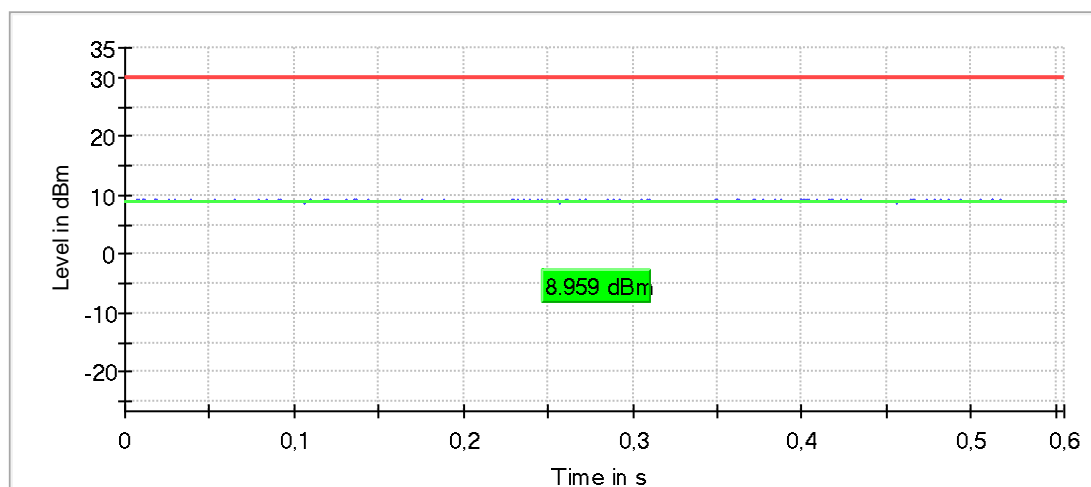
RF output power (5230 MHz; n40-mode [MCS5] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5230.000000	9.0	30.0	9.0	55.897	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 µs	1.000 µs

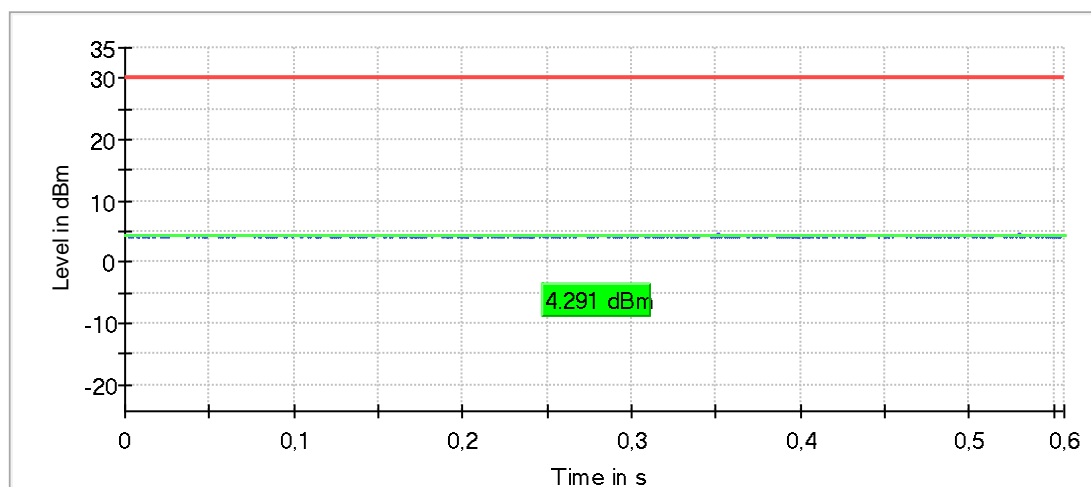
RF output power (5755 MHz; n40-mode [MCS5] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5755.000000	4.3	30.0	4.3	56.012	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 µs	1.000 µs

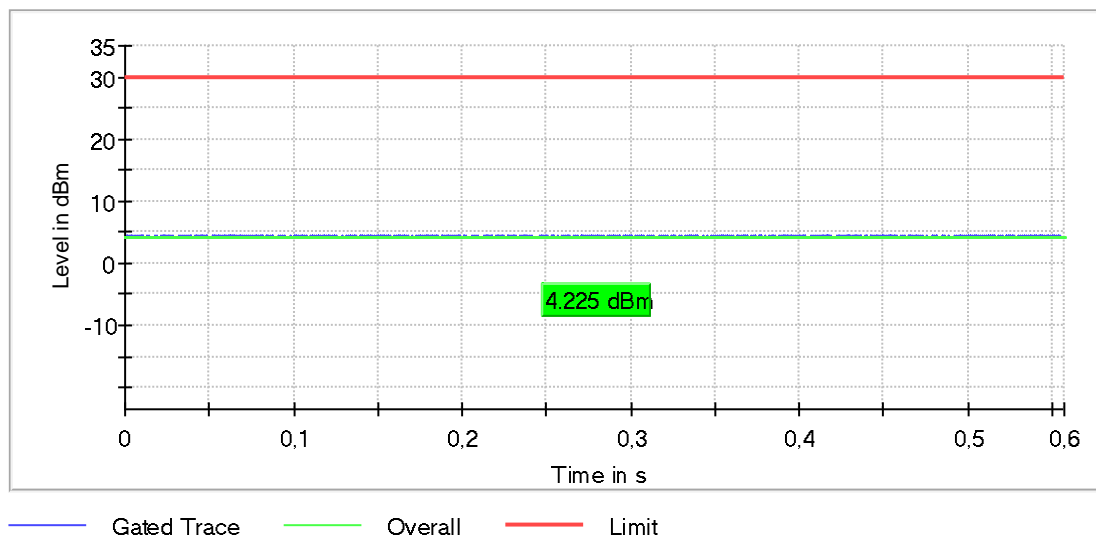
RF output power (5795 MHz; n40-mode [MCS5] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5795.000000	4.2	30.0	4.2	56.074	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 µs	1.000 µs

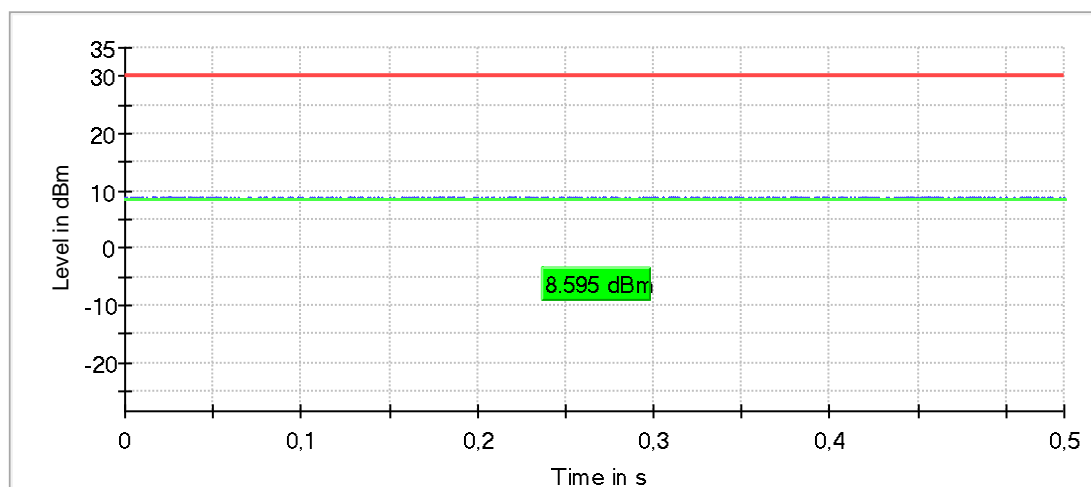
RF output power (5190 MHz; n40-mode [MCS6] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5190.000000	8.6	30.0	8.6	53.696	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 µs	1.000 µs

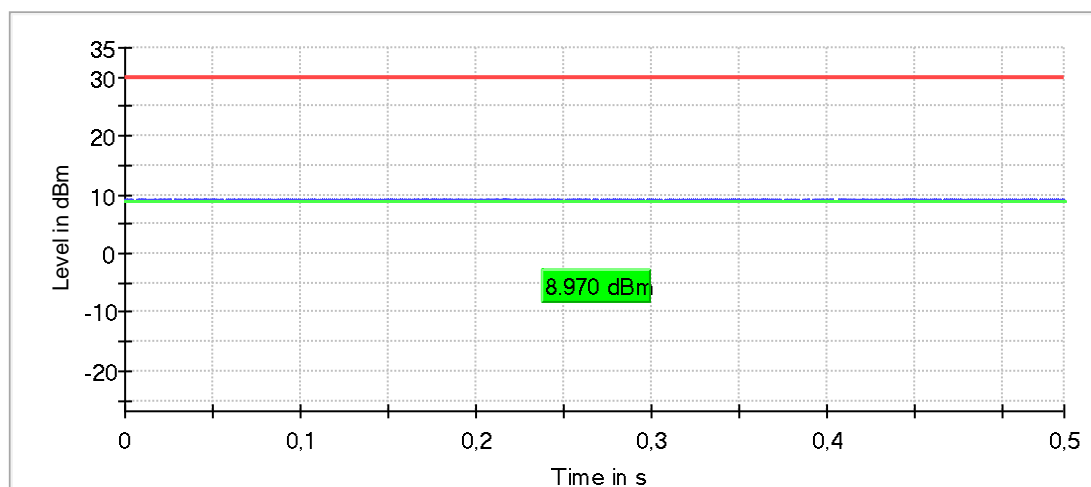
RF output power (5230 MHz; n40-mode [MCS6] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5230.000000	9.0	30.0	9.0	53.859	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μs	1.000 μs

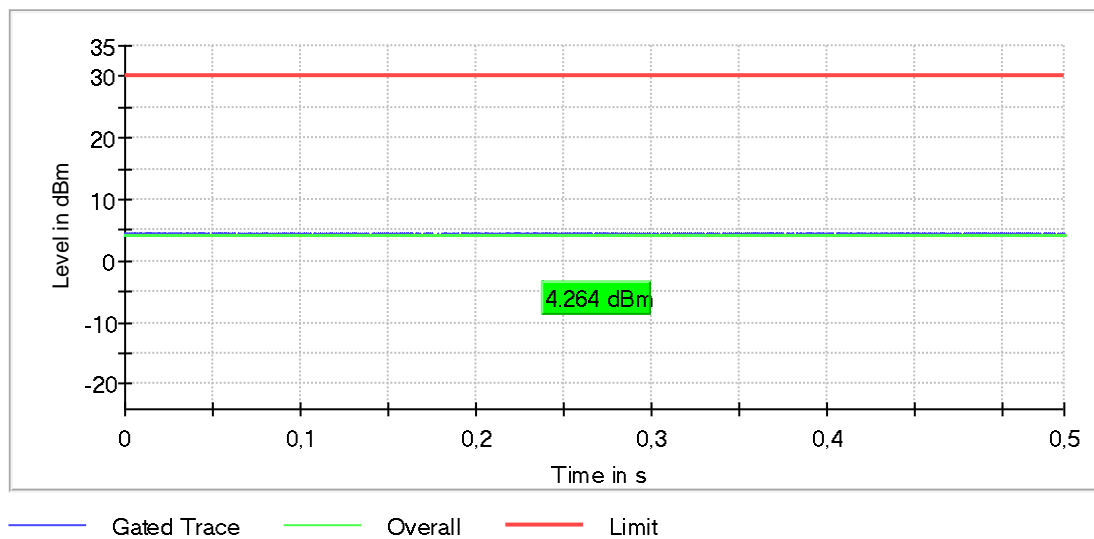
RF output power (5755 MHz; n40-mode [MCS6] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5755.000000	4.3	30.0	4.3	53.973	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

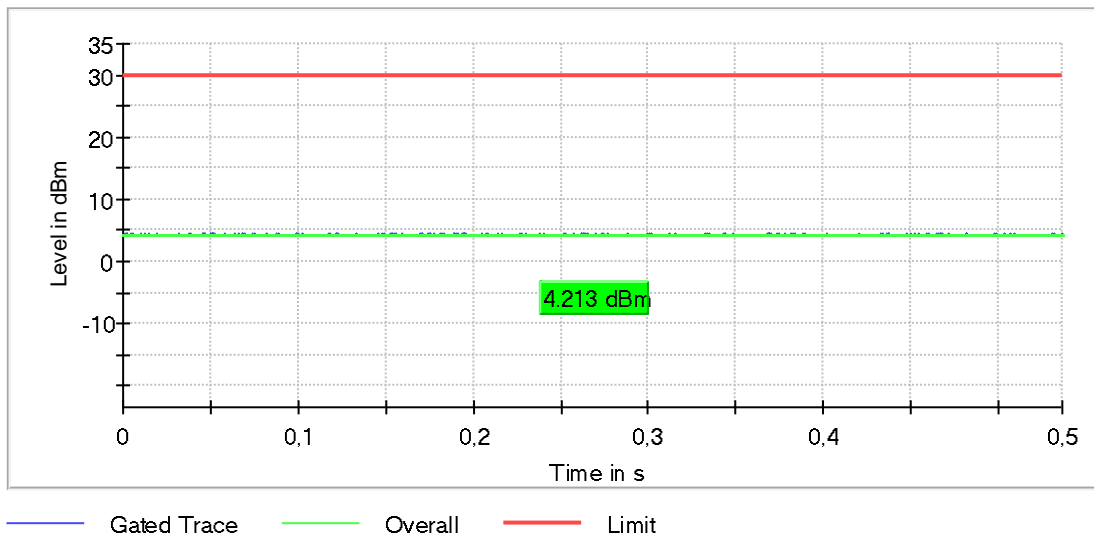
RF output power (5795 MHz; n40-mode [MCS6] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5795.000000	4.2	30.0	4.2	54.039	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 µs	1.000 µs

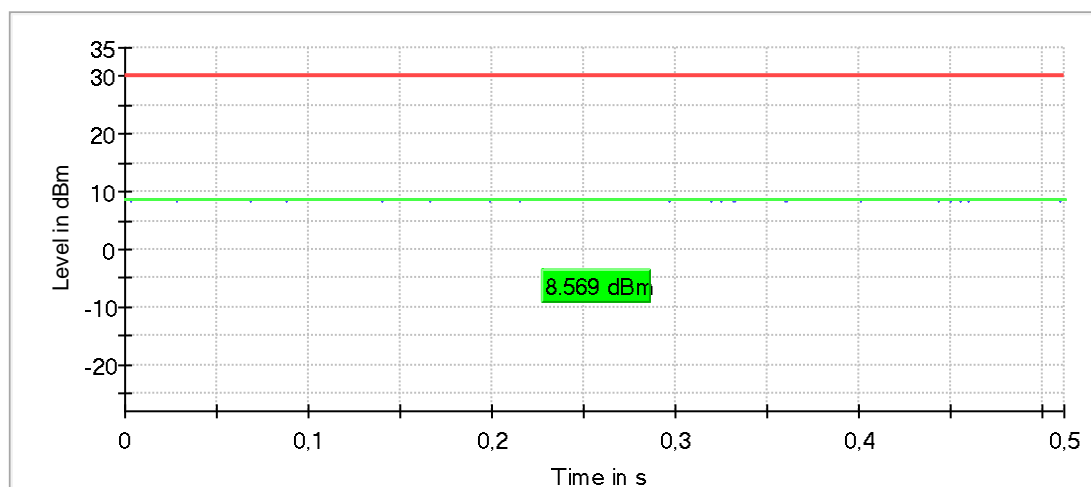
RF output power (5190 MHz; n40-mode [MCS7] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5190.000000	8.6	30.0	8.6	51.635	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 µs	1.000 µs

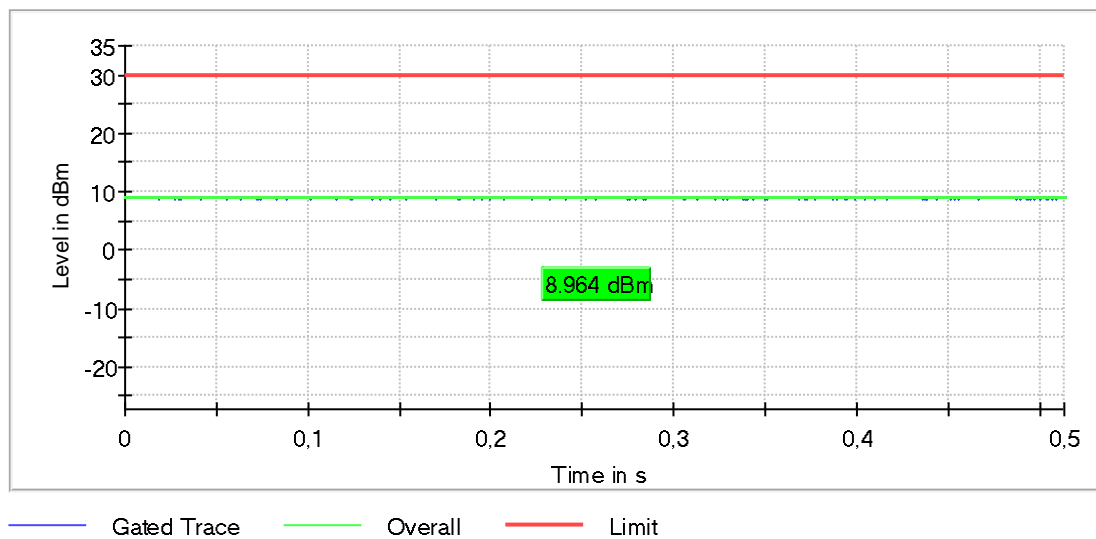
RF output power (5230 MHz; n40-mode [MCS7] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5230.000000	9.0	30.0	9.0	51.756	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 µs	1.000 µs

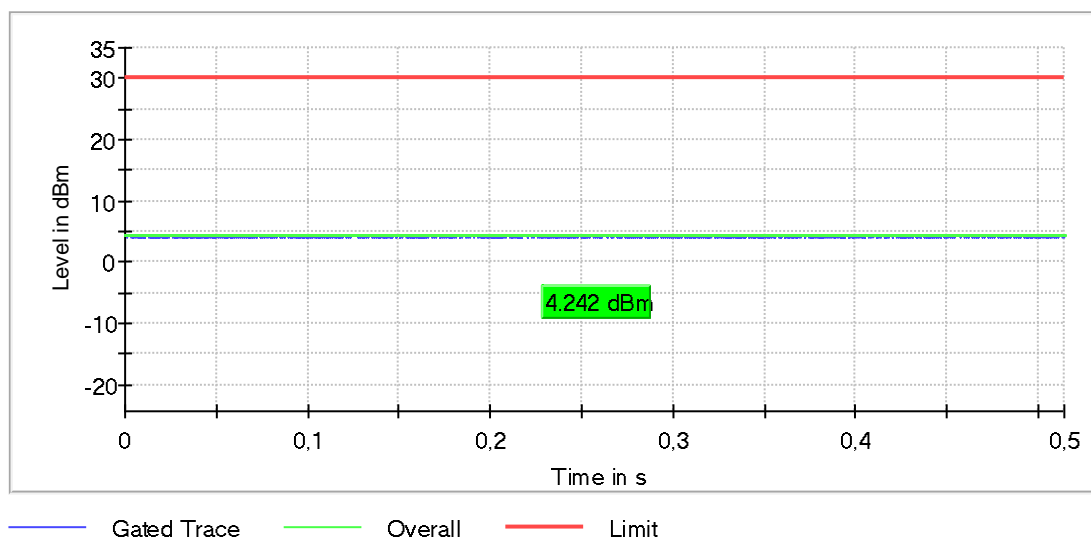
RF output power (5755 MHz; n40-mode [MCS7] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5755.000000	4.2	30.0	4.2	51.825	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 µs	1.000 µs

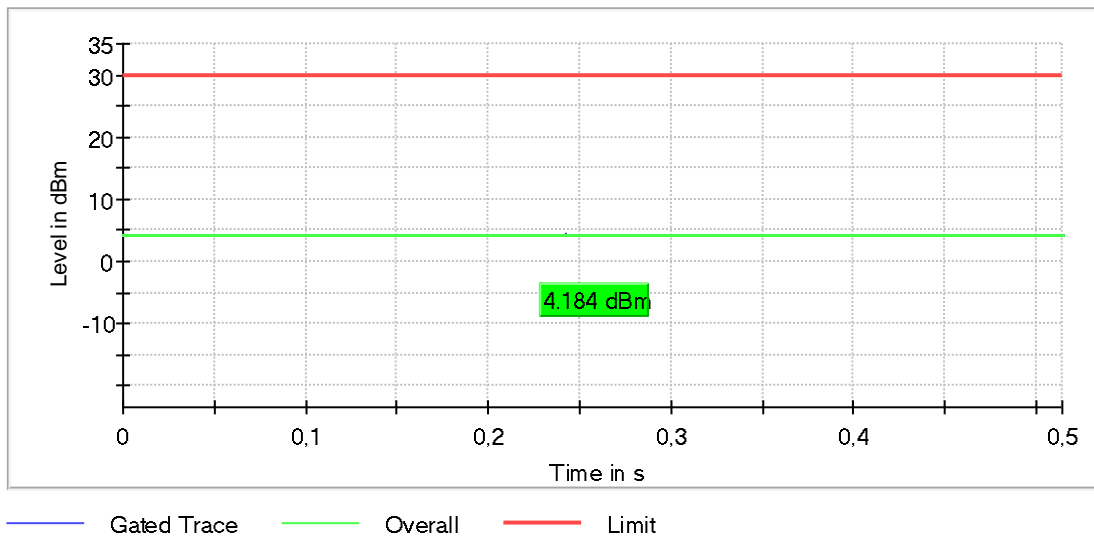
RF output power (5795 MHz; n40-mode [MCS7] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5795.000000	4.2	30.0	4.2	51.837	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 µs	1.000 µs

RF output power

Mode	DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
ac40-mode [VHT-MCS0]; 5190MHz	5190.0000	8.5	30.0	8.5	88.634	PASS
ac40-mode [VHT-MCS0]; 5230MHz	5230.0000	8.9	30.0	8.9	88.585	PASS
ac40-mode [VHT-MCS0]; 5755MHz	5755.0000	4.2	30.0	4.2	88.706	PASS
ac40-mode [VHT-MCS0]; 5795MHz	5795.0000	4.1	30.0	4.1	88.504	PASS
ac40-mode [VHT-MCS1]; 5190MHz	5190.0000	8.5	30.0	8.5	80.217	PASS
ac40-mode [VHT-MCS1]; 5230MHz	5230.0000	8.9	30.0	8.9	80.388	PASS
ac40-mode [VHT-MCS1]; 5755MHz	5755.0000	4.2	30.0	4.2	80.463	PASS
ac40-mode [VHT-MCS1]; 5795MHz	5795.0000	4.1	30.0	4.1	80.357	PASS
ac40-mode [VHT-MCS2]; 5190MHz	5190.0000	8.5	30.0	8.5	73.900	PASS
ac40-mode [VHT-MCS2]; 5230MHz	5230.0000	8.9	30.0	8.9	73.985	PASS
ac40-mode [VHT-MCS2]; 5755MHz	5755.0000	4.2	30.0	4.2	74.097	PASS
ac40-mode [VHT-MCS2]; 5795MHz	5795.0000	4.1	30.0	4.1	74.076	PASS
ac40-mode [VHT-MCS3]; 5190MHz	5190.0000	8.6	30.0	8.6	68.900	PASS
ac40-mode [VHT-MCS3]; 5230MHz	5230.0000	9.0	30.0	9.0	68.903	PASS
ac40-mode [VHT-MCS3]; 5755MHz	5755.0000	4.3	30.0	4.3	68.990	PASS
ac40-mode [VHT-MCS3]; 5795MHz	5795.0000	4.2	30.0	4.2	69.089	PASS
ac40-mode [VHT-MCS4]; 5190MHz	5190.0000	8.6	30.0	8.6	61.549	PASS
ac40-mode [VHT-MCS4]; 5230MHz	5230.0000	9.0	30.0	9.0	61.388	PASS
ac40-mode [VHT-MCS4]; 5755MHz	5755.0000	4.3	30.0	4.3	61.532	PASS
ac40-mode [VHT-MCS4]; 5795MHz	5795.0000	4.2	30.0	4.2	61.693	PASS
ac40-mode [VHT-MCS5]; 5190MHz	5190.0000	8.6	30.0	8.6	56.716	PASS
ac40-mode [VHT-MCS5]; 5230MHz	5230.0000	8.9	30.0	8.9	56.630	PASS
ac40-mode [VHT-MCS5]; 5755MHz	5755.0000	4.3	30.0	4.3	56.503	PASS
ac40-mode [VHT-MCS5]; 5795MHz	5795.0000	4.2	30.0	4.2	56.635	PASS
ac40-mode [VHT-MCS6]; 5190MHz	5190.0000	8.6	30.0	8.6	54.522	PASS
ac40-mode [VHT-MCS6]; 5230MHz	5230.0000	9.0	30.0	9.0	54.616	PASS
ac40-mode [VHT-MCS6]; 5755MHz	5755.0000	4.3	30.0	4.3	54.747	PASS
ac40-mode [VHT-MCS6]; 5795MHz	5795.0000	4.2	30.0	4.2	54.667	PASS
ac40-mode [VHT-MCS7]; 5190MHz	5190.0000	8.6	30.0	8.6	52.387	PASS
ac40-mode [VHT-MCS7]; 5230MHz	5230.0000	8.9	30.0	8.9	52.358	PASS
ac40-mode [VHT-MCS7]; 5755MHz	5755.0000	4.2	30.0	4.2	52.551	PASS
ac40-mode [VHT-MCS7]; 5795MHz	5795.0000	4.2	30.0	4.2	52.447	PASS

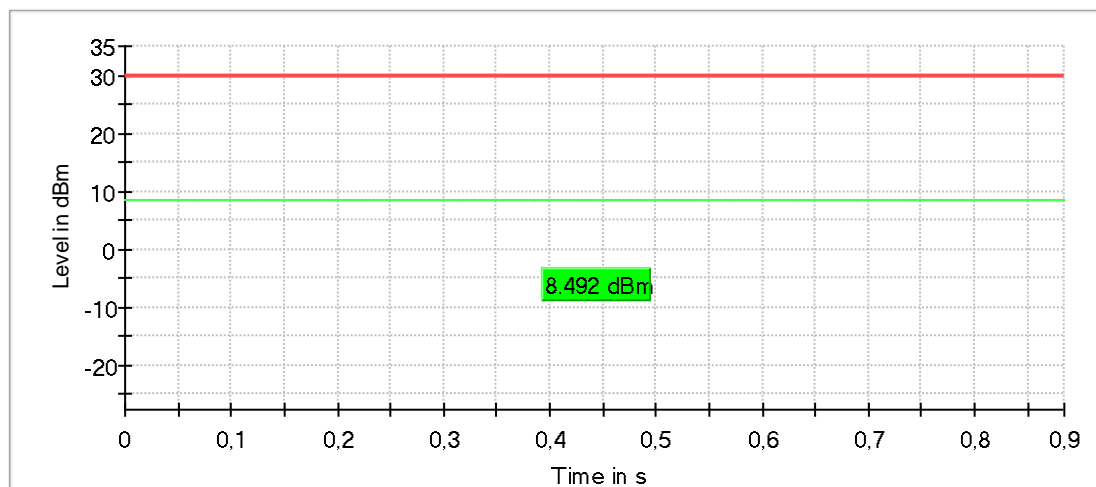
RF output power (5190 MHz; ac40-mode [VHT-MCS0] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5190.000000	8.5	30.0	8.5	88.634	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 µs	1.000 µs

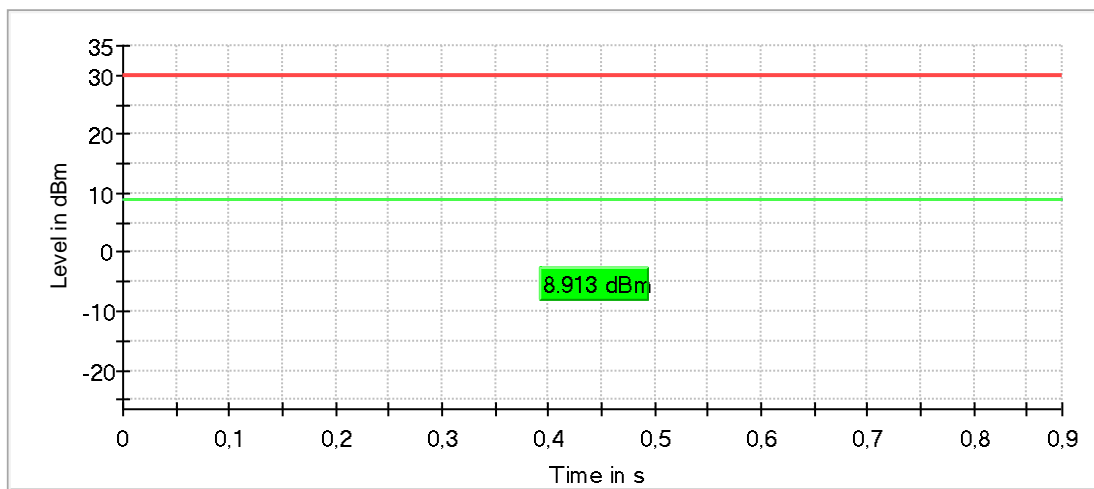
RF output power (5230 MHz; ac40-mode [VHT-MCS0] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5230.000000	8.9	30.0	8.9	88.585	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μs	1.000 μs

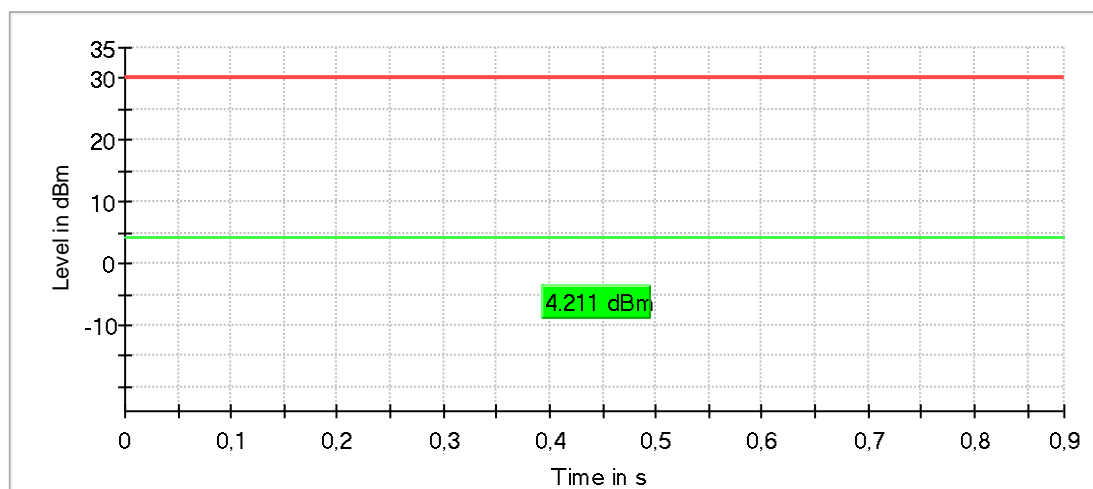
RF output power (5755 MHz; ac40-mode [VHT-MCS0] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5755.000000	4.2	30.0	4.2	88.706	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

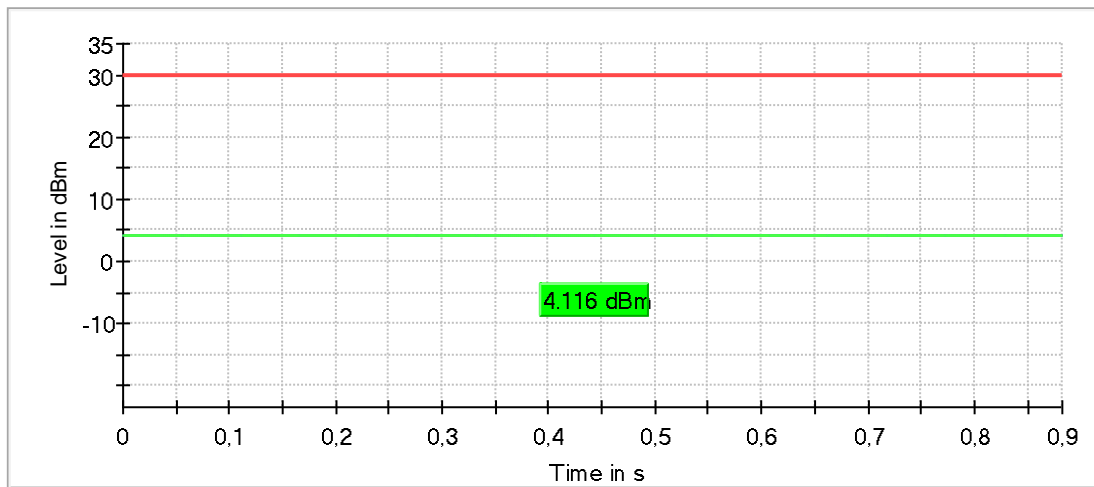
RF output power (5795 MHz; ac40-mode [VHT-MCS0] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5795.000000	4.1	30.0	4.1	88.504	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 µs	1.000 µs

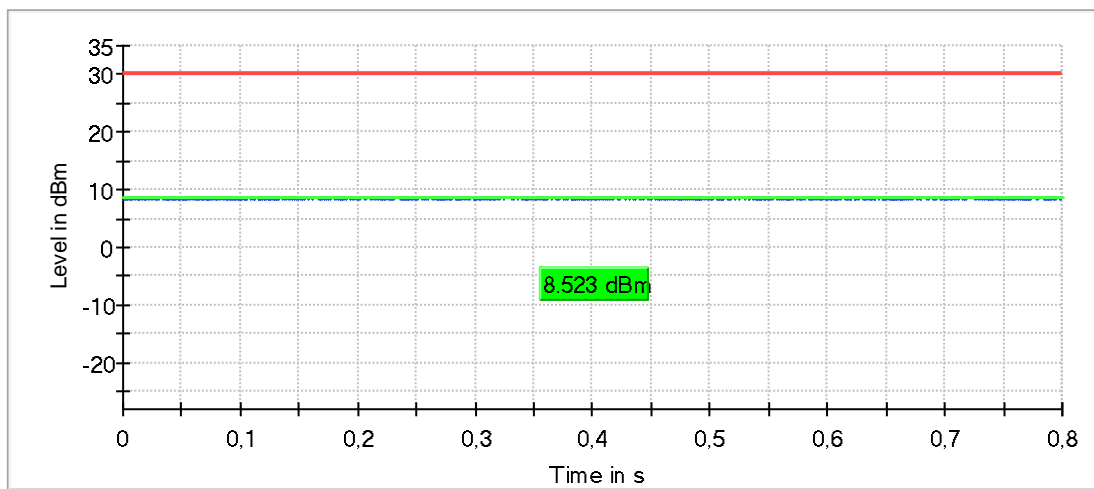
RF output power (5190 MHz; ac40-mode [VHT-MCS1] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5190.000000	8.5	30.0	8.5	80.217	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

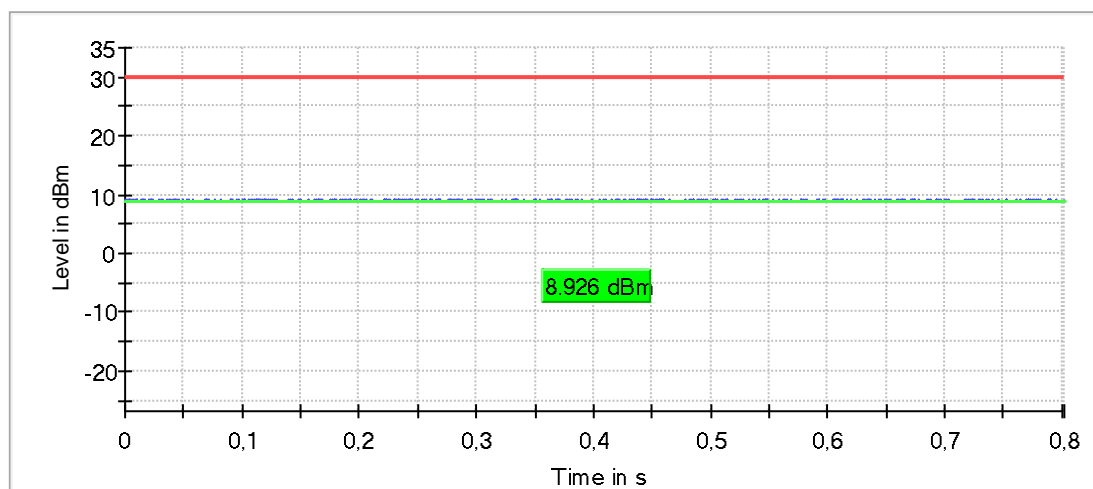
RF output power (5230 MHz; ac40-mode [VHT-MCS1] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5230.000000	8.9	30.0	8.9	80.388	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

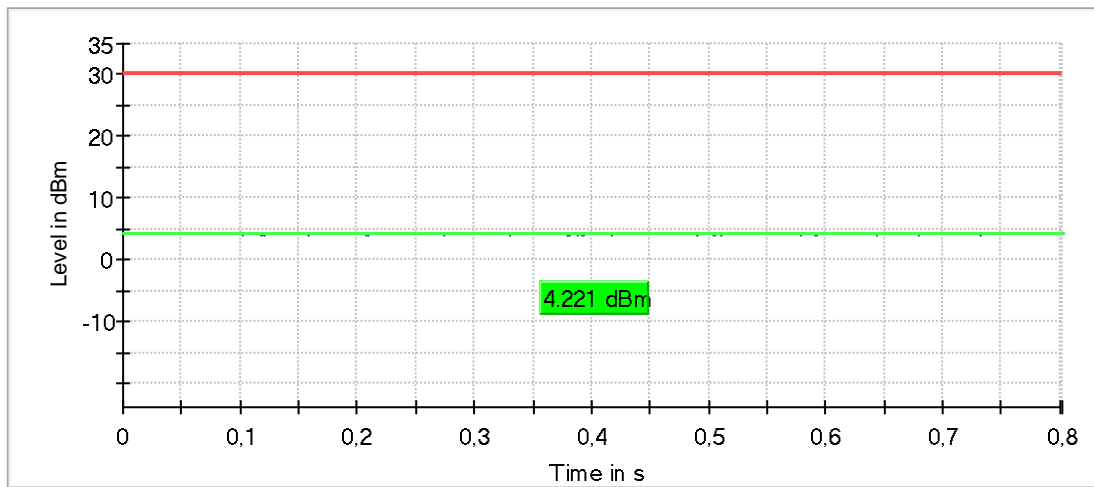
RF output power (5755 MHz; ac40-mode [VHT-MCS1] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5755.000000	4.2	30.0	4.2	80.463	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μs	1.000 μs

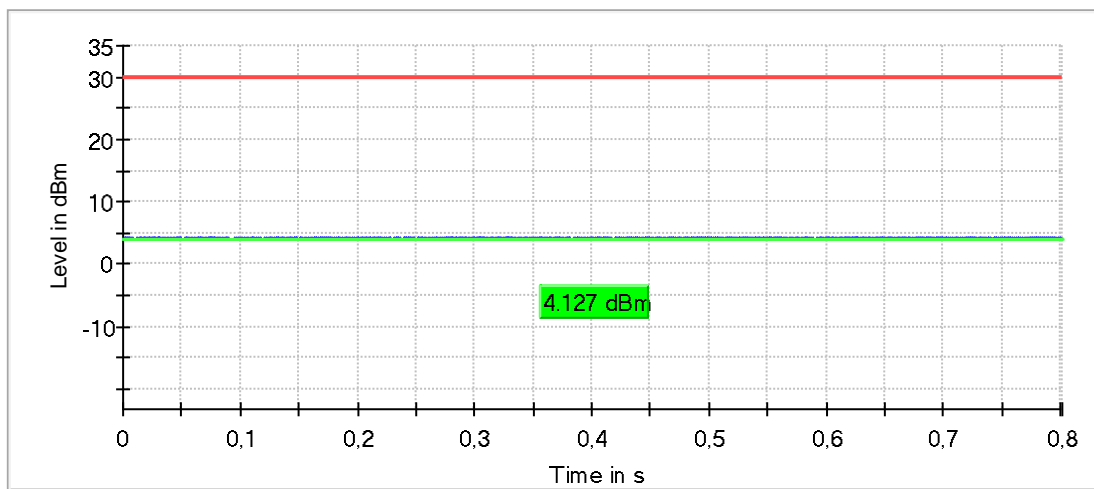
RF output power (5795 MHz; ac40-mode [VHT-MCS1] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5795.000000	4.1	30.0	4.1	80.357	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μs	1.000 μs

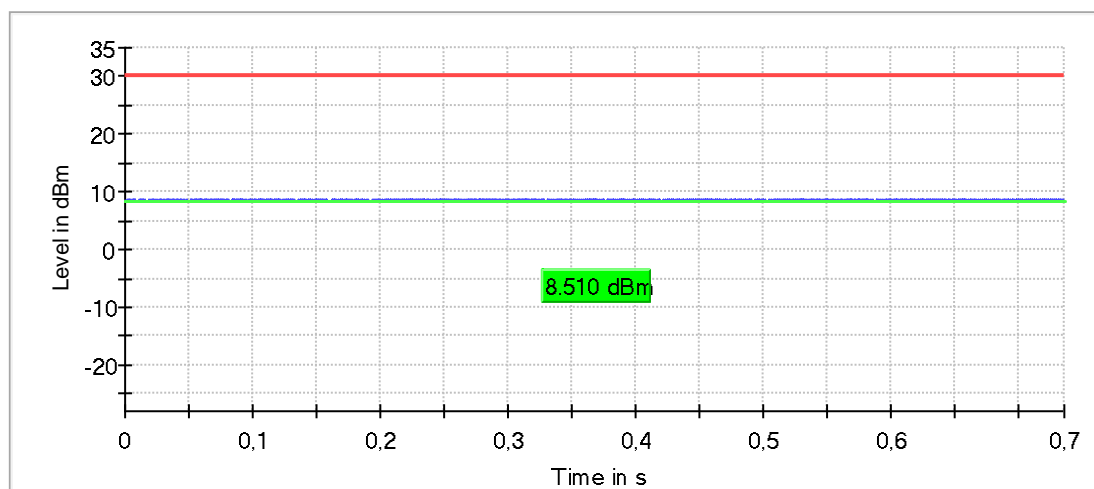
RF output power (5190 MHz; ac40-mode [VHT-MCS2] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5190.000000	8.5	30.0	8.5	73.900	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

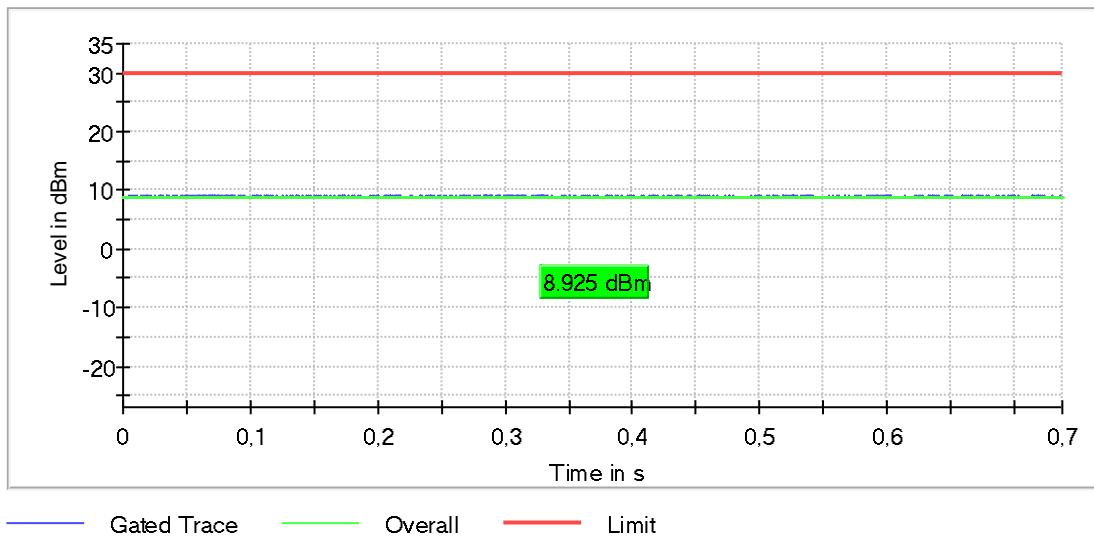
RF output power (5230 MHz; ac40-mode [VHT-MCS2] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5230.000000	8.9	30.0	8.9	73.985	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

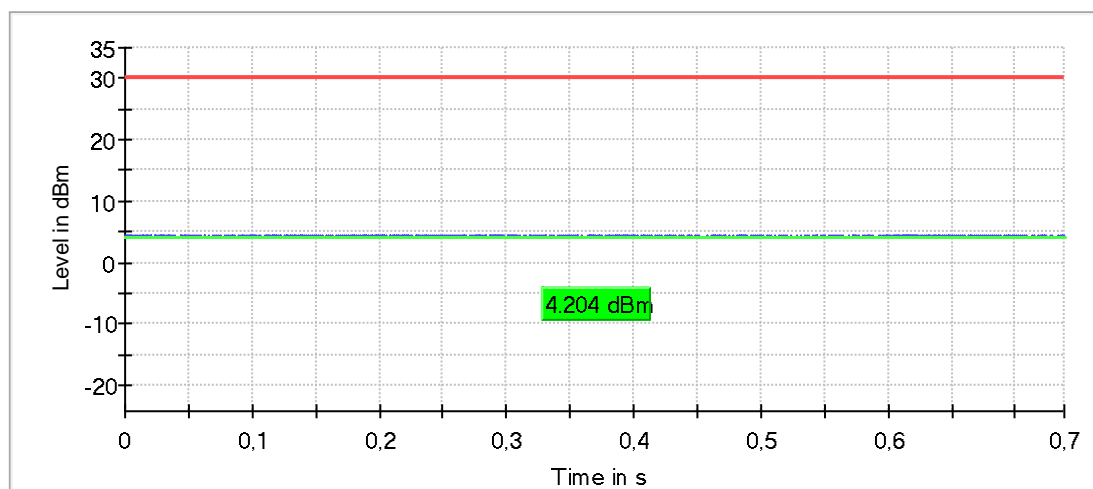
RF output power (5755 MHz; ac40-mode [VHT-MCS2] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5755.000000	4.2	30.0	4.2	74.097	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

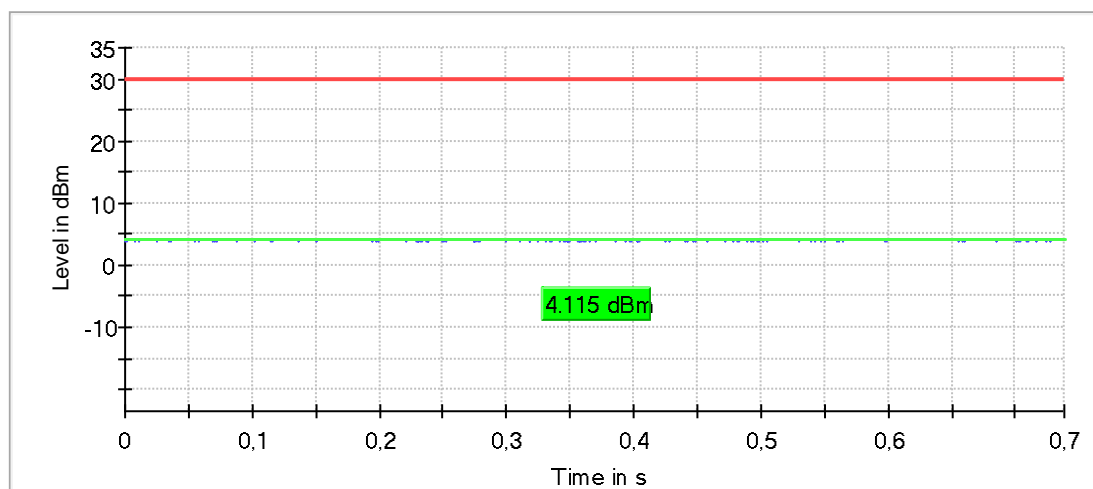
RF output power (5795 MHz; ac40-mode [VHT-MCS2] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5795.000000	4.1	30.0	4.1	74.076	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

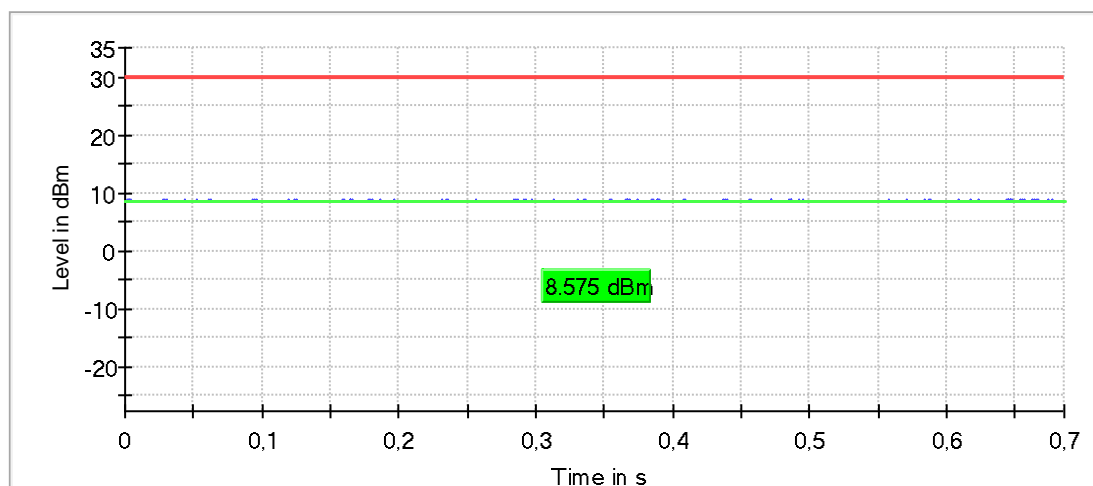
RF output power (5190 MHz; ac40-mode [VHT-MCS3] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5190.000000	8.6	30.0	8.6	68.900	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μs	1.000 μs

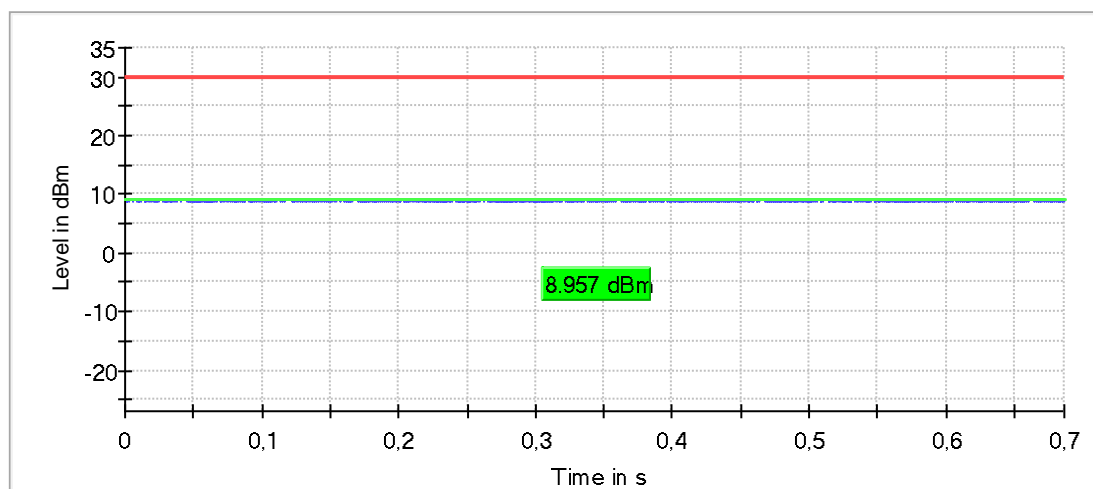
RF output power (5230 MHz; ac40-mode [VHT-MCS3] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5230.000000	9.0	30.0	9.0	68.903	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

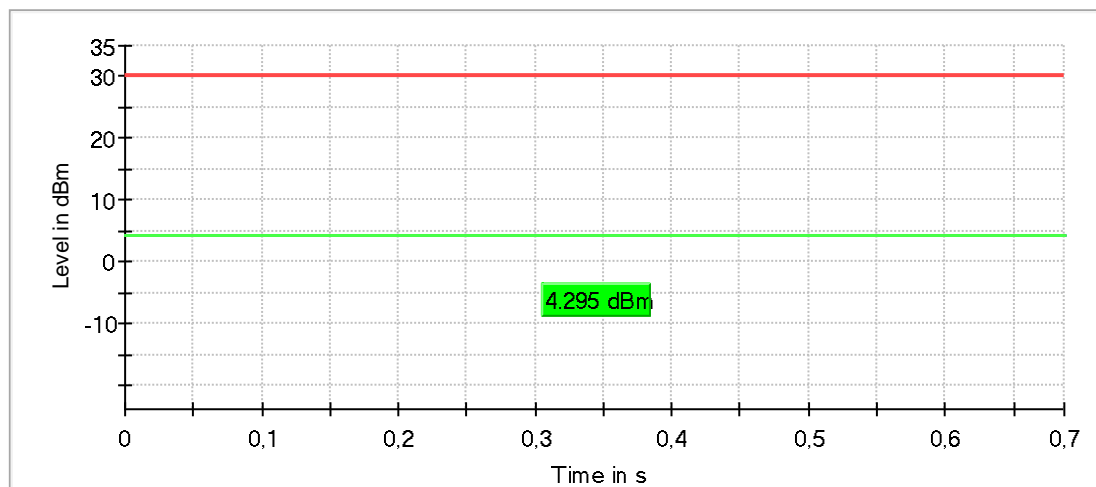
RF output power (5755 MHz; ac40-mode [VHT-MCS3] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5755.000000	4.3	30.0	4.3	68.990	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μs	1.000 μs

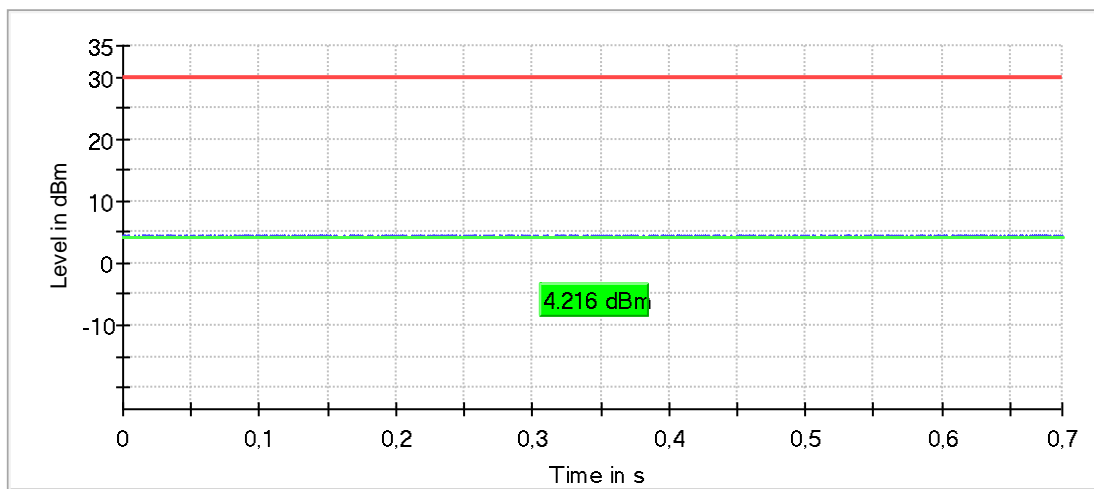
RF output power (5795 MHz; ac40-mode [VHT-MCS3] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5795.000000	4.2	30.0	4.2	69.089	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μs	1.000 μs

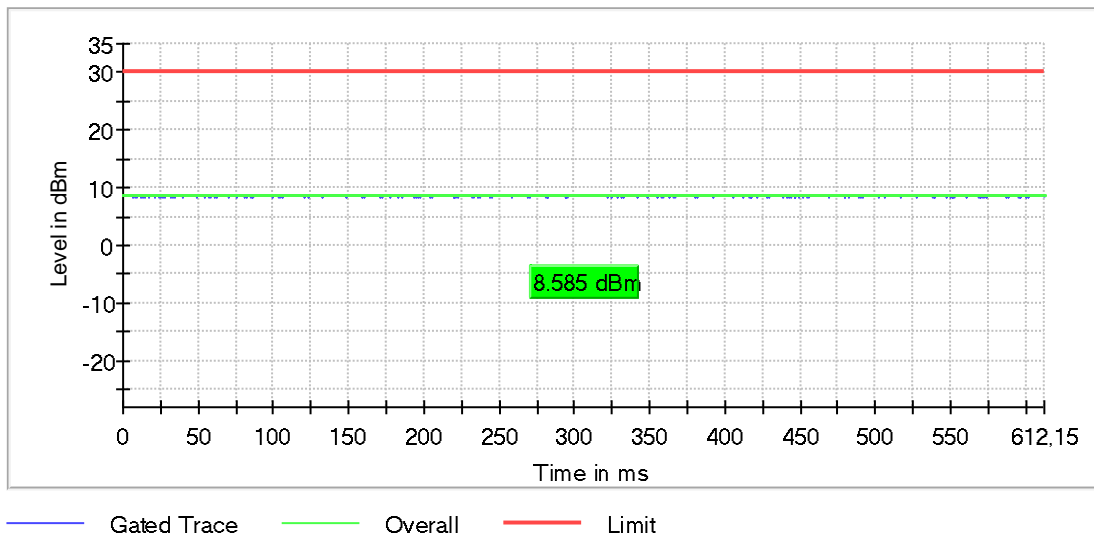
RF output power (5190 MHz; ac40-mode [VHT-MCS4] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5190.000000	8.6	30.0	8.6	61.549	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μs	1.000 μs

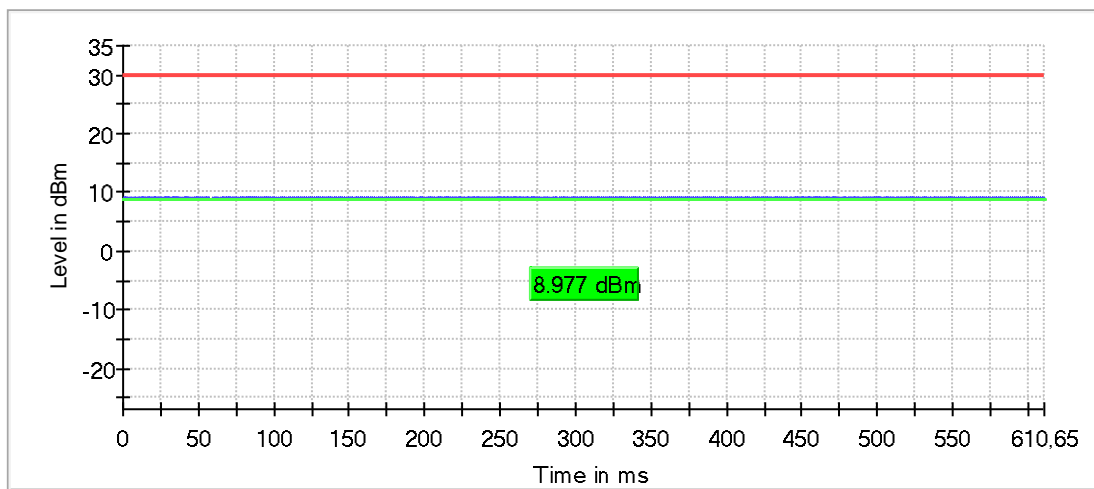
RF output power (5230 MHz; ac40-mode [VHT-MCS4] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5230.000000	9.0	30.0	9.0	61.388	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μs	1.000 μs

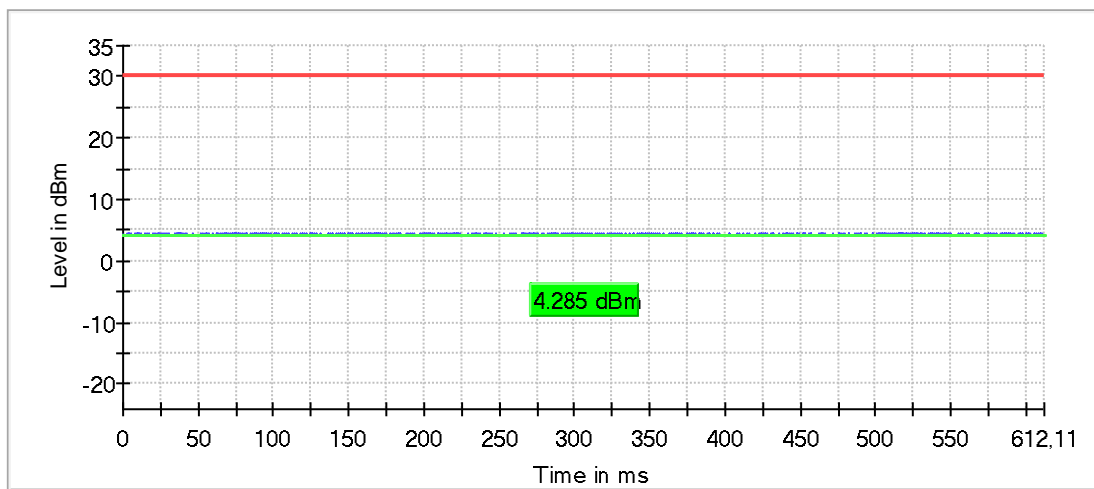
RF output power (5755 MHz; ac40-mode [VHT-MCS4] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5755.000000	4.3	30.0	4.3	61.532	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μs	1.000 μs

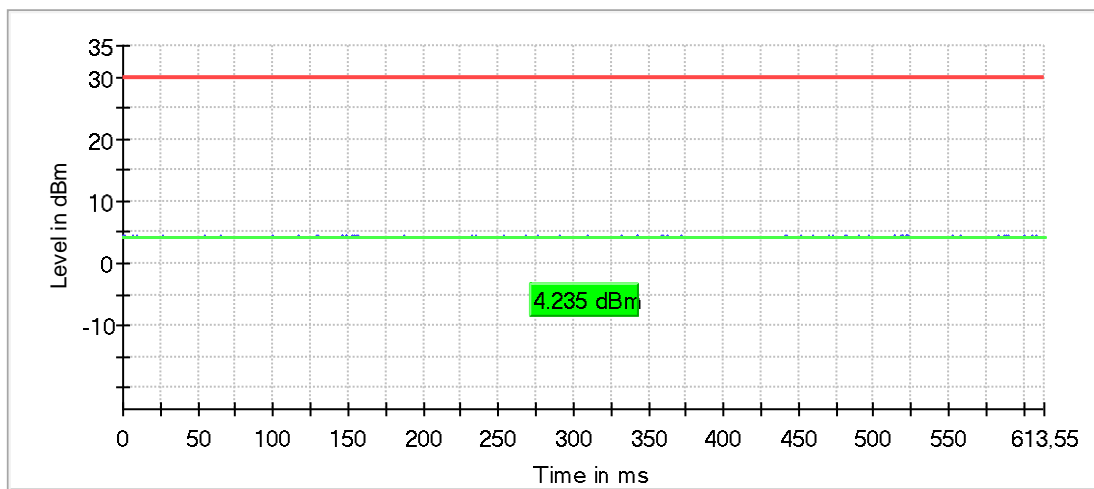
RF output power (5795 MHz; ac40-mode [VHT-MCS4] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5795.000000	4.2	30.0	4.2	61.693	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

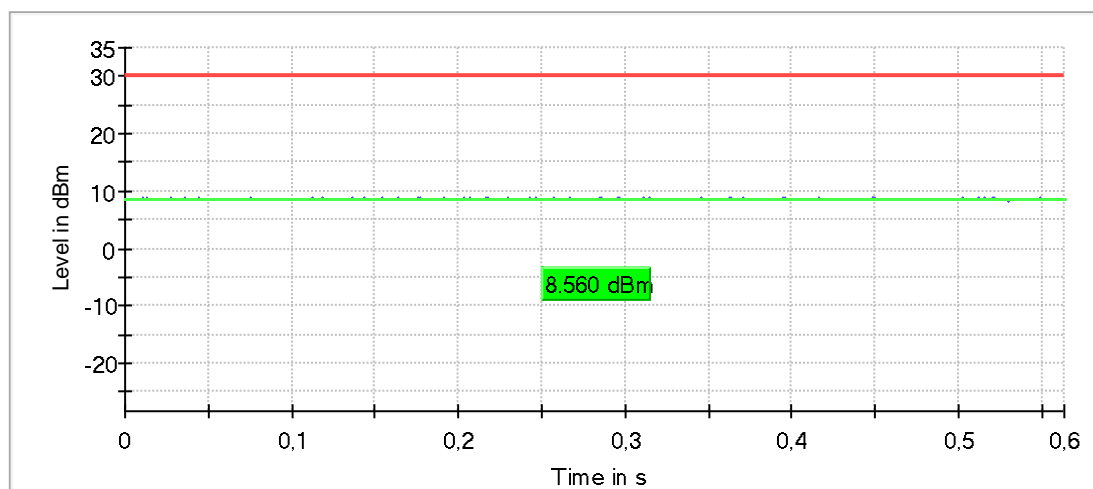
RF output power (5190 MHz; ac40-mode [VHT-MCS5] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5190.000000	8.6	30.0	8.6	56.716	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

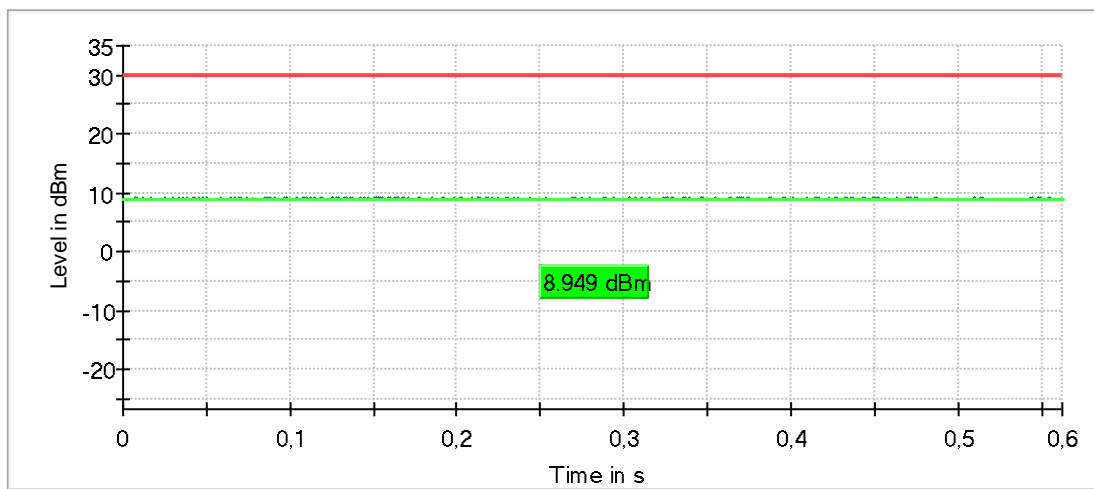
RF output power (5230 MHz; ac40-mode [VHT-MCS5] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5230.000000	8.9	30.0	8.9	56.630	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

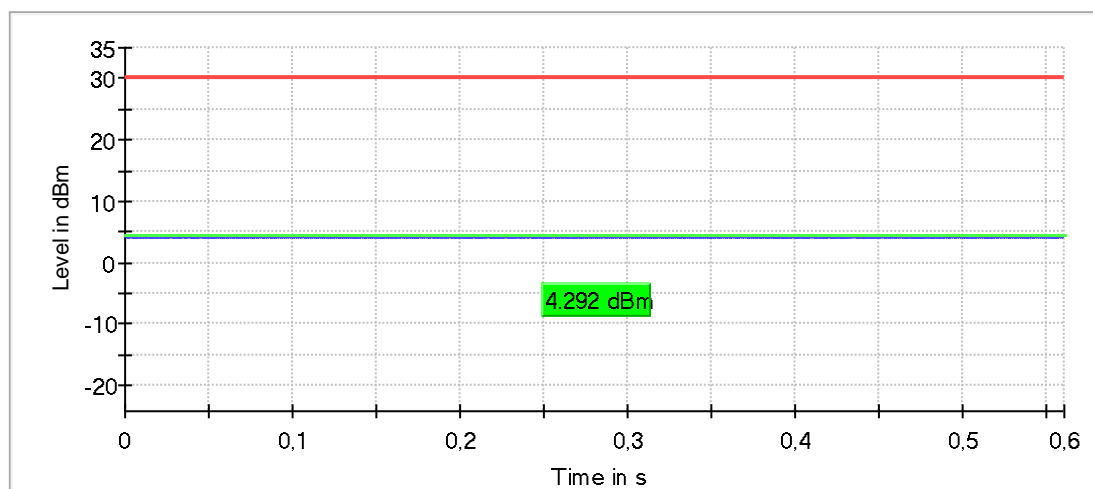
RF output power (5755 MHz; ac40-mode [VHT-MCS5] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5755.000000	4.3	30.0	4.3	56.503	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μs	1.000 μs

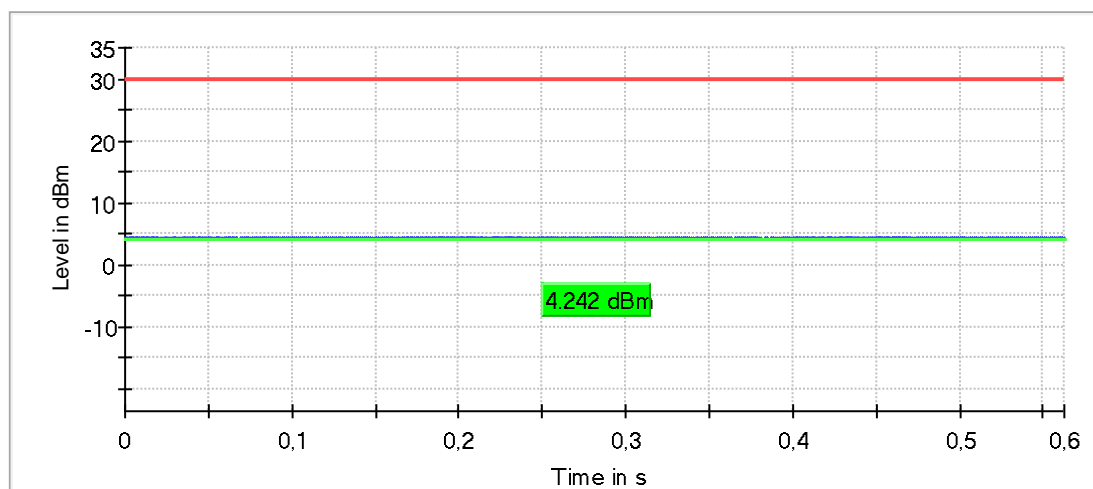
RF output power (5795 MHz; ac40-mode [VHT-MCS5] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5795.000000	4.2	30.0	4.2	56.635	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μs	1.000 μs

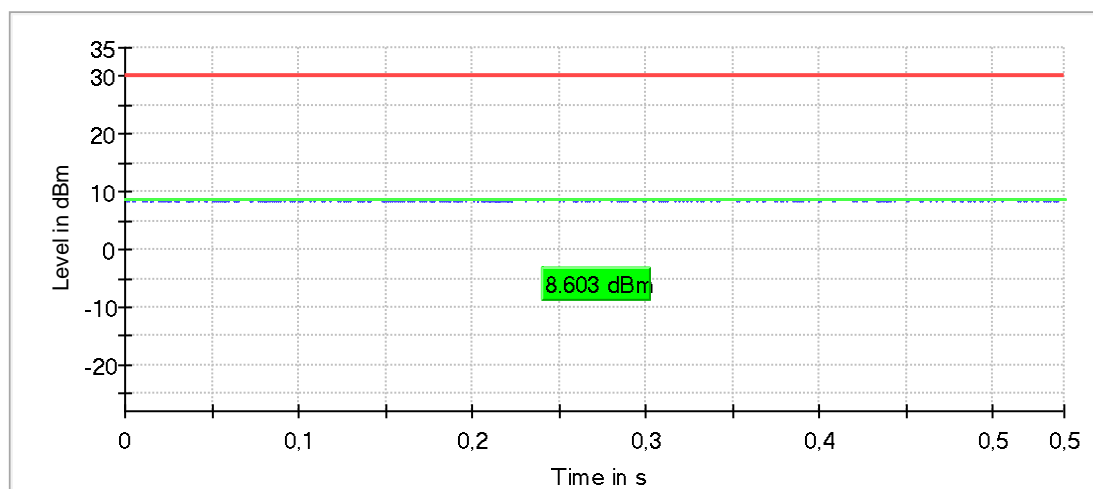
RF output power (5190 MHz; ac40-mode [VHT-MCS6] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5190.000000	8.6	30.0	8.6	54.522	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

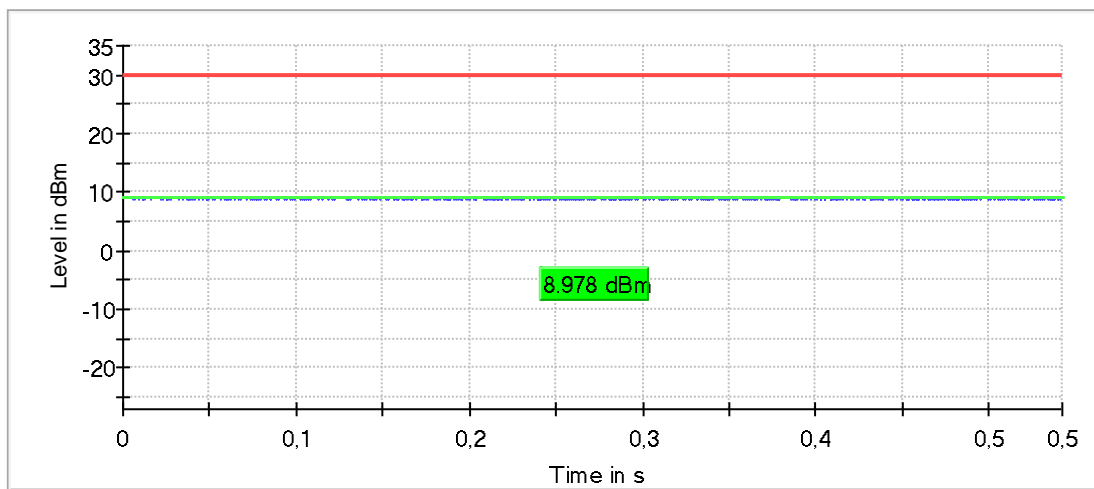
RF output power (5230 MHz; ac40-mode [VHT-MCS6] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5230.000000	9.0	30.0	9.0	54.616	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μs	1.000 μs

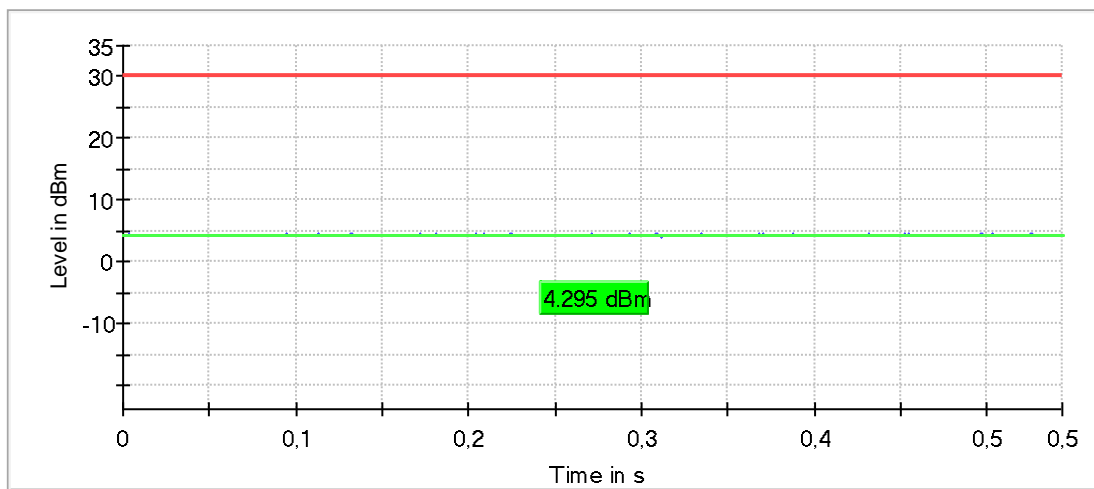
RF output power (5755 MHz; ac40-mode [VHT-MCS6] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5755.000000	4.3	30.0	4.3	54.747	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μs	1.000 μs

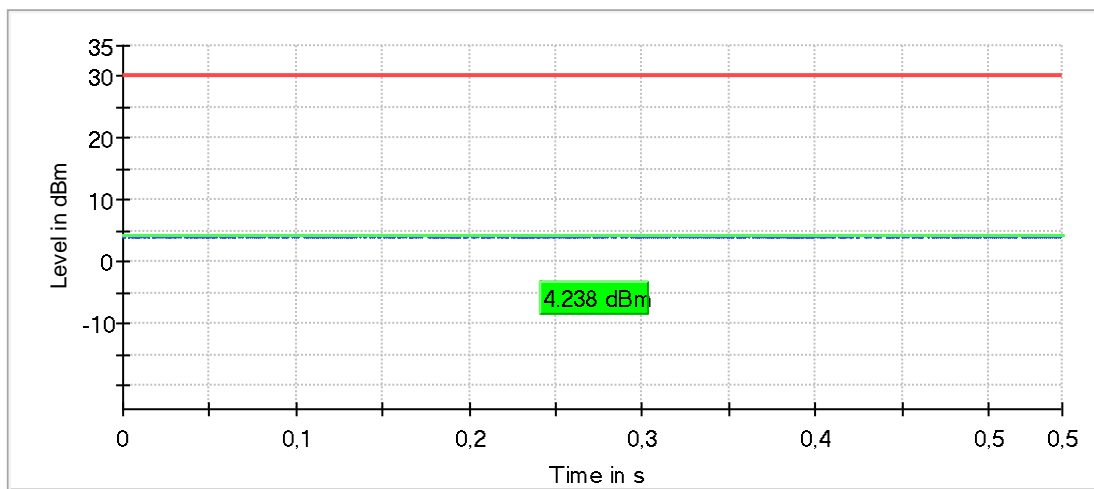
RF output power (5795 MHz; ac40-mode [VHT-MCS6] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5795.000000	4.2	30.0	4.2	54.667	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μs	1.000 μs

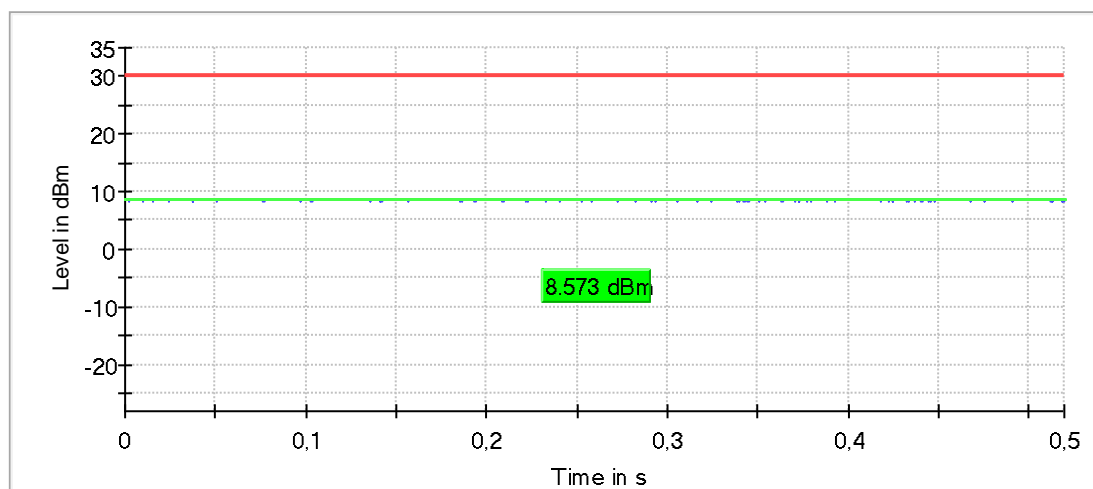
RF output power (5190 MHz; ac40-mode [VHT-MCS7] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5190.000000	8.6	30.0	8.6	52.387	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μs	1.000 μs

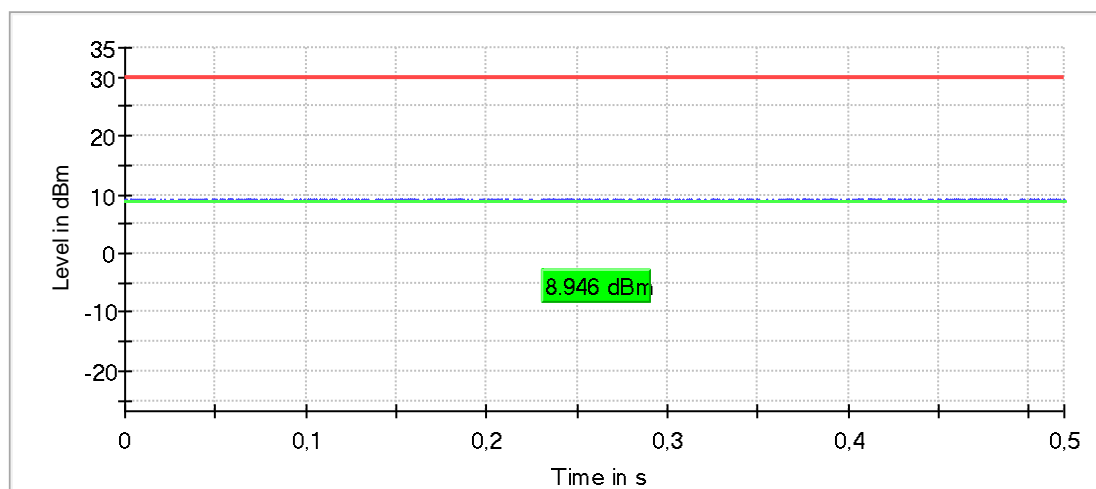
RF output power (5230 MHz; ac40-mode [VHT-MCS7] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5230.000000	8.9	30.0	8.9	52.358	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μs	1.000 μs

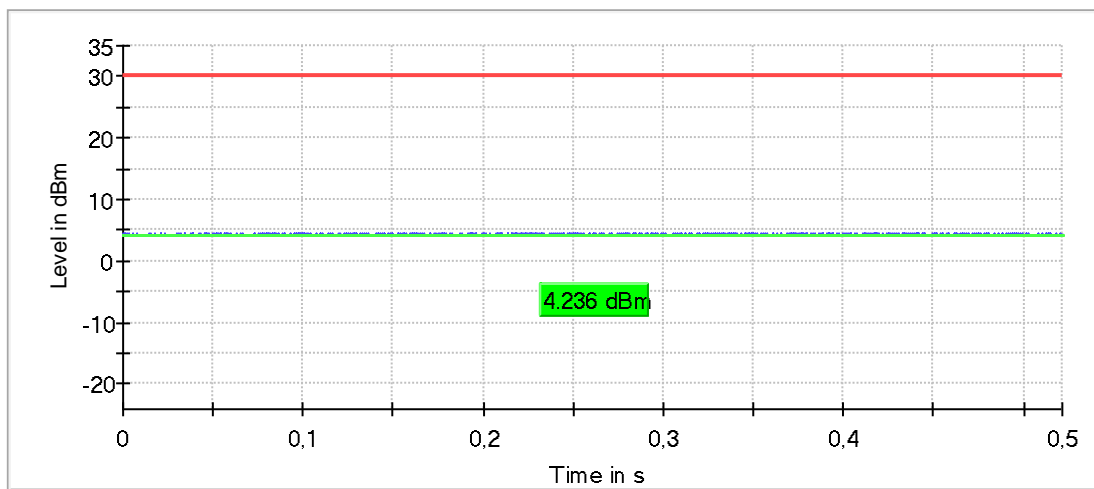
RF output power (5755 MHz; ac40-mode [VHT-MCS7] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5755.000000	4.2	30.0	4.2	52.551	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 µs	1.000 µs

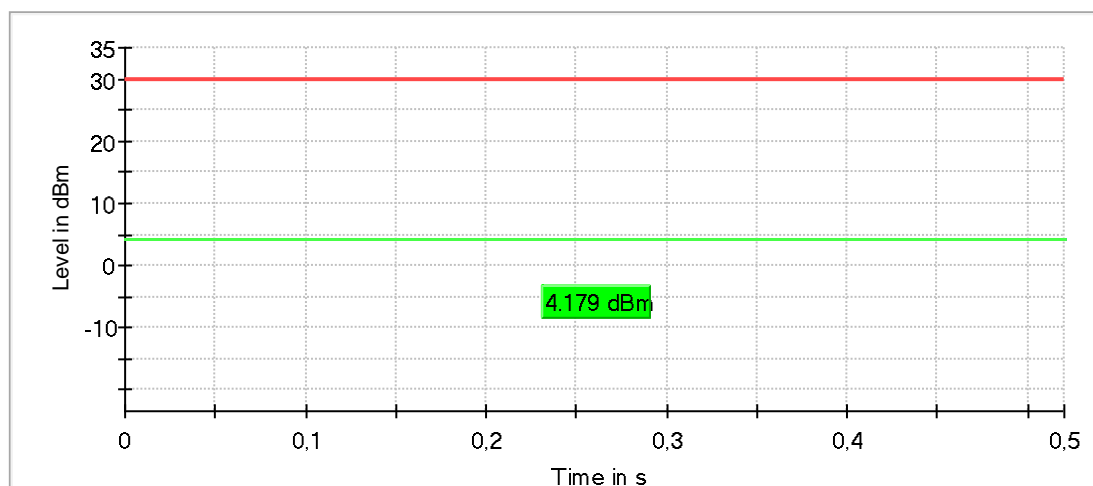
RF output power (5795 MHz; ac40-mode [VHT-MCS7] (20 dBm); 40 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5795.000000	4.2	30.0	4.2	52.447	PASS

Gated Trace



— Gated Trace — Overall — Limit

OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μs	1.000 μs